AVX Transient Suppression Products



Version 11.10



Transient Suppression Products



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AVX Multilayer Ceramic Transient Voltage Suppressors

GENERAL DESCRIPTION

The AVX TransGuard® Transient Voltage Suppressors (TVS) with unique high-energy multilayer construction represents state-of-the-art overvoltage circuit protection. Monolithic multilayer construction provides protection from voltage transients caused by ESD, lightning, NEMP, inductive switching, etc. True surface mount product is provided in EIA industry standard packages. Thru-hole components are supplied as conformally coated axial devices.

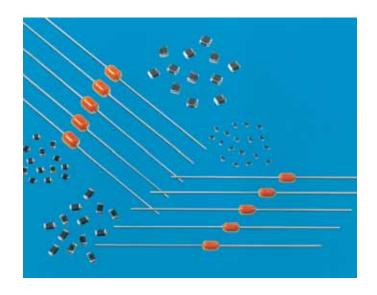
TRANSGUARD® DESCRIPTION

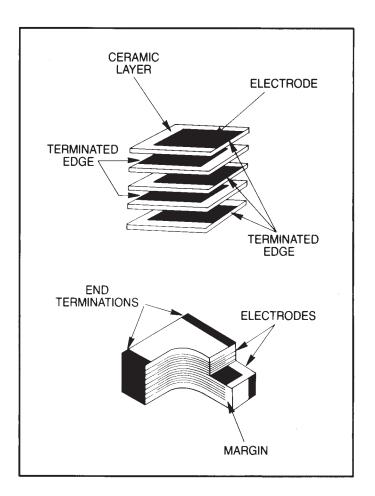
TransGuard® products are zinc oxide (ZnO) based ceramic semiconductor devices with non-linear voltage-current characteristics (bi-directional) similar to back-to-back zener diodes. They have the added advantage of greater current and energy handling capabilities as well as EMI/RFI attenuation. Devices are fabricated by a ceramic sintering process that yields a structure of conductive ZnO grains surrounded by electrically insulating barriers, creating varistor-like behavior.

The number of grain-boundary interfaces between conducting electrodes determines "Breakdown Voltage" of the device. High voltage applications such as AC line protection require many grains between electrodes while low voltage requires few grains to establish the appropriate breakdown voltage. Single layer ceramic disc processing proved to be a viable production method for thick cross section devices with many grains, but attempts to address low voltage suppression needs by processing single layer ceramic disc formulations with huge grain sites has had limited success.

AVX, the world leader in the manufacture of multilayer ceramic capacitors, now offers the low voltage transient protection marketplace a true multilayer, monolithic surface mount varistor. Technology leadership in processing thin dielectric materials and patented processes for precise ceramic grain growth have yielded superior energy dissipation in the smallest size. Now a varistor has voltage characteristics determined by design and not just cell sorting whatever falls out of the process.

Multilayer ceramic varistors are manufactured by mixing ceramic powder in an organic binder (slurry) and casting it into thin layers of precision thickness. Metal electrodes are deposited onto the green ceramic layers which are then stacked to form a laminated structure. The metal electrodes are arranged so that their terminations alternate from one end of the varistor to the other. The device becomes a monolithic block during the sintering (firing) cycle providing uniform energy dissipation in a small volume.









AVX Multilayer Ceramic Transient Voltage Suppressors

PART NUMBER IDENTIFICATION

N/A

N/A

121 = 120V

Surface Mount Devices

Important: For part number identification only, not for construction of part numbers.

The information below only defines the numerical value of part number digits, and cannot be used to construct a desired set of electrical limits. Please refer to the TransGuard® part number data for the correct electrical ratings.

VC 1206 05 D 150 R P **TERMINATION FINISH:** P = Ni/Sn Alloy (Plated) PACKAGING (Pcs/Reel): STYLE "D" "\//" VC0402 N/A N/A N/A 10,000 VC0603 1,000 4,000 10,000 N/A VC0805 1,000 4,000 10,000 N/A

VC1210 1,000 2,000 10,000 **CLAMPING VOLTAGE:* Where: 100 = 12V 500 = 50V 150 = 18V 560 = 60V

VC1206 1,000 4,000 10,000

200 = 22V 580 = 60V 250 = 27V 620 = 67V 300 = 32V 650 = 67V 390 = 42V 101 = 100V

ENERGY:

Where: A = 0.1JJ = 1.5JS = 1.9-2.0JB = 0.2JK = 0.6JT = 0.01JC = 0.3 JL = 0.8JU = 4.0-5.0JD = 0.4JM = 1.0JV = 0.02JE = 0.5JN = 1.1JW = 6.0JP = 3.0JF = 0.7JX = 0.05JY = 12.0JG = 0.9JQ = 1.3JH = 1.2JR = 1.7JZ = 25.0J

400 = 42V

WORKING VOLTAGE:

Where: 03 = 3.3 VDC 18 = 18.0 VDC 05 = 5.6 VDC 26 = 26.0 VDC 09 = 9.0 VDC 30 = 30.0 VDC 12 = 12.0 VDC 48 = 48.0 VDC 14 = 14.0 VDC 60 = 60.0 VDC 85 = 85.0 VDC

CASE SIZE DESIGNATOR:

SIZE	<u>LEN</u>	<u>IGTH</u>	WIDT	<u>H</u>
0402	1.00±0.10mm	(0.040"±0.004")	0.5±0.10mm	(0.020"±0.004")
0603	1.60±0.15mm	(0.063"±0.006")	0.8±0.15mm	(0.032"±0.006")
0805	2.01±0.2mm	(0.079"±0.008")	1.25±0.2mm	(0.049"±0.008")
1206	3.20±0.2mm	(0.126"±0.008")	1.60±0.2mm	(0.063"±0.008")
1210	3.20±0.2mm	(0.126"±0.008")	2.49±0.2mm	(0.098"±0.008")

CASE STYLE:

C = Chip

PRODUCT DESIGNATOR:

V = Varistor

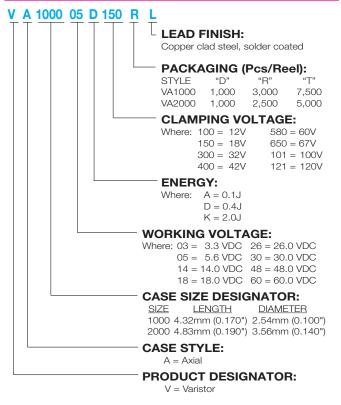
MARKING:

All standard surface mount TransGuard® chips will not be marked.

Axial Leaded Devices

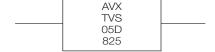
Important: For part number identification only, not for construction of part numbers.

The information below only defines the numerical value of part number digits, and cannot be used to construct a desired set of electrical limits. Please refer to the TransGuard® part number data for the correct electrical ratings.



MARKING:

All axial TransGuards® are marked with vendor identification, product identification, voltage/energy rating code and date code (see example below):



Where: AVX = Always AVX (Vendor Identification)

TVS = Always TVS (Product Identification

- Transient Voltage Suppressor)

05D = Working VDC and Energy Rating (Joules)

Where: 05 = 5.6 VDC, D = 0.4 J

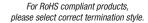
725 = Three Digit Date Code

Where: 8 = Last digit of year (2008) 25 = Week of year

Not RoHS Compliant











AVX Multilayer Ceramic Transient Voltage Suppressors

ELECTRICAL CHARACTERISTICS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Breakdown Voltage	Clamping Voltage	Test Current For V _c	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap	Frequency	Case Size
VC060303A100	3.3	2.3	5.0±20%	12	1	100	0.1	30	1450	K	0603
VC080503A100	3.3	2.3	5.0±20%	12	1	100	0.1	40	1400	K	0805
VC080503C100	3.3	2.3	5.0±20%	12	1	100	0.3	120	5000	K	0805
VC120603A100	3.3	2.3	5.0±20%	12	1	100	0.1	40	1250	K	1206
VC120603D100	3.3	2.3	5.0±20%	12	1	100	0.4	150	4700	K	1206
VA100003A100	3.3	2.3	5.0±20%	12	1	100	0.1	40	1500	K	1000
VA100003D100	3.3	2.3	5.0±20%	12	1	100	0.4	150	4700	K	1000
VC040205X150	5.6	4.0	8.5±20%	18	1	35	0.05	20	175	М	0402
VC060305A150	5.6	4.0	8.5±20%	18	1	35	0.1	30	750	K	0603
VC080505A150	5.6	4.0	8.5±20%	18	1	35	0.1	40	1100	K	0805
VC080505C150	5.6	4.0	8.5±20%	18	1	35	0.3	120	3000	K	0805
VC120605A150	5.6	4.0	8.5±20%	18	1	35	0.1	40	1200	K	1206
VC120605D150	5.6	4.0	8.5±20%	18	1	35	0.4	150	3000	K	1206
VA100005A150	5.6	4.0	8.5±20%	18	1	35	0.1	40	1000	K	1000
VA100005D150	5.6	4.0	8.5±20%	18	1	35	0.4	150	2800	K	1000
VC040209X200	9.0	6.4	12.7±15%	22	1	25	0.05	20	175	М	0402
VC060309A200	9.0	6.4	12.7±15%	22	1	25	0.1	30	550	K	0603
VC080509A200	9.0	6.4	12.7±15%	22	1	25	0.1	40	750	K	0805
VC080512A250	12.0	8.5	16±15%	27	1	25	0.1	40	525	K	0805
VC040214X300	14.0	10.0	18.5±12%	32	1	15	0.05	20	100	М	0402
VC060314A300	14.0	10.0	18.5±12%	32	1	15	0.1	30	350	K	0603
VC080514A300	14.0	10.0	18.5±12%	32	1	15	0.1	40	325	K	0805
VC080514C300	14.0	10.0	18.5±12%	32	1	15	0.3	120	900	K	0805
VC120614A300	14.0	10.0	18.5±12%	32	1	15	0.1	40	600	K	1206
VC120614D300	14.0	10.0	18.5±12%	32	1	15	0.4	150	1050	K	1206
VA100014A300	14.0	10.0	18.5±12%	32	1	15	0.1	40	325	K	1000
VA100014D300	14.0	10.0	18.5±12%	32	1	15	0.4	150	1100	K	1000
VC13MA0160KBA	16.0	14.0	24.5±10%	40	2.5	25	1.6	400	1800	K	1210
VC040218X400	18.0	13.0	25.5±10%	42	1	10	0.05	20	65	М	0402
VC060318A400	18.0	13.0	25.5±10%	42	1	10	0.1	30	150	K	0603
VC080518A400	18.0	13.0	25.5±10%	42	1	10	0.1	30	225	K	0805
VC080518C400	18.0	13.0	25.5±10%	42	1	10	0.3	100	550	K	0805
VC120618A400	18.0	13.0	25.5±10%	42	1	10	0.1	30	350	K	1206
VC120618D400	18.0	13.0	25.5±10%	42	1	10	0.4	150	900	K	1206
VC120618E380	18.0	13.0	22.0±10%	38	1	15	0.5	200	800	K	1206
VC121018J390	18.0	13.0	25.5±10%	42	5	10	1.5	500	3100	K	1210
VJ13MC0180KBA	18.0	13.0	24.0±10%	45	10	25	1.5	500	3000	K	1210
VA100018A400	18.0	13.0	25.5±10%	42	1	10	0.1	40	350	K	1000

L Termination/Lead Finish Code



⁻ Packaging Code



AVX Multilayer Ceramic Transient Voltage Suppressors

ELECTRICAL CHARACTERISTICS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Breakdown Voltage	Clamping Voltage	Test Current For V _c	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap	Frequency	Case Size
VA100018D400	18.0	13.0	25.5±10%	42	1	10	0.4	150	900	K	1000
VC060326A580	26.0	18.0	34.5±10%	60	1	10	0.1	30	155	K	0603
VC080526A580	26.0	18.0	34.5±10%	60	1	10	0.1	30	120	K	0805
VC080526C580	26.0	18.0	34.5±10%	60	1	10	0.3	100	250	K	0805
VC120626D580	26.0	18.0	34.5±10%	60	1	10	0.4	120	500	K	1206
VC120626F540	26.0	20.0	33.0±10%	54	1	15	0.7	200	600	K	1206
VC121026H560	26.0	18.0	34.5±10%	60	5	10	1.2	300	2150	K	1210
VJ13MC0260KBA	26.0	18.0	33.0±10%	62	10	25	1.2	300	1120	K	1210
VC181226P540	26.0	20.0	33.0±10%	54	5	15	3.0	800	3000	K	1812
VA100026D580	26.0	18.0	34.5±10%	60	1	10	0.4	120	650	K	1000
VC060330A650	30.0	21.0	41.0±10%	67	1	10	0.1	30	125	K	0603
VC080530A650	30.0	21.0	41.0±10%	67	1	10	0.1	30	90	М	0805
VC120630D650	30.0	21.0	41.0±10%	67	1	10	0.4	120	400	K	1206
VC121030G620	30.0	21.0	41.0±10%	67	5	10	0.9	220	1750	K	1210
VC121030H620	30.0	21.0	41.0±10%	67	5	10	1.2	280	1850	K	1210
VJ13MC0300KBA	30.0	21.0	39.0±10%	73	10	25	0.9	220	1020	K	1210
VJ13PC0300KBA	30.0	21.0	39.0±10%	73	10	25	1.2	280	1150	K	1210
VA100030D650	30.0	21.0	41.0±10%	67	1	10	0.4	120	550	K	1000
VC120631M650	31.0	25.0	39.0±10%	65	1	15	1.0	200	500	K	1206
VC120638N770	38.0	30.0	47.0±10%	77	1	15	1.1	200	350	K	1206
VC121038S770	38.0	30.0	47.0±10%	77	2.5	15	2.0	300	750	K	1210
VC181238U770	38.0	30.0	47.0±10%	77	5	15	4.2	800	1700	K	1812
VC120645K900	45.0	35.0	56.0±10%	90	1	15	0.6	200	260	K	1206
VC181245U900	45.0	35.0	56.0±10%	90	5	15	4.0	500	1200	K	1812
VC120648D101	48.0	34.0	62.0±10%	100	1	10	0.4	100	225	K	1206
VC121048G101	48.0	34.0	62.0±10%	100	5	10	0.9	220	450	K	1210
VC121048H101	48.0	34.0	62.0±10%	100	5	10	1.2	250	500	K	1210
VJ13MC0480KBA	48.0	34.0	60.5±10%	110	10	25	0.9	220	800	K	1210
VJ13PC0480KBA	48.0	34.0	60.5±10%	110	10	25	1.2	250	840	K	1210
VA100048D101	48.0	34.0	62.0±10%	100	1	10	0.4	100	200	K	1000
VC120656F111	56.0	40.0	68.0±10%	110	1	15	0.7	100	180	K	1206
VC181256U111	56.0	40.0	68.0±10%	110	5	15	4.8	500	800	K	1812
VC121060J121	60.0	42.0	76.0±10%	120	5	10	1.5	250	400	K	1210
VJ13MC0600KBA	60.0	42.0	75.0±10%	126	10	25	1.5	250	600	K	1210
VA200060K121	60.0	42.0	76.0±10%	120	1	10	2.0	300	400	K	2000
VC120665L131	65.0	50.0	82.0±10%	135	1	15	0.8	100	120	K	1206
VC121085S151	85.0	60.0	100±10%	150	1	35	2.0	250	275	K	1210

Termination/Lead Finish Code — Packaging Code

V_w(DC) V_w(AC) V_B Tol

DC Working Voltage (V) AC Working Voltage (V)

Typical Breakdown Voltage (V @ 1mA_{DC}) V_B Tolerance is ± from Typical Value Clamping Voltage (V @ I_{vc})

Test Current for V_c (A, 8x20µS)

Test Current for V_c (A, 8x20 μ S) Maximum Leakage Current at the Workin Transient Energy Rating (J, 10x1000 μ S) Maximum Leakage Current at the Working Voltage (µA)

Peak Current Rating (A, 8x20µS)

Typical Capacitance (pF) @ frequency specified and 0.5 V_{RMS}

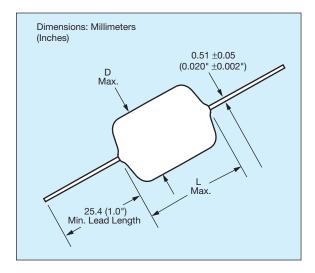
Freq Frequency at which capacitance is measured

(K = 1kHz, M = 1MHz)



Dimensions

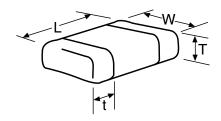




DIMENSIONS: mm (inches)

AVX Style		VA1000	VA2000
(L) Max Length	mm	4.32	4.83
	(in.)	(0.170)	(0.190)
(D) Max Diameter	mm	2.54	3.56
	(in.)	(0.100)	(0.140)

Lead Finish: Copper Clad Steel, Solder Coated



DIMENSIONS: mm (inches)

AVX Style		0402	0603	0805	1206	1210	1812	2220
(L) Length	mm	1.00±0.10	1.60±0.15	2.01±0.20	3.20±0.20	3.20±0.20	4.50±0.20	5.70±0.20
	(in.)	(0.040±0.004)	(0.063±0.006)	(0.079±0.008)	(0.126±0.008)	(0.126±0.008)	(0.177±0.008)	(0.224±0.008)
(W) Width mm (in.)				1.25±0.20 (0.049±0.008)	1.60±0.20 2.49±0.20 (0.063±0.008) (0.098±0.008)		3.20±0.20 (0.126±0.008)	5.00±0.20 (0.197±0.008)
(T) Max Thickness	mm	0.6	0.9	1.02	1.02	1.70	1.70	1.70
	(in.)	(0.024)	(0.035)	(0.040)	(0.040)	(0.067)	(0.067)	(0.067)
(t) Land Length	mm	0.25±0.15	0.35±0.15	0.71 max.	0.94 max.	1.14 max.	0.50±0.25	0.50±0.25
	(in.)	(0.010±0.006)	(0.014±0.006)	(0.028 max.)	(0.037 max.)	(0.045 max.)	(0.020±0.010)	(0.020±0.010)

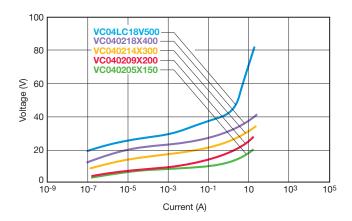


AVX Multilayer Ceramic Transient Voltage Suppressors

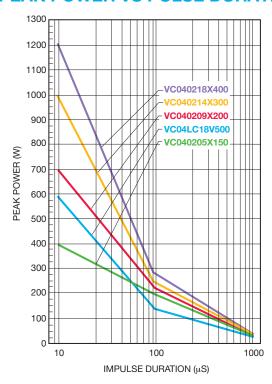
TYPICAL PERFORMANCE CURVES (0402 CHIP SIZE)

VOLTAGE/CURRENT CHARACTERISTICS

Multilayer construction and improved grain structure result in excellent transient clamping characteristics up to 20 amps peak current, while maintaining very low leakage currents under DC operating conditions. The VI curves below show the voltage/current characteristics for the 5.6V, 9V, 14V, 18V and low capacitance StaticGuard parts with currents ranging from parts of a micro amp to tens of amps.



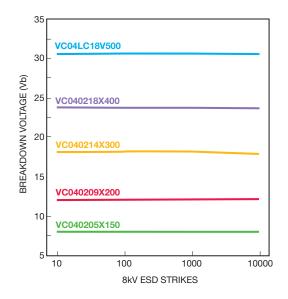
PEAK POWER VS PULSE DURATION



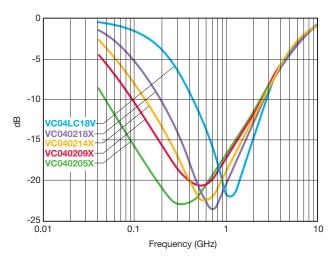
PULSE DEGRADATION

Traditionally varistors have suffered degradation of electrical performance with repeated high current pulses resulting in decreased breakdown voltage and increased leakage current. It has been suggested that irregular intergranular boundaries and bulk material result in restricted current paths and other non-Schottky barrier paralleled conduction paths in the ceramic. Repeated pulsing of TransGuard® transient voltage suppressors with 150Amp peak 8 x 20µS waveforms shows negligible degradation in breakdown voltage and minimal increases in leakage current. This does not mean that TransGuard® suppressors do not suffer degradation, but it occurs at much higher current.

ESD TEST OF 0402 PARTS



INSERTION LOSS CHARACTERISTICS





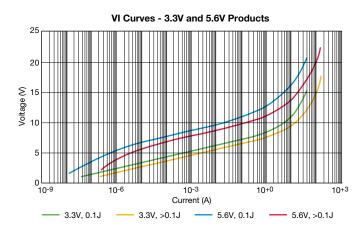


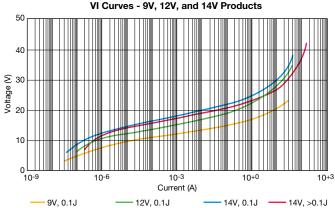
AVX Multilayer Ceramic Transient Voltage Suppressors

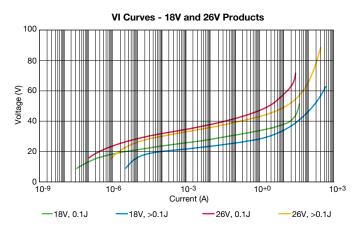
TYPICAL PERFORMANCE CURVES (0603, 0805, 1206 & 1210 CHIP SIZES)

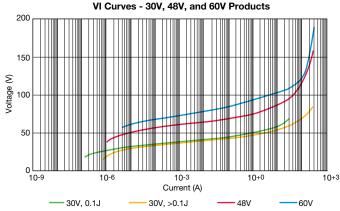
VOLTAGE/CURRENT CHARACTERISTICS

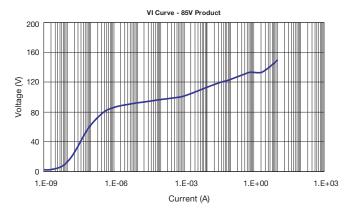
Multilayer construction and improved grain structure result in excellent transient clamping characteristics up to 500 amps peak current, depending on case size and energy rating, while maintaining very low leakage currents under DC operating conditions. The VI curve below shows the voltage/current characteristics for the 3.3V, 5.6V, 12V, 14V, 18V, 26V, 30V, 48V and 60VDC parts with currents ranging from parts of a micro amp to tens of amps.







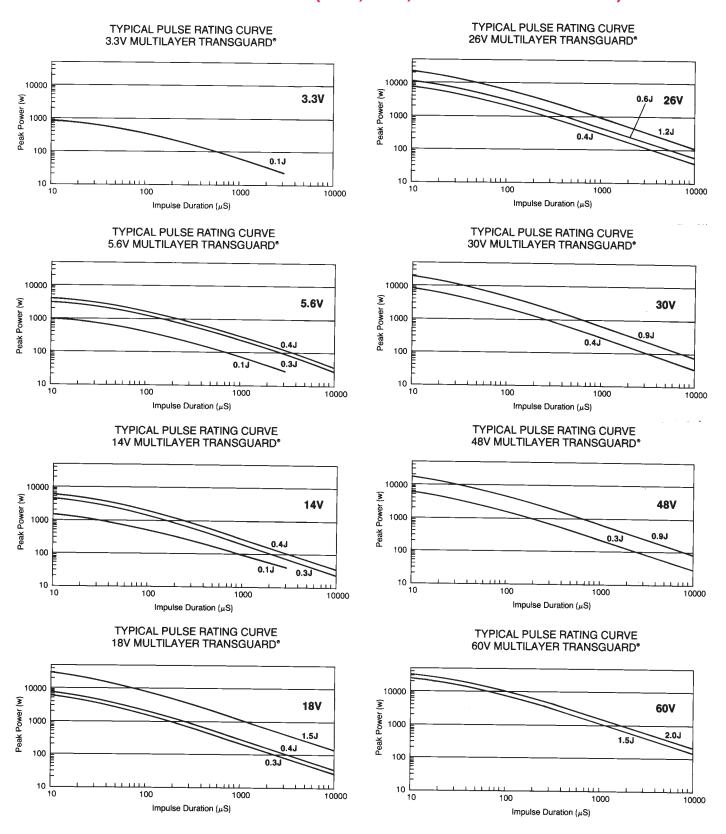






AVX Multilayer Ceramic Transient Voltage Suppressors

TYPICAL PERFORMANCE CURVES (0603, 0805, 1206 & 1210 CHIP SIZES)



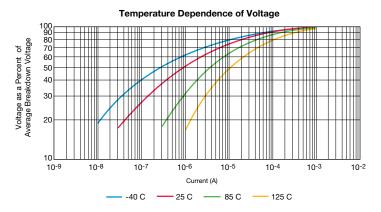


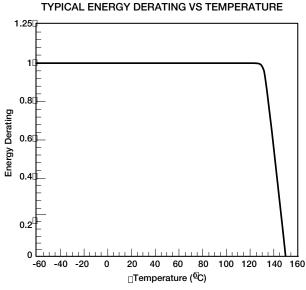
AVX Multilayer Ceramic Transient Voltage Suppressors

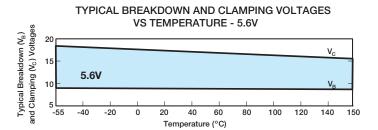
TYPICAL PERFORMANCE CURVES (0603, 0805, 1206 & 1210 CHIP SIZES)

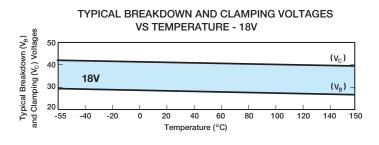
TEMPERATURE CHARACTERISTICS

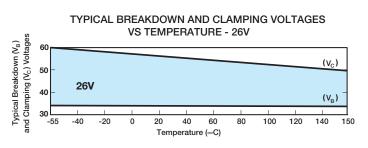
TransGuard® suppressors are designed to operate over the full temperature range from -55°C to +125°C. This operating temperature range is for both surface mount and axial leaded products.

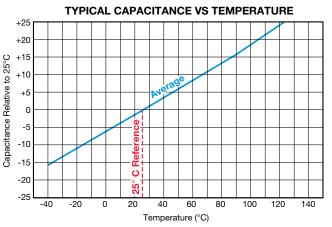














AVX Multilayer Ceramic Transient Voltage Suppressors

TYPICAL PERFORMANCE CURVES (0603, 0805, 1206 & 1210 CHIP SIZES)

PULSE DEGRADATION

Traditionally varistors have suffered degradation of electrical performance with repeated high current pulses resulting in decreased breakdown voltage and increased leakage current. It has been suggested that irregular intergranular boundaries and bulk material result in restricted current paths and other non-Schottky barrier paralleled conduction paths in the ceramic. Repeated pulsing of both 5.6 and 14V TransGuard® transient voltage suppressors with

150 Amp peak 8 x 20 μ S waveforms shows negligible degradation in breakdown voltage and minimal increases in leakage current. This does not mean that TransGuard® suppressors do not suffer degradation, but it occurs at much higher current. The plots of typical breakdown voltage vs number of 150A pulses are shown below.

Repetitive Peak Current Strikes TransGuard® 1206 0.4J Product

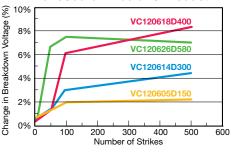
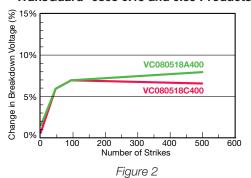
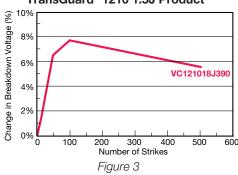


Figure 1

Repetitive Peak Current Strikes TransGuard® 0805 0.1J and 0.3J Products



Repetitive Peak Current Strikes TransGuard® 1210 1.5J Product



Repetitive Peak Current Strikes StaticGuard 0805 0.1J Product

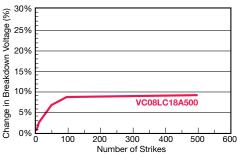
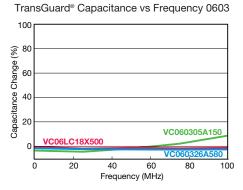
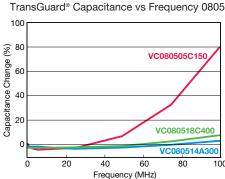


Figure 4

CAPACITANCE/FREQUENCY CHARACTERISTICS





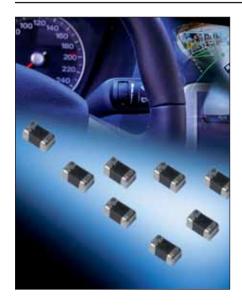
TransGuard® Capacitance vs Frequency 1206

100
(%) 80
80
90 ue do
0
VC120614D300
0
VC120648D101
0
VC12LC18A500
0
0
Frequency (MHz)





Multilayer Varistors for Automotive Applications



GENERAL DESCRIPTION

The TransGuard Automotive Series are zinc oxide (ZnO) based ceramic semiconductor devices with non-linear, bi-directional voltage-current characteristics.

They have the advantage of offering bi-directional overvoltage protection as well as EMI/RFI attenuation in a single SMT package. The Automotive Series high current and high energy handling capability make them well suited for protection against automotive related transients.

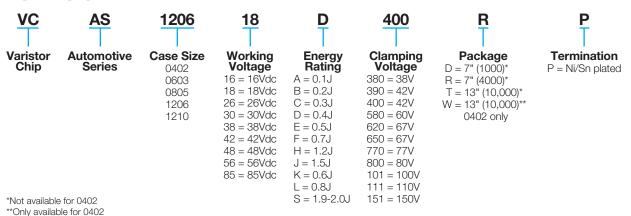
FEATURES

- · High Reliability
- High Energy Absorption (Load Dump)
- · High Current Handling
- AEC Q200 Qualified
- · Bi-Directional protection
- EMI/RFI attenuation
- Multi-strike capability
- Sub 1nS response to ESD strike

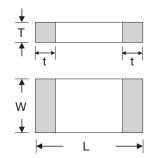
APPLICATIONS

- Internal Combustion Engine (ICE) Vehicles
- Hybrid Electric Vehicles (HEV)
- Plug-in Hybrid Electric Vehicles (PHEV)
- Commercial Vehicles
 - CAN, LIN, FLEXRAY based modules
 - Sensors
 - Module load dump protection
 - Motor/inductive load transient suppression

HOW TO ORDER



PHYSICAL DIMENSIONS: mm (inches)



Size (EIA)	Length (L)	Width (W)	Max Thickness (T)	Land Length (t)
0402	1.00±0.10		0.60 (0.024)	0.25±0.15 (0.010±0.006)
0603	1.60±0.15 (0.063±0.006)	0.80±0.15 (0.031±0.006)	0.90 (0.035)	0.35±0.15 (0.014±0.006)
0805	2.01±0.20 (0.079±0.008)	1.25±0.20 (0.049±0.008)	1.02 (0.040)	0.71 max. (0.028 max.)
1206	3.20±0.20 (0.126±0.008)	1.60±0.20 (0.063±0.008)	1.02 (0.040)	0.94 max. (0.037 max.)
1210	3.20±0.20 (0.126±0.008)	2.49±0.20 (0.098±0.008)	1.70 (0.067)	0.14 max. (0.045 max.)





Multilayer Varistors for Automotive Applications

ELECTRICAL CHARACTERISTICS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	V_{B}	V _c	Test Current for V _C	Maximum I _L	E _T	I _P	Typical Cap	Freq	V _{Jump}	P _{Diss. Max}
VCAS060316B400	16	11	25.5±10%	42	1	10	0.2	30	150	K	24.5	0.003
VCAS120616K380	16	11	22.0±10%	38	1	15	0.6	200	930	K	27.5	0.010
VCAS121016J390	16	11	25.5±10%	42	5	10	1.5	500	3100	K	27.5	0.030
VCAS040218X400	18	13	25.5±10%	42	1	10	0.05	20	65	М	24.5	0.001
VCAS060318A400	18	13	25.5±10%	42	1	10	0.1	30	150	K	24.5	0.003
VCAS080518A400	18	13	25.5±10%	42	1	10	0.1	30	225	K	27.5	0.002
VCAS080518C400	18	13	25.5±10%	42	1	10	0.3	120	550	K	27.5	0.007
VCAS120618A400	18	13	25.5±10%	42	1	10	0.1	30	350	K	27.5	0.002
VCAS120618D400	18	13	25.5±10%	42	1	10	0.4	150	900	K	27.5	0.008
VCAS120618E380	18	13	22.0±10%	38	1	15	0.5	200	930	K	27.5	0.010
VCAS121018J390	18	13	25.5±10%	42	5	10	1.5	500	3100	K	27.5	0.030
VCAS060326A580	26	18	34.5±10%	60	1	10	0.1	30	155	K	27.5	0.002
VCAS080526A580	26	18	34.5±10%	60	1	10	0.1	30	120	K	27.5	0.002
VCAS080526C580	26	18	34.5±10%	60	1	10	0.3	100	250	K	27.5	0.006
VCAS120626D580	26	18	34.5±10%	60	1	10	0.4	120	500	K	27.5	0.008
VCAS121026H560	26	18	34.5±10%	60	5	10	1.2	300	2150	K	27.5	0.018
VCAS060330A650	30	21	41.0±10%	67	1	10	0.1	30	125	K	29.0	0.002
VCAS080530A650	30	21	41.0±10%	67	1	10	0.1	30	90	М	29.0	0.002
VCAS080530C650	30	21	41.0±10%	67	1	10	0.3	30	250	K	29.0	0.005
VCAS120630D650	30	21	41.0±10%	67	1	10	0.4	120	400	K	29.0	0.008
VCAS121030H620	30	21	41.0±10%	67	5	10	1.2	280	1850	K	29.0	0.018
VCAS080538C770	38	30	47.0±10%	77	1	10	0.3	80	200	K	45.0	0.006
VCAS120642L800	42	32	51.0±10%	80	1	100	0.8	180	600	K	48.0	0.016
VCAS120648D101	48	34	62.0±10%	100	1	10	0.4	100	225	K	48.0	0.008
VCAS121048H101	48	34	62.0±10%	100	1	10	1.2	250	500	K	48.0	0.022
VCAS120656F111	56	40	68.0±10%	110	1	15	0.7	100	180	K	48.0	0.014
VCAS121085S151	85	60	100.0±10%	150	1	35	2.0	250	275	K	48.0	0.040

 $V_w(DC)$ DC Working Voltage [V] $V_w(AC)$ AC Working Voltage [V]

V_B Typical Breakdown Votage [V @ 1mA_{DC}]

V_C Clamping Voltage [V @ I_N]

 I_{VC} Test Current for V_{C}

I_L Maximum leakage current at the working voltage [μΑ]

 E_t Transient Energy Rating [J, 10x1000 μ S] I_P Peak Current Rating [A, 8x20 μ S]

Cap Typical capacitance [pF] @ frequency specified and $0.5V_{\scriptsize RMS}$

V_{Jump} Jump Start (V)

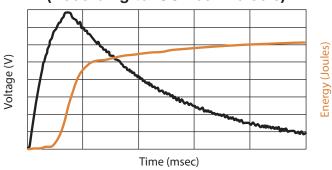
P_{DISS} Power Dissipation (W)



Multilayer Varistors for Automotive Applications

AUTOMOTIVE SERIES – LOAD DUMP TEST According to ISO DP7637 rev 2 Pulse 5

Automotive Load Dump Pulse (According to ISO 7637 Pulse 5)



When using the test method indicated below, the amount of Energy dissipated by the varistor must not exceed the Load Dump Energy value specified in the product table.

CONSUMER VEHICLE TESTING (12V Network)

AVX Part Number	Working Voltage	Working Voltage	Transient Energy	Load Dump Energy	Typical Vz Max Versus Pulse Duration and Rs		
	(DC)	(AC)	10 x 1000 us (Joules)	(x10) Joules	0.5 Ohm 100 mS	4 Ohm 100 mS	
VCAS060316B400	16	11	0.2	0.25	35	40	
VCAS120616K380	16	11	0.6	1.5	40	55	
VCAS121016J390	16	11	1.5	3	45	65	
VCSA040218X400	18	13	0.05	0.05	30	35	
VCAS060318A400	18	13	0.1	0.1	35	40	
VCAS080518A400	18	13	0.1	0.1	35	40	
VCAS080518C400	18	13	0.3	1	35	45	
VCAS120618A400	18	13	0.1	0.1	40	50	
VCAS120618D400	18	13	0.4	1.5	40	55	
VCAS120618E380	18	13	0.5	1.5	40	55	
VCAS121018J390	18	13	1.5	3	45	65	

COMMERCIAL VEHICLE TESTING (24V Network)

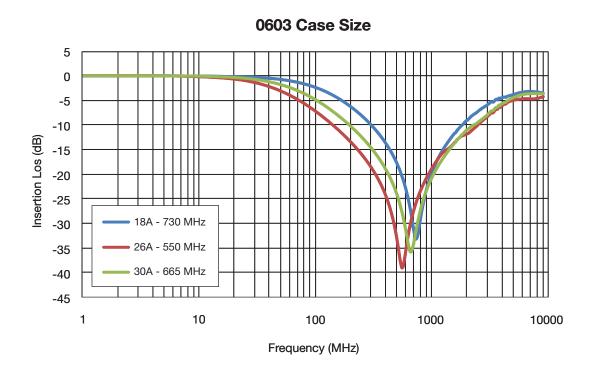
AVX Part Number	Working Voltage	Working Voltage	Transient Energy	Load Dump Energy		x Versus Pulse n and Rs
	(DC)	(AC)	10 x 1000 us (Joules)	(x10) Joules	1 Ohm 100 mS	8 Ohm 100 mS
VCAS060326A580	26	18	0.1	0.1	45	50
VCAS080526A580	26	18	0.1	0.15	50	55
VCAS080526C580	26	18	0.3	0.5	50	60
VCAS120626D580	26	6 18 0.4 1		1	50	60
VCAS121026H560	26	18	1.2	3	55	80
VCAS060330A650	30	21	0.1	0.15	50	60
VCAS080530A650	30	21	0.1	0.15	50	60
VCAS080530C650	30	21	0.3	0.5	55	65
VCAS120630D650	30	21	0.4	1	60	70
VCAS121030H620	30	21	1.2	3	60	90

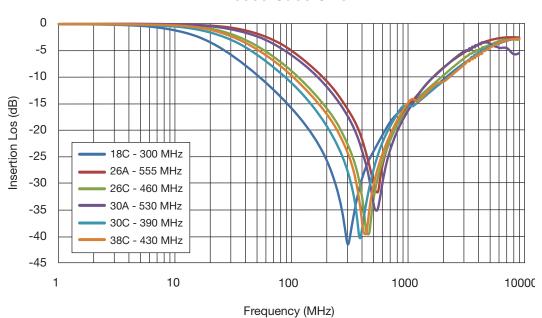




Multilayer Varistors for Automotive Applications

FORWARD TRANSMISSION CHARACTERISTICS (S21)

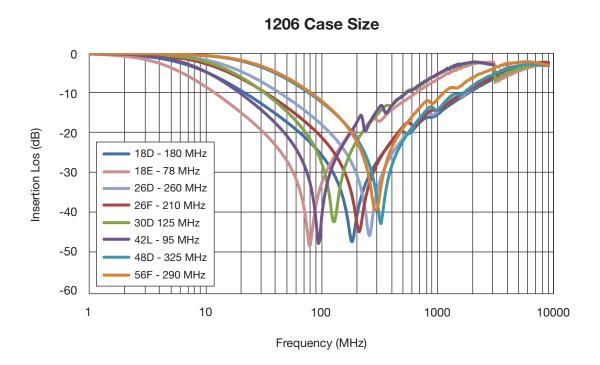


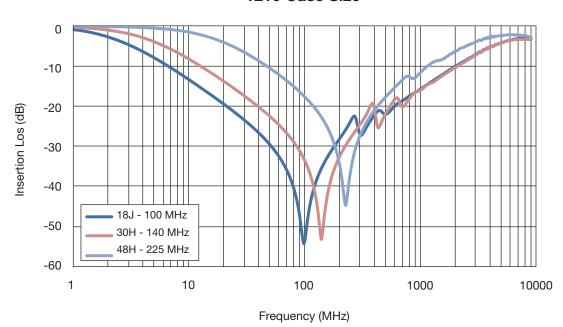






FORWARD TRANSMISSION CHARACTERISTICS (S21)

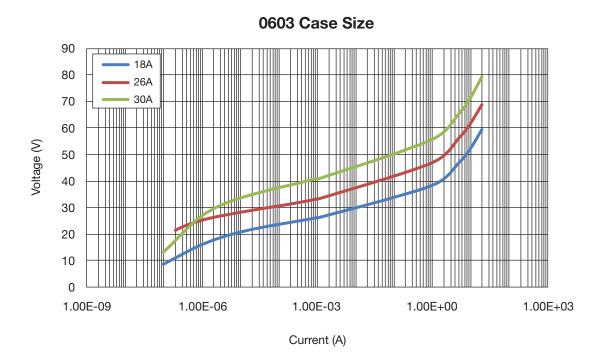


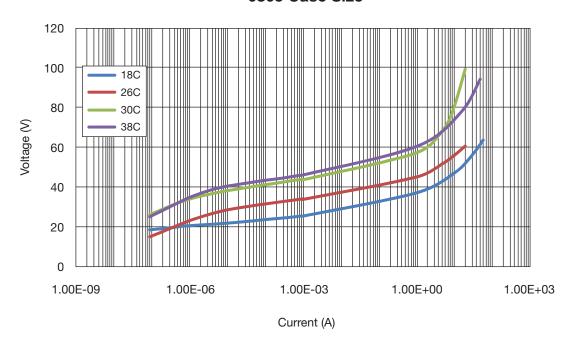






V-I CHARACTERISTICS



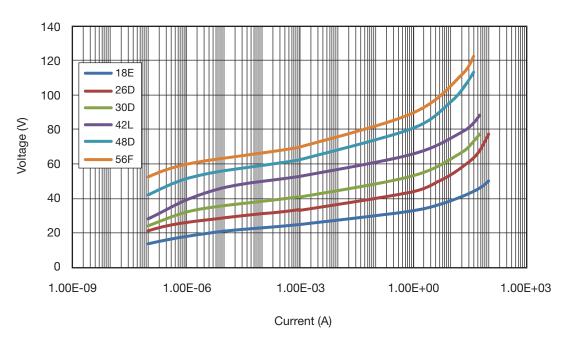


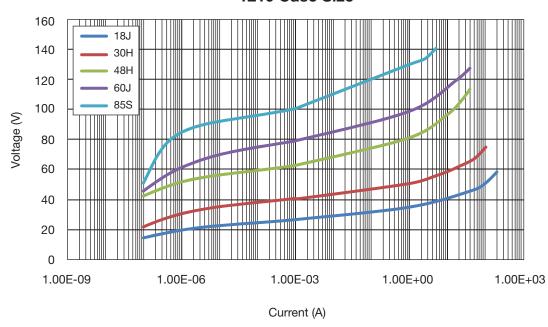




V-I CHARACTERISTICS

1206 Case Size





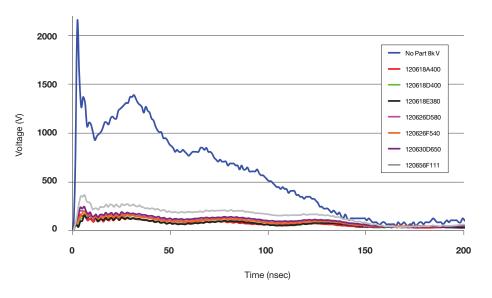






ESD V-I CHARACTERISTICS

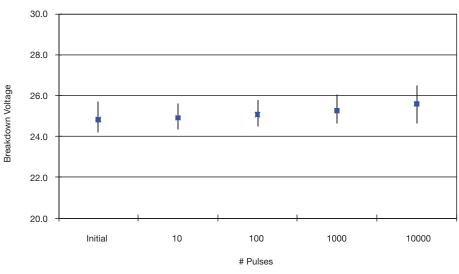
8 kV ESD Vc (150pF/300ohm IEC Network)



TYPICAL VOLTAGE AT 8 KV PULSE

8kV Pulse	Peak Voltage (V)	30ns Voltage (V)	100ns Voltage (V)		
No Part (No Suppression)	2130	1370	517		
120618A400	0618A400 171 123				
120618D400	177	133	66		
120618E380	161	121	63		
120626D580	203	155	88		
102626F540	201	159	84		
120630D650	249	177	106		
120656F111	366	262	169		

ESD 8 kV IEC 61000-4-2 150pF / 330Ω Resistor VC060318A400



Miniature AC Varistor – MAV

Low Power AC Circuit Protection



GENERAL DESCRIPTION

AVX Miniature AC Varistors are designed for use in low power AC circuit protection. MAV series devices are an ideal solution to transient suppression in LC resonant circuits intended for signal & power transfer. The AVX part provides low loss in the resonant circuit yet is able to clamp large amounts of transients in a bi-directional manner.

The ability to handle large transients makes the MAV series useful in low power AC circuit protection and the AEC Q200 qualification allows for use in automotive applications.



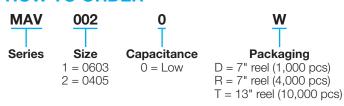
FEATURES

- 110 Pk-Pk @ 125kHz capability
- AEC Q200 qualified
- ESD rated to 25kV (HBM ESD Level 6)
- EMI/RFI attenuation in off state
- Bi-Directional protection

APPLICATIONS

- LC resonant circuits
- AC sampling circuitry
- Transformer secondaries
- GFI modules

HOW TO ORDER





ANTENNAGUARD CATALOG PART NUMBERS/ELECTRICAL VALUES

AVX Part Number	V _W (DC)	V _W (AC)	V _B	V _C	I _{vc}	E _T	I _P	ΙL	Сар	Elements
MAV0010_P	70	52	120 ±15%	225	1	0.015	2	10	22pF Max	1
MAV0020_P	70	52	120 ±15%	225	1	0.020	3	10	8pF Max	2

L Packaging Code

 $V_w(DC)$ DC Working Voltage [V] I_L Maximum leakage current at the working voltage [μ A]

 $V_{w}(AC)$ AC Working Voltage [V] E_{T} Transient Energy Rating [J, 10x100 μ S] V_{B} Breakdown Voltage [V @ 1mA_{DC}] I_{D} Peak Current Rating [A, 8x10 μ S]

 V_c Clamping Voltage [V @ I_{vc}] Cap Maximum capacitance @ 1MHz and 0.5 $V_{\text{\tiny RMS}}$



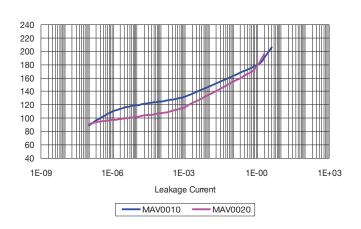
Miniature AC Varistor - MAV

Low Power AC Circuit Protection

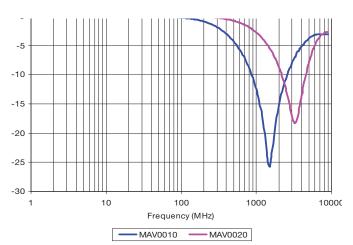


TYPICAL PERFORMANCE CURVES

Voltage/Current Characteristics

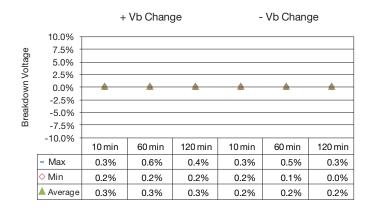


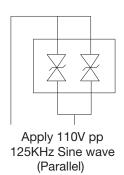
Transmission Characteristics



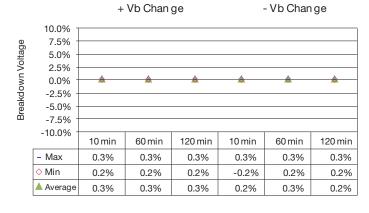
TYPICAL PERFORMANCE CURVES

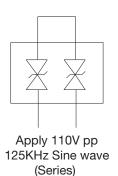
Impact of AC Voltage on Breakdown Voltage Parallel 110VPP @ 125 kHz





Impact of AC Voltage on Breakdown Voltage Series 110VPP @ 125 kHz



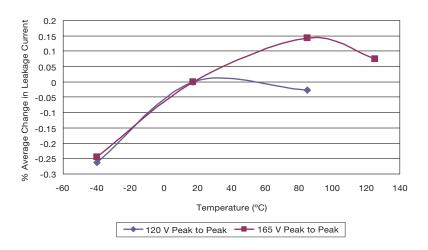


Miniature AC Varistor - MAV

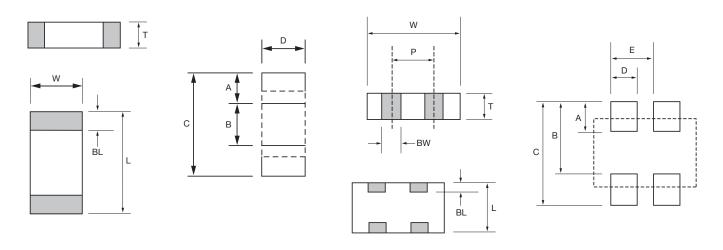




IMPACT OF AC VOLTAGE ON LEAKAGE CURRENT



PHYSICAL DIMENSIONS AND RECOMMENDED PAD LAYOUT



L	W	Т	BW	BL	Р	Α	В	С	D	E
	MAV0010									
1.60 ± 0.15 (0.063±0.006)	0.80 ± 0.15 (0.032±0.006)	0.90 Max (0.035) Max	N/A	0.35 ± 0.15 (0.014±0.006)	N/A	0.89 (0.035)	0.76 (0.030)	2.54 (0.100)	0.76 (0.030)	N/A
	MAV0020									
1.00 ± 0.15 (0.039±0.006)	1.37 ± 0.15 (0.054±0.006)	0.66 Max (0.026) Max	0.36 ± 0.10 (0.014±0.004)	0.20 ± 0.10 (0.008±0.004)	0.64 REF (0.025)REF	0.46 (0.018)	0.74 (0.029)	1.20 (0.047)	0.30 (0.012)	0.64 (0.025)

Radial Leaded High Temperature Automotive

150°C Rated Radial Leaded TransGuard®



GENERAL DESCRIPTION

AVX High Temperature Multi-Layer Varistors are designed for underhood applications. Products have been tested, qualified, and specified to 150°C. The Radial Leaded TransGuard is built for durability in harsh environments. The MLV advantage is EMI/RFI attenuation in the off state. This allows designers to combine the circuit protection and EMI/RFI attenuation function into a single highly reliable device.

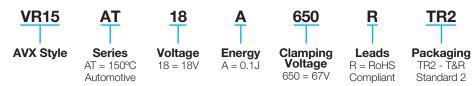
FEATURES

- Rated at 150°C
- AEC Q200 qualified
- ESD rated to 25kV (HBM ESD Level 6)
- EMI/RFI attenuation in off state
- Excellent current and energy handling

APPLICATIONS

- Under hood
- Down Hole Drilling
- · Any high temperature application

HOW TO ORDER



AVX Part Number	Vw (DC)	Vw (AC)	V B	V c	Ет	lР	lι	Jump Start	Сар
VR15AT18A650R	18	13	41 ± 10%	67	0.1	30	10	29	90

V_w(DC) DC Working Voltage [V] $V_w(AC)$ AC Working Voltage [V]

Breakdown Votage [V @ 1mApc] V_{B} V_{C}

Clamping Votage [V @ 1A]

Maximum leakage current at the working voltage [µA] I_{\parallel}

 E_{T} Transient Energy Rating [J, 10x1000µS]

Peak Current Rating [A, 8x20µS]

Capacitance [pF] @ 1KHz specified and 0.5V_{RMS} Cap

Jump Start Max V

PHYSICAL DIMENSIONS

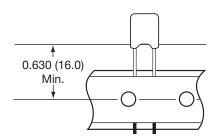
150 (3.81) 100 (2.54)±.030

mm (inches)

Width	Height	Thickness	Lead Spacing	Lead Diameter
4.32 Max.	3.81	2.54	2.54	0.508
(0.170)	(0.150)	(0.100)	(0.100)	(0.020)

TAPE & REEL PACKAGING OPTIONS

TR1 Tape & Reel Standard 1



0.478 (19.0) Min.

TR2

Tape & Reel Standard 2

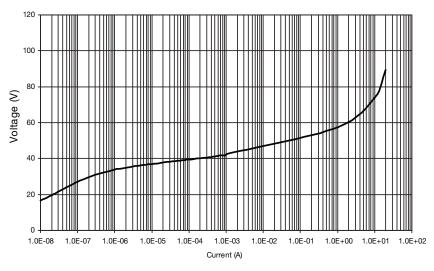


Radial Leaded High Temperature Automotive

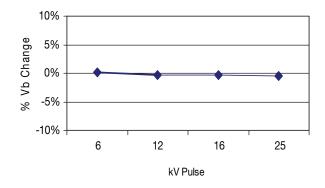
150°C Rated Radial Leaded TransGuard®

TYPICAL PERFORMANCE CURVES

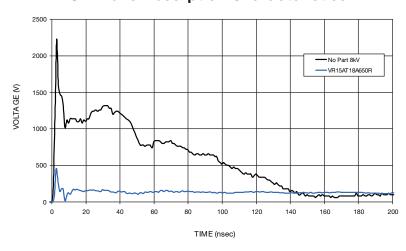
Voltage/Current Characteristics



AEC-Q200-002 ESD Characteristics



ESD Wave Absorption Characteristics

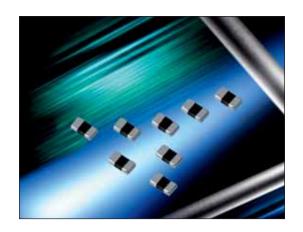


8 kV ESD Vc (150pF/330ohm IEC Network)



Controlled Capacitance Multilayer Varistor





GENERAL DESCRIPTION

The Controlled Capacitance TransGuard is an application specific bi-directional transient voltage suppressor developed for use in mixed signal environments. The Controlled Cap MLV has three purposes: 1) reduce emissions from a high speed ASIC, 2) prevent induced E fields from conducting into the IC, and 3) clamp transient voltages



LEAD-FREE COMPATIBLE COMPONENT

By controlling capacitance of the MLV, the center frequency and 20db range for filtering purposes can be targeted. A Controlled Cap MLV can greatly improve overall system EMC performance and reduce system size.

HOW TO ORDER











R = 4k pcs

TerminationP = Ni Barrier/
100% Sn (matte)

AVX Part Number	Vw (DC)	Vw (AC)	V B	V c	ΙL	Ет	lР	Сар	Cap Tolerance	Case Size
VCAC060322A470NRP	22	17	32.5±25%	50	10	0.1	30	47	30%	0603
VCAC060326C820MRP	26	20	36.0±15%	67	10	0.3	30	82	20%	0603

 $V_{W}(DC)$ DC Working Voltage [V] $V_{W}(AC)$ AC Working Voltage [V]

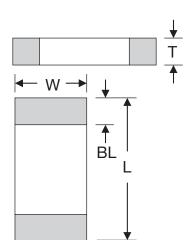
V_B Breakdown Votage [V @ 1mA_{DC}]

V_C Clamping Votage [V @ 1A]

Maximum leakage current at the working voltage [μ A]

 E_T Transient Energy Rating [J, $10x1000\mu$ S] I_P Peak Current Rating [A, $8x20\mu$ S]

Cap Capacitance [pF] @ 1KHz specified and 0.5V_{RMS}

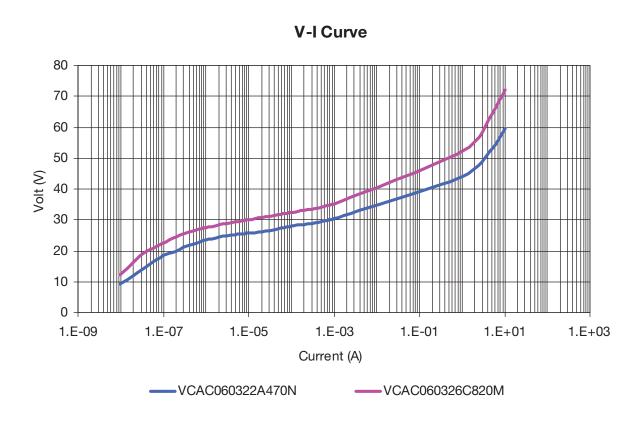


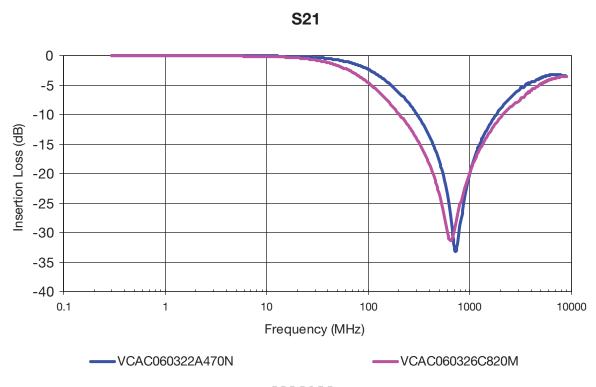
0603 D i	ons	mm (inches)		
L	W	Т	BW	BL
1.60±0.15	0.80±0.15	0.90 MAX	NI/A	0.35±0.15
(0.063±0.006)	(0.031±0.006)	(0.035 MAX)	N/A	(0.014±0.006)



Controlled Capacitance Multilayer Varistor

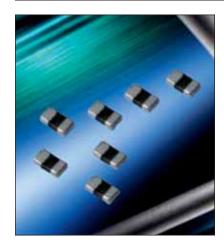






Miniature 0201 MLV

AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for any Circuit with Board Space Constraints



GENERAL DESCRIPTION

AVX 0201 Multi-Layer Varistors are designed for circuits where board space is a premium. 0201 MLV offer bi-directional ESD protection in the smallest package available today. The added advantage is EMI/RFI attenuation. 0201 MLV can replace 2 diodes and the EMC capacitor for a one chip solution.





The miniature size and one chip solution team to offer designers the best in ESD protection and EMI filtering in one ultra compact device.

APPLICATIONS

- Cell phone
- PDA
- · Camera modules
- Embedded components
- Hearing aid
- Any circuit with space constraints

FEATURES

- Capacitance 15pF to 150pF
- Low V_B Version

TVS Dodes

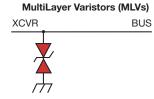
DIODE PROTECTION METHOD

- Bi-Directional protection
- Fastest response time to ESD strikes
- Multi-strike capability

BUS

EMC

• Ultra compact 0201 case size



MLV PROTECTION METHOD SINGLE COMPONENT SOLUTION TVS & EMI



XCVR

TVS + EMI

HOW TO ORDER



AVX Part Number	V _W (DC)	V _W (AC)	V _B	V _C	I _{vc}	IL	E _T	l _P	Сар
VC020103V101WP	3.5	2.0	4.76 min 8.84 max	14max	1	50	0.02	10	100pF ±30%
VC020103V121WP	3.5	2.0	4.76 min 8.84 max	14max	1	50	0.02	10	125pF ±30%
VC020103V151WP	3.5	2.0	4.76 min 8.84 max	14max	1	50	0.02	10	150pF ±30%
VC020105T150WP	5.6	4.0	10.0 min 15.6 max	35max	1	50	0.01	2	15pF ±30%
VC020105T330WP	5.6	4.0	10.0 min 15.6 max	35max	1	50	0.01	4	33pF ±30%
VC020105T500WP	5.6	4.0	10.0 min 15.6 max	35max	1	50	0.01	5	50pF ±30%
VC020105T101WP	5.6	4.0	10.0 min 15.6 max	35max	1	50	0.01	5	100pF ±30%
VC020105V101WP	5.6	4.0	6.4 min 9.6 max	17max	1	50	0.02	4	100pF ±30%
VC020107V101WP	7.0	5.6	9.6 min 14.4 max	20max	1	50	0.02	5	100pF ±30%
VC020116T150WP	16	11	21.7 min 29.3 max	45max	1	50	0.01	1	15pF ±30%

 $V_w(DC)$ DC Working Voltage [V] AC Working Voltage [V] $V_w(AC)$

Breakdown Votage [V @ 1mADC] V_{R} Clamping Votage IV @ IVC1

 V_{c} Test Current for VC [A, 8x20µS] I_{VC}

Maximum leakage current at the working voltage [µA]

Transient Energy Rating [J, 10x1000µS] $E_{\scriptscriptstyle T}$ Peak Current Rating [A, 8x20µS]

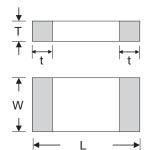
Capacitance [pF] @ 1KHz specified and 0.5VRMS



Miniature 0201 MLV

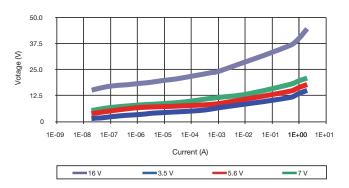
AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for any Circuit with Board Space Constraints

PHYSICAL DIMENSIONS: mm (inches)

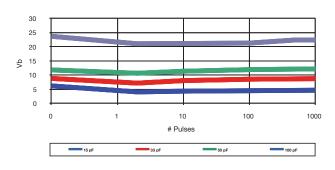


Size (EIA)	Lenght (L)	Width (W)	Max Thickness (T)	Terminal (t)
0201	0.60±0.03	0.30±0.03	0.33 max.	0.15±0.05
0201	(0.024±.001)	(0.011±0.001)	(0.013 max.)	(0.006±0.002)

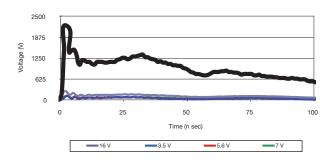
VOLTAGE/CURRENT CHARACTERISTICS



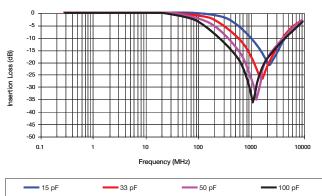
TYPLICAL 8 KV ESD PERFORMANCE (150pF / 300ohm IEC Network)



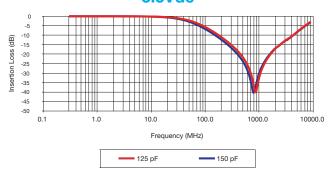
8kV CONTACT ESD vs PULSE 1 Mohm Input (150pF / 330ohm Network)

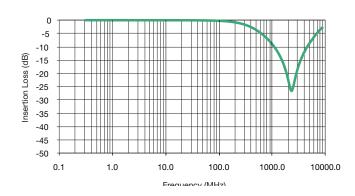


TRANSMISSION CHARACTERISTICS 5.6Vdc



3.5Vdc





High Temperature Automotive

150°C Rated Varistors



GENERAL DESCRIPTION

AVX High Temperature Multi-Layer Varistors are designed for underhood applications. Products have been tested, qualified, and specified to 150°C. The MLV advantage is EMI/RFI attenuation in the off state. This allows designers the ability to combine the circuit protection and EMI/RFI attenuation function into a single highly reliable device.





FEATURES

- Rated at 150°C
- AEC Q200 qualified
- ESD rating to 25kV contact
- EMI/RFI attenuation in off state
- Excellent current and energy handling
- Down Hole

Under hood

Down Hole Drilling

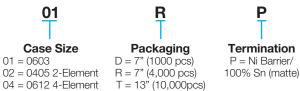
APPLICATIONS

• Any high temperature application

CAN SERIES

HOW TO ORDER





AVX Part Number	V _W (DC)	V _W (AC)	V _B	ΙL	E _T	l _P	Cap	Case Size	Elements
CANAT01	≤ 18	≤ 14	120	10	0.015	4	22	0603	1
CANAT02	≤ 18	≤ 14	70	10	0.015	4	22	0405	2
CANAT04	≤ 18	≤ 14	100	10	0.015	4	22	0612	4

 $V_{w}(DC)$ DC Working Voltage [V] $V_{w}(AC)$ AC Working Voltage [V]

 V_{B} Breakdown Votage [V @ 1mA $_{DC}$] V_{C} Clamping Votage [V @ IVC]

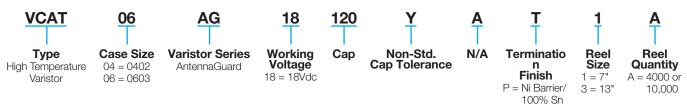
Maximum leakage current at the working voltage [µA]

 E_T Transient Energy Rating [J, $10x1000\mu$ S] I_P Peak Current Rating [A, $8x20\mu$ S]

Cap Capacitance [pF] @ 1KHz specified and 0.5VRMS

ANTENNAGUARD SERIES

HOW TO ORDER



AVX Part Number	V _W (DC)	V _W (AC)	I _L	Cap	Cap Tolerance	Case Size
VCAT06AG18120YAT	≤ 18	≤ 14	10	12	+4, -2pF	0603

 $\begin{array}{lll} V_{\text{W}}(\text{DC}) & \text{DC Working Voltage [V]} & \text{I}_{\text{L}} & \text{Maximum leakage current at the working voltage } [\mu\text{A}] \\ V_{\text{W}}(\text{AC}) & \text{AC Working Voltage [V]} & \text{Cap acitance [pF] @ 1KHz specified and 0.5VRMS} \end{array}$

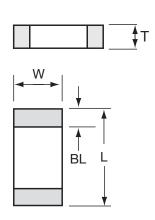


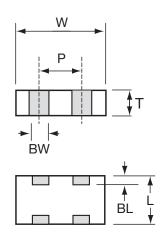
High Temperature Automotive

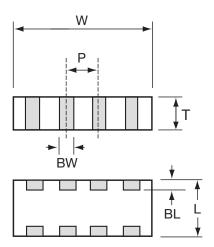


150°C Rated Varistors

PHYSICAL DIMENSIONS







0603 Discrete Dimensions

ı	mm (inches)
RΙ	D

L	W	Т	BW	BL	Р
1.60±0.15 (0.063±0.006)	0.80±0.15 (0.032±0.006)	0.90 MAX (0.035 MAX)	N/A	0.35±0.15 (0.014±0.006)	N/A

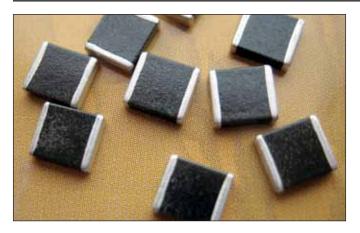
0405 2 Elements Array Dimensions mm (inches)

L	W	Т	BW	BL	Р
1.00±0.15	1.37±0.15	0.66 MAX	0.36±0.10	0.20±0.10	0.64 REF
(0.039±0.006)	(0.054±0.006)	(0.026 MAX)	(0.014±0.004)	(0.008±0.004)	(0.025 REF)

0612 4 Elements Array Dimensions mm (inches)

L	W	T	BW	BL	Р
1.60±0.20	3.20±0.20	1.22 MAX	0.41±0.10	0.18 +0.25	0.76 REF
(0.063±0.008)	(0.126±0.008)	(0.048 MAX)	(0.016±0.004)	(0.008 +.010)	(0.030 REF)

Transient Voltage Suppression, ESD Protection Devices & EMI Devices



GENERAL DESCRIPTION

AVX's Professional Multilayer Varistors include 3 series of glass coated products as listed below:

- Standard M0 Series
- Telecom MT Series
- Automotive MA/PA Series

The glass encapsulation process ensures high insulation resistance values after reflow soldering and excellent SMT compatibility. This protection ensures reliability and acid-resistance against harsh environment like chlorite flux.





TYPICAL APPLICATIONS

Mainly used to reduce transient over-voltages in a very wide range of electronic products. Some example applications are:

1) Telecom, 2) Automotive, 3) Consumer Electronics, and 4) Industrial Applications.

PHYSICAL CHARACTERISTICS

Construction Weight: <0.2g

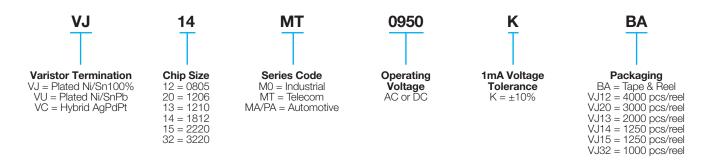


- 1 Zinc varistor
- 2 Glass lead-free encapsulation
- 3 Silver termination
- 4 Nickel barrier
- 5 Tin 100%

PHYSICAL DIMENSIONS: mm (inches)

	Туре	IEC Size	L	w	Т	Land Length t
	VJ12	0805	2.01±0.20 (0.079±0.008)	1.25±0.15 (0.049±0.006)	1.3 max. (0.051 max.)	0.150.55 (0.0060.022)
W	VJ20	1206	3.20±0.20 (0.126±0.008)	1.60±0.20 (0.063±0.008)	1.7 max. (0.067 max.)	0.250.75 (0.0100.030)
	VJ13	1210	3.20±0.30 (0.126±0.012)	2.50±0.25 (0.098±0.010)	1.7 max. (0.067 max.)	0.250.75 (0.0100.030)
	VJ14	1812	4.50±0.30 (0.177±0.012)	3.20±0.30 (0.126±0.012)	2.0 max. (0.079 max.)	0.251.00 (0.0100.039)
1	VJ15	2220	5.70±0.40 (0.224±0.016)	5.00±0.40 (0.197±0.016)	2.5max. (0.098 max.)	0.251.00 (0.0100.039)
	VJ32	3220	8.20±0.40 (0.323±0.016)	8.20±0.40 (0.323±0.016)	2.5 max. (0.098 max.)	0.251.00 (0.0100.039)

PART NUMBERING





Automotive MLV Range - MA and PA Series

AUTOMOTIVE SERIES - VJ12, 20, 13, 14, 15, 32 MA and PA SERIES

FEATURES

- Available in case size 0805, 1206, 1210, 1812, 2220, (3220 under development)
- Nickel and Tin (100%) plated Termination
- Max Energy absorption: 1.5 to 25J (50J under development)
- Well suited to protect against automotive related transients
- Load Dump capabilities: according to ISO standard DP7637-2 12V and 24V pulse 5
- Jump start capability (12V): 24.5 V 5mn
- Complying to main requirements of AECQ 200
- RoHS Compliant and IMDS Registration

GENERAL CHARACTERISTICS

Storage Temperature: -55°C to +150°C Operating Temperature: -55°C to +125°C*

APPLICATIONS

- Protection of various semiconductor elements from overvoltage.
- Absorption of switching surge and electrostatic surge for relays and motors.
- Protection of electronic equipment for automobiles from induced lightning surge.

PART NUMBERS

Part Number	Case Size EIA	Working Voltage	Breakdown Voltage	Peak current	Maximum leakage current at Vdc	Energy 10*1000μs	Energy Load-Dump (x10)	Jump Start	T max
		Vdc	V(1mA)	Amp. 8*20μs	μА	Joules	Joules	Vmax (5mn min.)	Thickness mm (inches)
*VJ12PA0160	0805	16	24.5	120	20	0.3	1	24.5	1.3
VJ20MA0160	1206	16	24.5	200	20	0.6	1.5	24.5	1.7
VJ20PA0160	1206	16	24.5	300	20	1.1	2	24.5	1.7
VJ13MA0160	1210	16	24.5	400	20	1.6	3	24.5	1.7
VJ13PA0160	1210	16	24.5	500	20	2	5	24.5	1.7
VJ14MA0160	1812	16	24.5	800	20	2.4	6	25.5	2
VJ14PA0160	1812	16	24.5	1000	20	2.9	10	25.5	2
VJ15MA0160	2220	16	24.5	1200	20	5.8	12	25.5	2
VJ15PA0160	2220	16	24.5	1500	20	7.2	25	25.5	2
VJ32PA0160	3220	16	24.5	2000	20	13.8	50	24.5	2.5
VJ15MA0340	2220	34	47	1200	20	10	12	47	2.5
VJ15PA0340	2220	34	47	2000	20	13	25	47	2.5
*VJ32PA0340	3220	34	47	2000	20	19	50	47	2.5

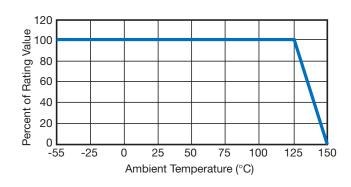
^{*} under development

Hybrid termination AgPdPt upon request

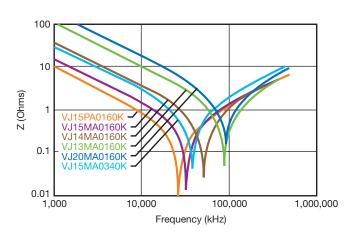


TEMPERATURE CHARACTERISTICS

For Current, Energy and Power



IMPEDANCE CHARACTERISTICS

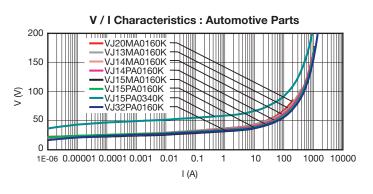


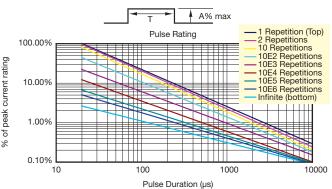


^{* 150°}C upon request

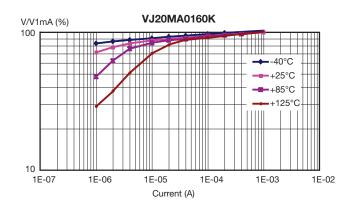
Automotive MLV Range – MA and PA Series

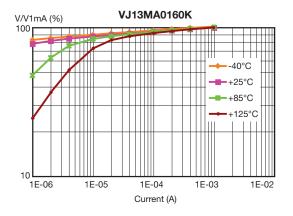
AUTOMOTIVE SERIES – VJ12, 20, 13, 14, 15, 32 MA and PA SERIES V / I CHARACTERISTICS PULSE RATING

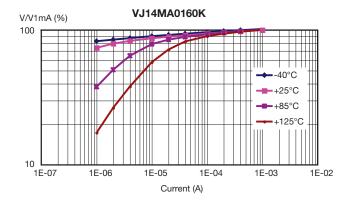


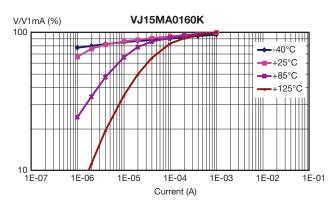


TEMPERATURE DEPENDENCE OF V/I CHARACTERISTICS







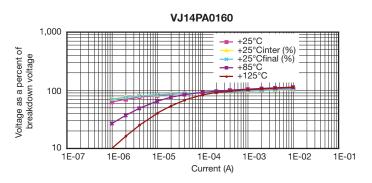


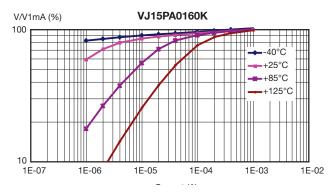


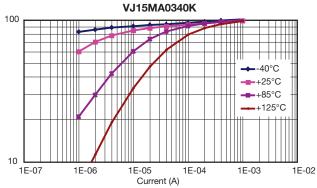


Automotive MLV Range - MA and PA Series

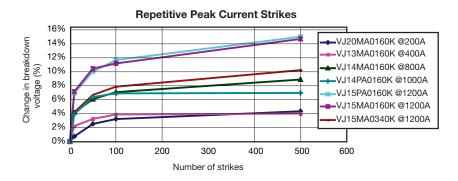
AUTOMOTIVE SERIES - VJ12, 20, 13, 14, 15, 32 MA and PA SERIES







PULSE DEGRADATION



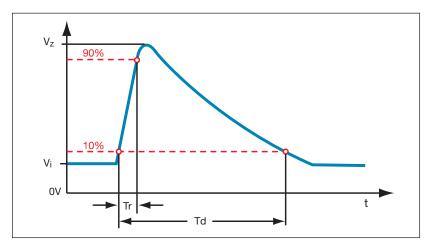




Automotive MLV Range – MA and PA Series

AUTOMOTIVE SERIES – VJ12, 20, 13, 14, 15, 32 MA and PA SERIES AUTOMOTIVE LOAD DUMP TEST

(According to ISO DP7637/2 Pulse 5)



When using the test method indicated below, the amount of Energy dissipated by the varistor must not exceed the Load Dump Energy value specified in the product table.

Voltage Pulse applied to the varistor:

12V Network

Vi = 13.5V

Td = 100 to 350 ms

Ri = 2 Ohms (Internal Resistance)

Vz - 70 to 200V

Number of Pulses = 10 Pulses

Other Load Dump Simulations can be achieved

24V Network

Vi = 27V

Td = 100 to 350 ms

Ri = 2 Ohms (Internal Resistance)

Vz - 70 to 200V

Number of Pulses = 10 Pulses

Pulse 5: Typical Vz max versus Pulse duration and Rs

VJ20MA0160K	0.5 Ohm	1 Ohm	2 Ohms
50ms	33	34	39
100ms	31	31	34
200ms	27	28	33
400ms	28	30	34
VJ13PA0160K	0.5 Ohm	1 Ohm	2 Ohms
50ms	44	48	57
100ms	36	39	46
200ms	33	33	39
400ms	29	28	34
VJ14PA0160K	0.5 Ohm	1 Ohm	2 Ohms
50ms	60	68	85
100ms	46	52	62
200ms	37	41	50
400ms	32	35	43
VJ15PA0160K	0.5 Ohm	1 Ohm	2 Ohms
50ms	98	116	150
100ms	66	80	104
200ms	50	60	78
400ms	41	47	58
VJ32PA0160K	0.5 Ohm	1 Ohm	2 Ohms
50ms	146	186	200
100ms	105	131	179
200ms	72	88	113
400ms	54	67	96





Glass Encapsulated SMD Varistor MLV / (VJ12, 20, 13, 14, 15)

Industrial MLV Range – M0 Series

INDUSTRIAL MLV RANGE - VJ12, 20, 13, 14, 15 M0 SERIES

FEATURES

- Glass encapsulation device with very low leakage current under DC operating conditions
- Device available in case size 1206, 1210, 1812, 2220 (3220)
- Nickel and Tin (100%) plated Termination (Hybrid AgPdPt termination available upon request)
- Bi-Directional protection. Fast Turn-On Time.
- Excellent transient clamping characteristics up to 1200amps peak current
- Multi strike capability. Provide EMC Capacitance
- RoHS Compliant

GENERAL CHARACTERISTICS

Storage Temperature: -55°C to +150°C Operating Temperature: -55°C to +125°C

TYPICAL APPLICATIONS

Many uses to reduce transient over-voltage in the very wide range of electronic products in the Professional, Industrial and Consumer Applications.

Туре	Case Size	Vrms	VDC	Breakdown Voltage	Max. Clamping Voltage		Maximum Leakage Current	Energy 10*1000µs	Max. Peak Current 8*20µs	Cap. Typical (1KHz/0.5V)
		(V)	(V)	(V)	Vp (V)	lp (A)	μA	(J)	(A)	(pF)
VJ20M00140K	1206	14	18	22±10%	38	1	20	0.5	200	900
VJ13M00140K	1210	14	18	22±10%	38	2.5	20	1.6	400	1800
VJ14M00140K	1812	14	18	22±10%	38	5	20	2.3	800	4200
VJ15M00140K	2220	14	18	22±10%	38	10	20	5.8	1200	9600
VJ20M00170K	1206	17	22	27±10%	44	1	20	0.6	200	800
VJ13M00170K	1210	17	22	27±10%	44	2.5	20	1.7	500	2500
VJ14M00170K	1812	17	22	27±10%	44	5	20	2.7	800	3700
VJ15M00170K	2220	17	22	27±10%	44	10	20	7.2	1200	8600
VJ20M00200K	1206	20	26	33±10%	54	1	20	0.7	200	550
VJ13M00200K	1210	20	26	33±10%	54	2.5	20	1.9	500	1200
VJ14M00200K	1812	20	26	33±10%	54	5	20	3	800	2800
VJ15M00200K	2220	20	26	33±10%	54	10	20	7.8	1200	6400
VJ20M00250K	1206	25	31	39±10%	65	1	20	1	200	500
VJ13M00250K	1210	25	31	39±10%	65	2.5	20	1.7	500	1100
VJ14M00250K	1812	25	31	39±10%	65	5	20	3.7	800	2600
VJ15M00250K	2220	25	31	39±10%	65	10	20	9.6	1200	5800
VJ20M00300K	1206	30	38	47±10%	77	1	20	1.1	200	400
VJ13M00300K	1210	30	38	47±10%	77	2.5	20	2	400	1200
VJ14M00300K	1812	30	38	47±10%	77	5	20	4.2	800	1800
VJ15M00300K	2220	30	38	47±10%	77	10	20	12	1200	4200
VJ20M00350K	1206	35	45	56±10%	90	1	20	0.6	200	260
VJ13M00350K	1210	35	45	56±10%	90	2.5	20	1.5	300	1200
VJ14M00350K	1812	35	45	56±10%	90	5	20	4	500	2500
VJ15M00350K	2220	35	45	56±10%	90	10	20	10	1000	4000
VJ20M00400K	1206	40	56	68±10%	110	1	20	0.7	100	190
VJ13M00400K	1210	40	56	68±10%	110	2.5	20	2.3	250	380
VJ14M00400K	1812	40	56	68±10%	110	5	20	4.8	500	800
VJ15M00400K	2220	40	56	68±10%	110	10	20	9	1000	2000
VJ20M00500K	1206	50	65	82±10%	135	1	20	0.8	100	130
VJ13M00500K	1210	50	65	82±10%	135	2.5	20	1.6	250	700
VJ14M00500K	1812	50	65	82±10%	135	5	20	4.5	400	600
VJ15M00500K	2220	50	65	82±10%	135	10	20	7	800	1400
VJ20M00600K	1206	60	85	100±10%	165	1	20	0.9	100	100
VJ13M00600K	1210	60	85	100±10%	165	2.5	20	1.5	250	600
VJ14M00600K	1812	60	85	100±10%	165	5	20	4.5	400	500
VJ15M00600K	2220	60	85	100±10%	165	10	20	6.8	800	1100

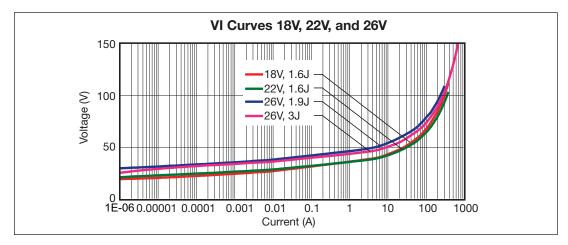


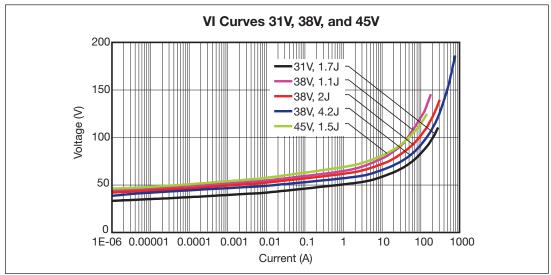


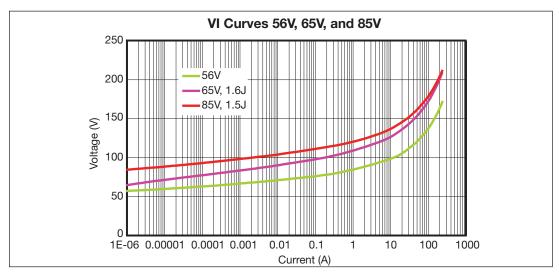
Glass Encapsulated SMD Varistor MLV / (VJ12, 20, 13, 14, 15)

Industrial MLV Range - M0 Series

INDUSTRIAL MLV RANGE – VJ12, 20, 13, 14, 15 M0 SERIES V/I CHARACTERISTIC











Glass Encapsulated SMD Varistor MLV / (VJ14)

Telecom MLV Range – MT Series

TELECOM MLV RANGE - VJ14 MT SERIES

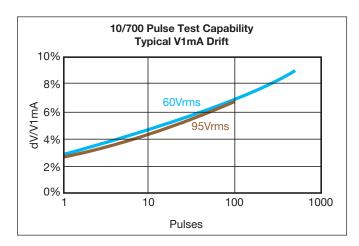
FEATURES

- Effective alternative to leaded MOVs between 60 and 90 Vrsm
- High Energy Ratings up to 6 Joules with 1812 case size
- Nickel barrier or hybrid AgPdPt terminations
- Multiple Strike Capability
- Provide EMC Capacitance
- Specified in accordance to CCITT 10/1000µs Pulse test
- RoHS Compliant and IMDS Registration

CCITT 10x700µs TEST

A pulse of 10 x 700µs duration as specified by CCITT or IEC 61000-4-5 is often used to check the interference immunity of Telecom equipment.

The curves show that the 60Vrms Varistor can reduce the interference of the equipment from 2KV to less than 200V.

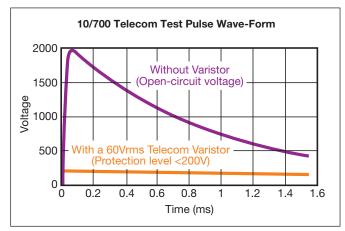


TARGET APPLICATIONS

- Phone Lines, ADSL Lines, and other Telecom Circuits
- Consumer Products

GENERAL CHARACTERISTICS

Storage Temperature: -55°C to +125°C Operating Temperature: -55°C to +125°C



Ten pulses with a duration of 10x700µs applied at one minute intervals are specified for telecom equipment.

The curves show the V1mA drift when more than 10 pulses are applied.

PART NUMBERS

Part Number	Case Size	Operating	g Voltage	Breakdown Voltage	own ge Max. Clamping Voltage		Max. Clamping Voltage CCITT 10 Pulses 10*700µs 8*20µ:		Energy 10*1000µs	Mean Power Dissipation	Typical Cap.
	EIA	Vac	Vdc	V(1mA)	V	Amp.	Amp.	Amp.	Joules	W	pF
VJ14MT0600	1812	60	85	100	400	45	45	400	6	0.015	400
VJ14MT0750	1812	75	100	120	400	45	45	400	6	0.015	400
VJ14MT0950	1812	95	125	150	250	45	45	250	5	0.015	250

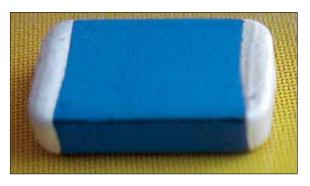
Hybrid termination AgPdPt (VC Range) upon request





Glass Encapsulated SMD Varistor MLV / (VC32)

Single Layer SLV Range - M0 Series



FEATURES

- Lead less surface mount chip 3220 Case Size
- Voltage Ratings from 175Vrms to 300 Vrms
- VC32 with hybrid Ag-100% Terminations
- Operating temperature from -55°C to +125°C
- RoHS Compliant

GENERAL DESCRIPTION

The VC32M0 Series offers the designer a surface mount solution with higher voltage ratings and transient energy ratings. This Single Layer Surface Mount Varistor replaces the traditional radial-lead Varistors with reduced size and weight. The glass encapsulation ensures the high performances in voltage up to 300Vrms reliability and acid-resistance against harsh environment like chlorite soldering flux.





APPLICATIONS

- MOV (Radial) Replacement
- Suppression of transient on line voltage
- Electric Meters
- Industrial Equipment
- Mains PSUs
- Telecommunications
- Consumer Electronics

PART NUMBERS

Part Number	Operating	Operating Voltage Max. Max. Clamping Leakage 8*20µs		-			Cap. Typical (1KHz/0.5V)	
	Vrms	Vdc	μΑ	V	Α		J	pF
VC32M01750K	175	270	100	455	10	400	15	135
VC32M00231K	230	360	50	595	10	400	20	100
VC32M00251K	250	390	50	650	10	400	21	90
VC32M02750K	275	430	50	710	10	400	23	80
VC32M00301K	300	470	50	775	10	400	23	70



Glass Encapsulated SMD Varistor MLV (VJ13, 14, 15, 20)

Surface Mounting Guide

SURFACE MOUNTING GUIDE (VJ13, 14, 15, 20) APPLICATIONS NOTES

SOLDERABILITY/LEACHING

Terminations to be well soldered after immersion in a 60/40 tin/lead solder bath at $235\pm5^{\circ}\text{C}$ for 2 ± 1 seconds. Terminations will resist leaching for at least the immersion times and conditions recommendations shown below.

P/N	Termination Type	Solder Tin/Lead	Solder Temp. °C	Immersion Time (sec)
VC	Unplated MLV Hybrid Termination	60/40	260±5	15 max
VJ	Plated MLV Nickel and Matte Tin Plating Termination	60/40	260±5	30±1

will need to be modified as lead free joints are not as bright as with tin-lead pastes and the fillet may not be as large.

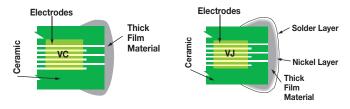
b) Lead-free solder pastes do not allow the same self align-

a) The visual standards used for evaluation of solder joints

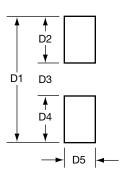
 b) Lead-free solder pastes do not allow the same self alignment as lead containing systems. Standard mounting pads are acceptable, but machine set up may need to be modified.

Unplated MLV

Plated MLV



RECOMMENDED SOLDER PAD LAYOUT



RECOMMENDED SOLDERING PROFILES

VJ products are compatible with a wide range of soldering conditions consistent with good manufacturing practice for surface mount components. This includes Pb free reflow processes and peak temperatures up to 270°C. Recommended profiles for reflow and wave soldering are show below for reference.

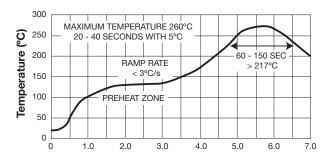
VC products are recommended for lead soldering application or gluing techniques.

REFLOW SOLDERING

Dimensions in mm (inches)

	Case Size	D1	D2	D3	D4	D5
	1206	4.00 (0.157)	1.00 (0.039)	2.00 (0.079)	1.00 (0.039)	1.06 (0.042)
	1210	4.00 (0.157)	1.00 (0.039)	2.00 (0.079)	1.00 (0.039)	2.05 (0.081)
	1812	5.60 (0.220)	1.00 (0.039)	3.60 (0.142)	1.00 (0.039)	3.00 (0.118)
Ì	2220	6.60 (0.260)	1.00 (0.039)	4.60 (0.181)	1.00 (0.039)	5.00 (0.197)
	3220	10.21 (0.402)	2.21 (0.087)	5.79 (0.228)	2.21 (0.087)	5.50 (0.217)

VJ Products Lead-Free Reflow Profile



WAVE SOLDERING

Dimensions in mm (inches)

Case Size	D1	D2	D3	D4	D5	
1206	5.00 (0.197)	1.50 (0.059)	2.00 (0.079)	1.50 (0.059)	1.06 (0.042)	
1210	5.00 (0.197)	1.50 (0.059)	2.00 (0.079)	1.50 (0.059)	2.05 (0.081)	
1812	6.60 (0.260)	1.50 (0.059)	3.60 (0.142)	1.50 (0.059)	3.00 (0.118)	
2220	7.60 (0.299)	1.50 (0.059)	4.60 (0.181)	1.50 (0.059)	5.00 (0.197)	
3220	11.21 (0.441)	1.50 (0.059)	5.79 (0.228)	1.50 (0.059)	5.50 (0.217)	





StaticGuard

AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for CMOS, Bi Polar and SiGe Based Systems

GENERAL INFORMATION

- Typical ESD failure voltage for CMOS and/or Bi Polar is ≥ 200 V.
- 15kV ESD pulse (air discharge) per IEC 1000-4-2, Level 4, generates < 20 millijoules of energy.
- Low capacitance (<200pF) is required for high-speed data transmission.
- Low leakage current (I,) is necessary for battery operated equipment.

StaticGuard

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Clamping Voltage	Test Current For V _c	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap	Case Size	Elements
VC04LC18V500	≤18.0	≤14.0	50	1	10	0.02	15	40	0402	1
VC06LC18X500	≤18.0	≤14.0	50	1	10	0.05	30	50	0603	1
VC08LC18A500	≤18.0	≤14.0	50	1	10	0.10	30	80	0805	1
VC12LC18A500	≤18.0	≤14.0	50	1	10	0.10	30	200	1206	1
VA10LC18A500	≤18.0	≤14.0	50	1	10	0.10	30	200	Axial	1

L Termination/Lead Finish Code

Packaging Code

 $V_{w}(DC)$ DC Working Voltage (V)

 $V_{w}(AC)$ AC Working Voltage (V)

 V_{c} Clamping Voltage (V @ I_{VC})

Test Current for V_c (A, 8x20µS)

Maximum Leakage Current at the Working Voltage (µA)

Е Transient Energy Rating (J. 10x1000µS)

 $|_{p}$ Peak Current Rating (A, 8x20µS)

Typical Capacitance (pF) @ frequency specified and 0.5 V Cap

Not RoHS Compliant







For RoHS compliant products. please select correct termination style.

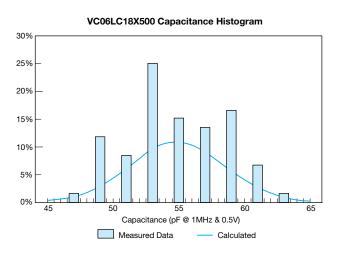
PART NUMBER IDENTIFICATION

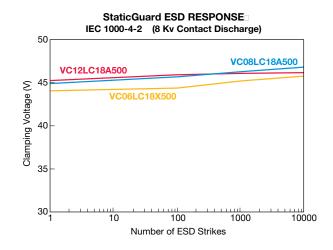
Chips Axials V A 10 LC 18 A 500 R L V C 08 LC 18 A 500 R P **TERMINATION FINISH: LEAD FINISH:** P = Ni/Sn Alloy (Plated) L = Copper Clad Steel, Solder Coated PACKAGING (Pcs/Reel) PACKAGING (Pcs/Reel) **CLAMPING VOLTAGE CLAMPING VOLTAGE ENERGY RATING ENERGY RATING WORKING VOLTAGE (0-18VDC) WORKING VOLTAGE (0-18VDC)** LOW CAPACITANCE DESIGN LOW CAPACITANCE DESIGN **CASE SIZE DESIGNATOR CASE SIZE DESIGNATOR CASE STYLE CASE STYLE** PRODUCT DESIGNATOR PRODUCT DESIGNATOR

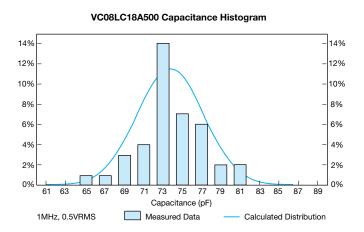
StaticGuard

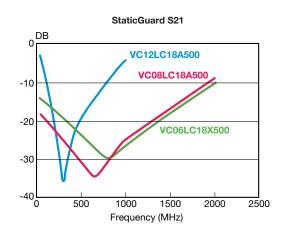
AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for CMOS, Bi Polar and SiGe Based Systems

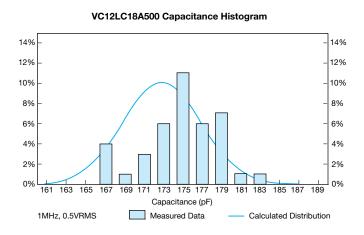
TYPICAL PERFORMANCE DATA

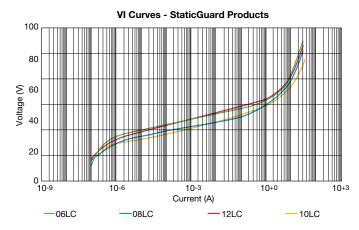














StaticGuard

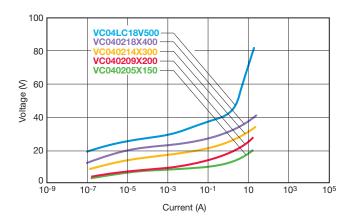


AVX Multilayer Ceramic Transient Voltage Suppressors

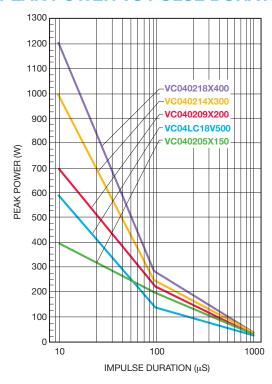
TYPICAL PERFORMANCE CURVES (0402 CHIP SIZE)

VOLTAGE/CURRENT CHARACTERISTICS

Multilayer construction and improved grain structure result in excellent transient clamping characteristics up to 20 amps peak current, while maintaining very low leakage currents under DC operating conditions. The VI curves below show the voltage/current characteristics for the 5.6V, 9V, 14V, 18V and low capacitance StaticGuard parts with currents ranging from parts of a micro amp to tens of amps.



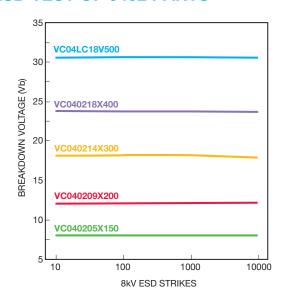
PEAK POWER VS PULSE DURATION



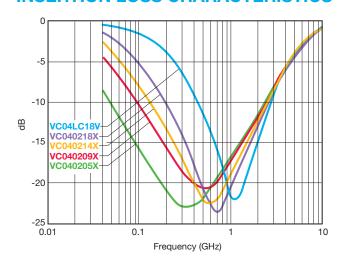
PULSE DEGRADATION

Traditionally varistors have suffered degradation of electrical performance with repeated high current pulses resulting in decreased breakdown voltage and increased leakage current. It has been suggested that irregular intergranular boundaries and bulk material result in restricted current paths and other non-Schottky barrier paralleled conduction paths in the ceramic. Repeated pulsing of TransGuard® transient voltage suppressors with 150Amp peak 8 x 20µS waveforms shows negligible degradation in breakdown voltage and minimal increases in leakage current. This does not mean that TransGuard® suppressors do not suffer degradation, but it occurs at much higher current.

ESD TEST OF 0402 PARTS



INSERTION LOSS CHARACTERISTICS

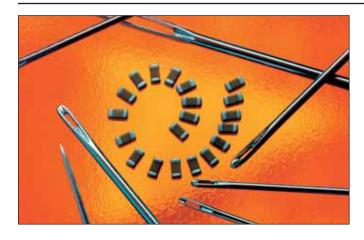




StaticGuard Automotive Series



Multilayer Varistors for Automotive Applications



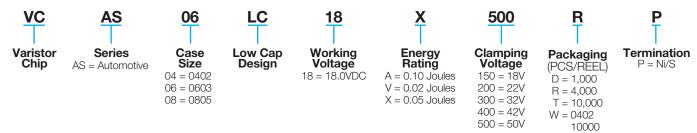
GENERAL DESCRIPTION

The StaticGuard Automotive Series are low capacitance versions of the TransGuard and are designed for general ESD protection of CMOS, Bi-Polar, and SiGe based systems. The low capacitance makes these products suitable for use in high speed data transmission lines.

FEATURES

- AEC Q200 Qualified
- ISO 7637 Pulse 1-3 capability
- Meet 27.5Vdc Jump Start requirements
- Multi-strike capability
- Sub 1nS response to ESD strike

HOW TO ORDER



ELECTRIAL CHARACTERISTICS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Clamping Voltage	Test Current For V _c	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap	Case Size	Power Dissipation
VCAS04LC18V500	≤18.0	≤14.0	50	1	10	0.02	15	40	0402	0.0004
VCAS06LC18X500	≤18.0	≤14.0	50	1	10	0.05	30	50	0603	0.001
VCAS08LC18A500	≤18.0	≤14.0	50	1	10	0.10	30	80	0805	0.002

 $\begin{array}{lll} V_w(DC) & DC \ Working \ Voltage \ (V) \\ V_w(AC) & AC \ Working \ Voltage \ (V) \\ V_c & Clamping \ Voltage \ (V @ I_{vc}) \\ I_{VC} & Test \ Current \ for \ V_c \ (A, \ 8x20\mu S) \end{array}$

I₁ Maximum Leakage Current at the Working Voltage (μΑ)

E_T Transient Energy Rating (J, 10x1000μS)

I_P Peak Current Rating (A, 8x20μS)

Cap Typical Capacitance (pF) @ frequency specified and 0.5 V_{RMS}

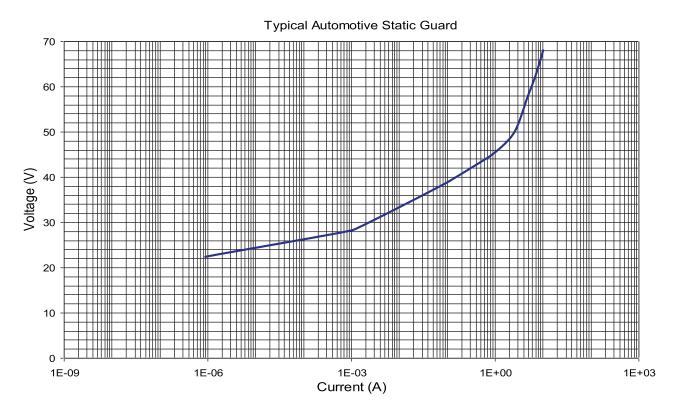


StaticGuard Automotive Series



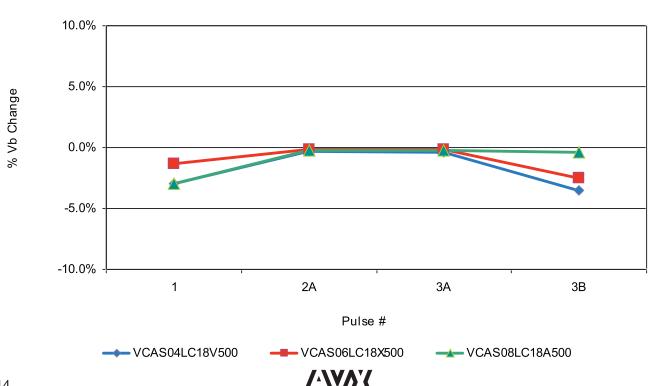
Multilayer Varistors for Automotive Applications

VOLTAGE/CURRENT CHARACTERISTICS



ELECTRICAL TRANSIENT CONDUCTION

ISO 7637 Pulse 1-3

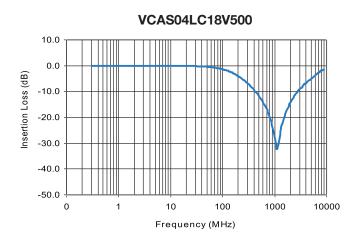


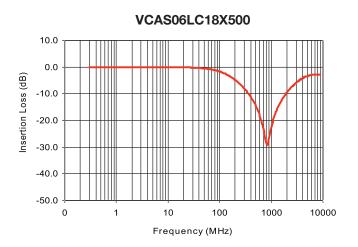
StaticGuard Automotive Series

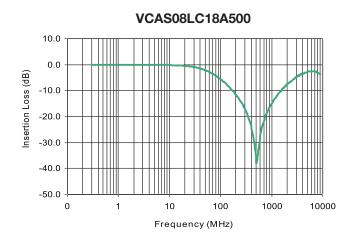


Multilayer Varistors for Automotive Applications

VOLTAGE/CURRENT CHARACTERISTICS







MultiGuard (2&4 Elements)





GENERAL DESCRIPTION AND COMMENTS

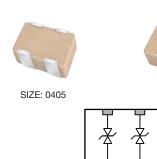
AVX's Transient Voltage Suppression (TVS) Arrays address six trends in today's electronic circuits: (1) mandatory ESD protection, (2) mandatory EMI control, (3) signal integrity improvement, (4) PCB downsizing, (5) reduced component placement costs, and (6) protection from induced slow speed transient voltages and currents.

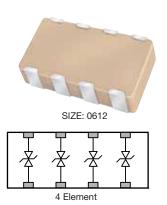
AVX's MultiGuard products offer numerous advantages, which include a faster turn-on-time (<1nS), repetitive strike capability, and space savings. In some cases, MultiGuard consumes less than 75% of the PCB real estate required for the equivalent number of discrete chips. This size advantage, coupled with the savings associated with placing only one chip, makes MultiGuard the TVS component of choice for

ESD protection of I/O lines in portable equipment and programming ports in cellular phones. Other applications include differential data line protection, ASIC protection and LCD driver protection for portable computing devices.

Where multiple lines require the ESD protection, the 4-element 0612 chip is an ideal solution. The 2-element 0405 MultiGuard is the smallest TVS array device available in the market today.

Available with standard working voltage of 5.6V up to 18V with low capacitance in the 3 case sizes, AVX MultiGuard arrays offer a very broad range of integrated TVS solutions to the design community.





ELECTRICAL CHARACTERISTICS PER ELEMENT

SIZE: 0508

	AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Breakdown Voltage	Clamping Voltage	Test Current For V _c	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap
	MG042S05X150	5.6	4.0	8.5±20%	18	1	35	0.05	15	300
2 Element 0405 Chip	MG042L14V400	14.0	10.0	18.5±12%	32	1	15	0.02	15	45
0403 Onip	MG042L18V500	18.0	14.0	N/A	50	1	10	0.02	15	40
	MG052S05A150	5.6	4.0	8.5±20%	18	1	35	0.10	30	825
	MG052S09A200	9.0	6.4	12.7±15%	22	1	25	0.10	30	550
2 Element 0508 Chip	MG052S14A300	14.0	10.0	19.5±12%	32	1	15	0.10	30	425
0300 Chip	MG052S18A400	18.0	14.0	25.5±10%	42	1	10	0.10	30	225
	MG052L18X500	≤18.0	≤14.0	N/A	50	1	10	0.10	20	50
	MG064S05A150	5.6	4.0	8.5±20%	18	1	35	0.10	30	825
	MG064S09A200	9.0	6.4	12.7±15%	22	1	25	0.10	30	550
4 Element 0612 Chip	MG064S14A300	14.0	10.0	19.5±12%	32	1	15	0.10	30	425
OU 12 CHIP	MG064S18A400	18.0	14.0	25.5±10%	42	1	10	0.05	15	120
	MG064L18X500	≤18.0	≤14.0	N/A	50	1	10	0.10	20	75

L Termination Finish Code Packaging Code

DC Working Voltage (V) AC Working Voltage (V) V_w (AC) Typical Breakdown Voltage

(V @ 1mA_{DC})

V_o Tolerance is ± from Typical Value

Clamping Voltage (V @ I_{vc})

Test Current for V_c (A, 8x20µS) Maximum Leakage Current at the Working Voltage (µA)

Transient Energy Rating (J, 10x1000µS) Peak Current Rating (A, 8x20µS)

Typical Capacitance (pF) @ 1MHz and 0.5 V_{RMS}

MultiGuard (2&4 Elements)

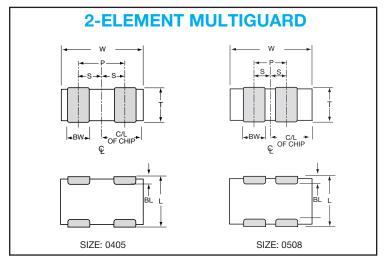
AVX Multilayer Ceramic

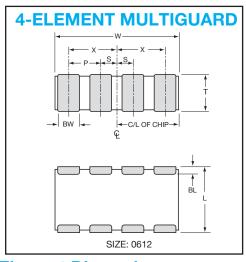
Transient Voltage Suppression Arrays





PHYSICAL DIMENSIONS AND PAD LAYOUT





0405 2 Element Dimensions mm (inches)

L	W	T	BW	BL	Р	S
	1.37±0.15 (0.054±0.006)					

0612 4 Element Dimensions

mm (inches)

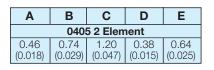
mm (inches)

L	W	Т	BW	BL	P	Х	S
1.60±0.20 (0.063±0.008	3.20±0.20 (0.126±0.008)	1.22 MAX (0.048 MAX)	0.41±0.10 (0.016±0.004)	0.18+0.25 -0.08 (0.007+.010)	0.76 REF (0.030 REF)	1.14±0.10 (0.045±0.004)	0.38±0.10 (0.015±0.004)

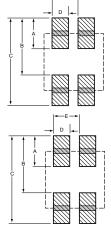
0508 2 Element Dimensions mm (inches)

L	W	T	BW	BL	Р	S
1.25±0.20	2.01±0.20	1.02 MAX	0.41±0.1	0.18 +0.25	0.76 REF	0.38±0.10
(0.049±0.008)	(0.079±0.008)	(0.040 MAX)	(0.016±0.004)	(0.007 +.010)	(0.030 REF)	(0.015±0.004)

Pad Layout Dimensions

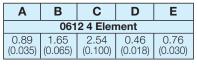


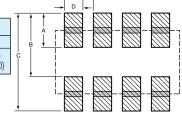
Α	В	С	D	E						
	0508 2 Element									
0.89 (0.035)	1.27 (0.050)	2.16 (0.085)	0.46 (0.018)	0.76 (0.030)						



mm (inches)

Pad Layout Dimensions

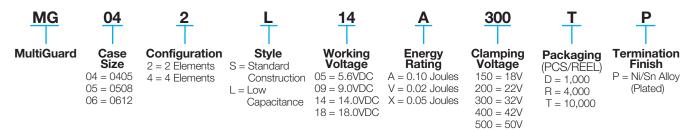








HOW TO ORDER



MultiGuard (2 & 4 Elements)

AVX Multilayer Ceramic

Transient Voltage Suppression Arrays

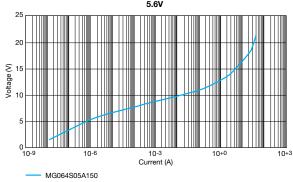


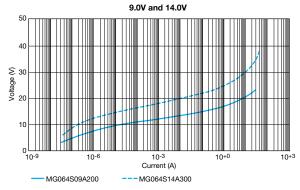


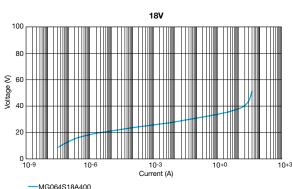
TYPICAL PERFORMANCE CURVES - VOLTAGE/CURRENT CHARACTERISTICS

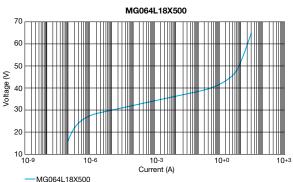
Multilayer construction and improved grain structure result in excellent transient clamping characteristics in excess of 30 amps (20 amps on MG064L18X500) peak current while maintaining very low leakage currents under DC operating

conditions. The VI curves below show the voltage/current characteristics for the 5.6V, 9V, 14V and 18V parts with currents ranging from fractions of a micro amp to tens of amps.



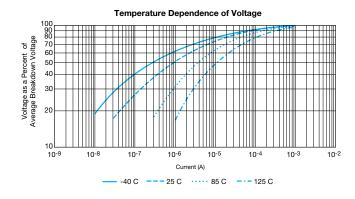


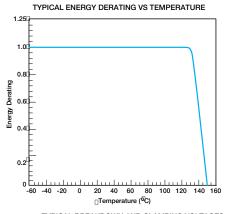


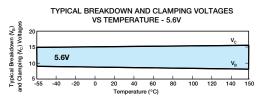


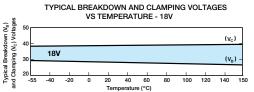
TYPICAL PERFORMANCE CURVES – TEMPERATURE CHARACTERISTICS

MultiGuard suppressors are designed to operate over the full temperature range from -55°C to +125°C.











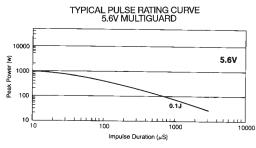
MultiGuard (2 & 4 Elements)

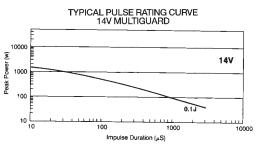
AVX Multilayer Ceramic

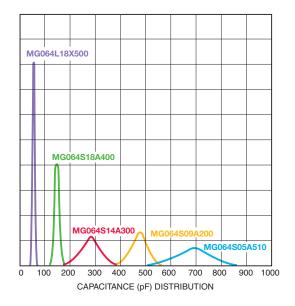
Transient Voltage Suppression Arrays ESD Protection for CMOS and Bi Polar Systems



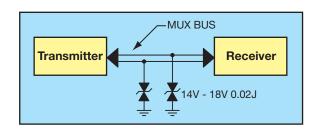
TRANSIENT VOLTAGE SUPPRESSORS – TYPICAL PERFORMANCE CURVES

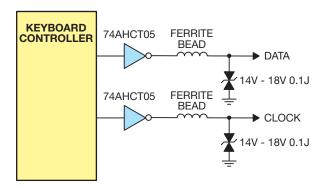






APPLICATION









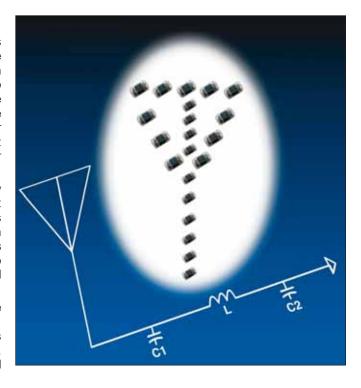
AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for Antennas and Low Capacitor Loading Applications

GENERAL DESCRIPTION

RF antenna/RF amplifier protection against ESD events is a growing concern of RF circuit designers today, given the combination of increased signal "gain" demands, coupled with the required downsizing of the transistor package. The ability to achieve both objectives is tied to a reduced thickness of the ${\rm SiO}_2$ gate insulator layer within the semiconductor. The corresponding result of such a change increases the Power Amplifier's (PA's) vulnerability to ESD strikes — a common event with handheld electronic products with RF transmitting and/or receiving features.

AVX's 0402/0603 AntennaGuard products are an ultra-low capacitance extension of the proven TransGuard® TVS (transient voltage suppression) line of multilayer varistors. RF designers now have a <u>single chip</u> option over conventional protection methods (passive filters with diode clamps), which not only gives superior performance over traditional schemes, but also provides the added benefits of reduced PCB real estate and lower installation costs.

AVX's AntennaGuard products are available in capacitance ratings of \leq 3pF (0402 & 0603 chips) and \leq 12pF (0603 chip). These low capacitance values have low insertion loss, as well as give other TransGuard® advantages such as small size, sub-nanosecond response time, low leakage currents and unsurpassed reliability (FIT Rate of 0.2) compared to diodes.



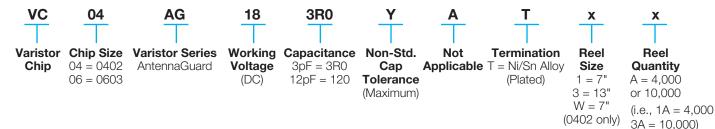
FEATURES

- Smallest TVS Component
- Standard EIA Chip Sizes
- Chip Placement Compatible
- Fastest Response Time to ESD Strikes
- Two Cap Values (≤3 and ≤12pF)

APPLICATION

- ESD Protection for RF Amplifiers
- Laser Drivers

HOW TO ORDER







WA = 10,000





AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for Antennas and Low Capacitor Loading Applications

ANTENNAGUARD CATALOG PART NUMBERS/ELECTRICAL VALUES

AVX Part Number	V _W (DC)	V _W (AC)	I _L	Сар	Case Size	Elements
VC04AG183R0YAT	≤18	≤14	0.1	3	0402	1
VC06AG183R0YAT	≤18	≤14	0.1	3	0603	1
VC06AG18120YAT	≤18	≤14	0.1	12	0603	1

L Termination Finish Code

Packaging Code

V_w(DC) DC Working Voltage (V)

V_w(AC) AC Working Voltage (V)

I₁ Maximum Leakage Current at the Working Voltage (μA)

Cap Maximum Capacitance (pF) @ 1 MHz and 0.5 Vrms; VC06AG18120YAT capacitance tolerance: +4, -2pF

PHYSICAL DIMENSIONS

mm (inches)

	0402	0603
Length	1.0 (0.039) ±0.1 (0.004)	1.6 (0.063) ±0.15 (0.006)
Width	0.5 (0.020) ±0.1 (0.004)	0.8 (0.031) ±0.15 (0.006)
Thickness	0.6 Max. (0.024)	0.9 Max. (0.035)
Termination Band Width	0.25 (0.010) ±0.15 (0.006)	0.35 (0.014) ±0.15 (0.006)





AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for Antennas and Low Capacitor Loading Applications

Antenna Varistors

AVX offers a series of 0402 and 0603 chip varistors, designated the AntennaGuard series, for RF antenna/RF amplifier protection. These devices offer ultra-low capacitance (<3pF in 0402 chips, and ≤3pF & ≤12pF in 0603 packages), as well as low insertion loss. Antenna varistors can replace output capacitors and provide ESD suppression in cell phones, pagers and wireless LANs.

It is very common to employ some form of a FET in many types of efficient/miniature RF amplifiers. Typically, these RF transistors have nearly ideal input gate impedance and outstanding noise figures. However, FETs are very susceptible to ESD damage due to the very thin layer of SiO_2 uses as the gate insulator. The ultra-thin SiO_2 layer is required to improve the gain of the transistor. In other words, the upside of the performance enhancement becomes the downside of the transistors survival when subjected to an ESD event.

ESD damage to the RF Field Effect Transistors (FETs) is a

growing concern among RF designers due to the following trends: (1) RF amplifiers continue to shrink in size, and (2) FET gains figures continue to increase. Both trends relate to decreasing gate oxide thickness, which in turn, is directly proportional to increased ESD sensitivity. As miniaturization trends accelerate, the traditional methods to protect against ESD damage (i.e., PC board layout, passive filters, and diode clamps) are becoming less and less effective.

AVX's AntennaGuard varistor can be used to protect the FET and offer superior performance to the previously mentioned protection methods given above. The standard EIA 0603 chip size, and particularly the 0402 chip, offer designers an ESD protection solution consistent with today's downsizing trend in portable electronic products. Savings in component volume up to 86%, and PC board footprint savings up to 83% are realistic expectations. These percentages are based upon the following table and Figures 1A and 1B.

mm (inches)

Suppression Device	Pad Dimensions								
Suppression Device	D1	D2	D3	D4	D 5				
AVX 0402 TransGuard®	1.70 (0.067)	0.61 (0.024)	0.51 (0.020)	0.61 (0.024)	0.51 (0.020)				
AVX 0603 TransGuard®	2.54 (0.100)	0.89 (0.035)	0.76 (0.030)	0.89 (0.035)	0.76 (0.030)				
Competitor's SOT23 Diode	See Below								

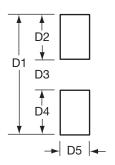


Figure 1A. 0402/0603 IR Solder Pad Layout

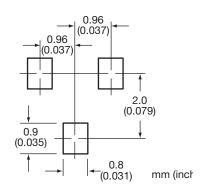


Figure 1B. SOT23- Solder Pad Layout



AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for Antennas and Low Capacitor Loading Applications

Antenna varistors offer excellent ESD repetitive strike capability compared to a SOT23 diode when subjected to IEC 61000-4-2 8Kv contact discharge. A performance summary is shown in Figure 2.

ESD TEST OF ANTENNAGUARD RATINGS

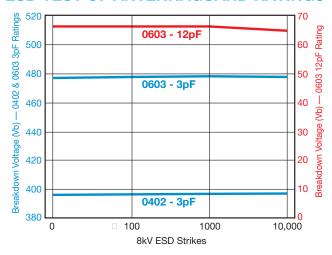


Figure 2. Repetitive 8kV ESD Strike

Antenna varistors also turn on and divert ESD overvoltages at a much faster rate than SOT23 devices (typically 300pS vs 1500pS - 5000pS). See Figure 3.

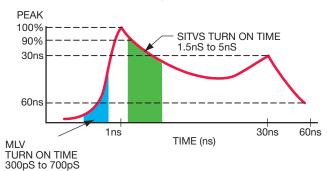


Figure 3. Turn On Time

The equivalent circuit model for a typical antenna varistor is shown in Figure 4.

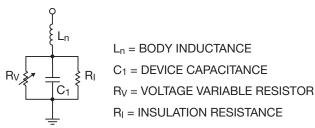


Figure 4. Antenna Varistor

The varistor shown exhibits a capacitance of ≤3pF which can be used to replace the parallel capacitance typically found prior to the antenna output of an RF amplifier. In the off state, the varistor acts as a capacitor and helps to filter RF output. The varistor is not affected by RF output power or voltage and has little insertion loss. See Figure 3.

ANTENNA VARISTOR S21

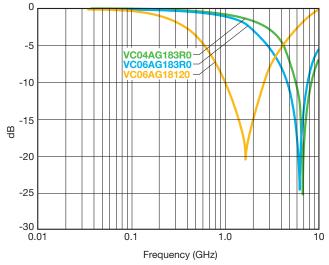


Figure 5. Antenna vs Frequency

Typical implementations of the antenna varistors are shown for use in cell phone, pager and wireless LAN applications in Figures 6A, 6B and 6C.

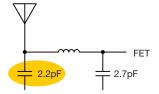


Figure 6A. Cell Phone

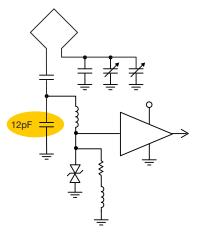


Figure 6B. Pager

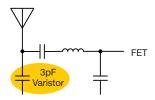


Figure 6C.

AntennaGuard/SPV

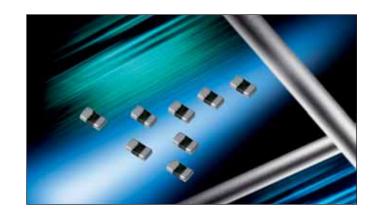


AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for any Circuit Sensitive to Capacitance

GENERAL DESCRIPTION

AVX offers ultra-low capacitance ESD protection in the Sub 1pF range for use in circuits that are sensitive to capacitance. The Sub pF Varistor (SPV) is available in 0.8pF and 0.4pF capacitance values in a compact 0402 low profile package. SPV devices provide excellent response time to ESD strikes to protect sensitive circuits from over voltage conditions.

The development of new information processing technologies call for ever increasing digital system speeds. Higher speeds necessitate the use of ultra-low capacitance values in order to minimize signal distortion.



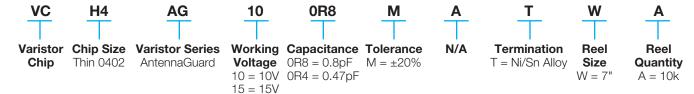
FEATURES

- High Reliability
- Capacitance <1pF
- Bi-Directional protection
- Fastest response time to ESD strikes
- Multi-strike capability
- · Low insertion loss
- Low profile 0402 case size

APPLICATIONS

- Antennas
- Optics
- HDMI
- RF circuits
- FlexRay
- Portable devices
- Analog sensors
- Any circuit sensitive to capacitance

HOW TO ORDER



ANTENNAGUARD CATALOG PART NUMBERS/ELECTRICAL VALUES

AVX Part Number	V _W (DC)	V_{B}	IL	Сар	Cap Tolerance	3db Freq (MHz)	Case Size
VCH4AG100R8MA	≤10	125	<10 nA	0.8	±20%	5800	LP 0402
VCH4AG150R8MA	≤15	125	<10 nA	0.96 pF Max	Max	5800	LP 0402
VCH4AG150R4MA	≤15	135	<100 nA	0.47 pF Max	±20%	6700	LP 0402

V_w(DC) DC Working Voltage (V)

V_B Typical Breakdown Voltage (V @ 1mA_{DC})

Typical leakage current at the working voltage

Cap Typical capacitance (pF) @ frequency specified and $0.5V_{RMS}$ Freq Frequency at which capacitance is measured (M = 1MHz)





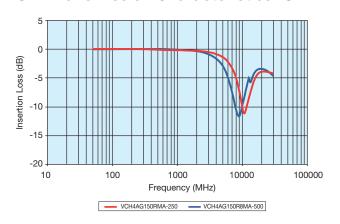


AntennaGuard/SPV

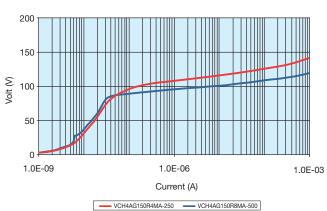


AVX Multilayer Ceramic Transient Voltage Suppressors ESD Protection for any Circuit Sensitive to Capacitance

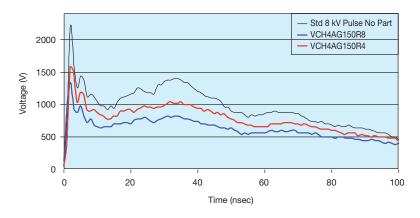
S21 Transmission Characteristics -SPV

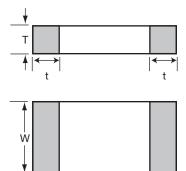


V/I Curve - SPV



ESD Wave Absorption Characteristics





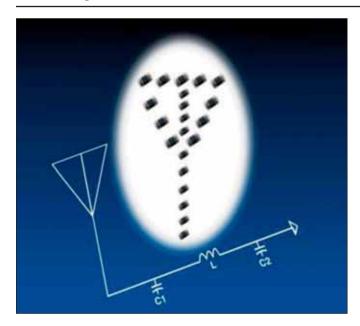
	mm (inches)
Size (EIA)	0402
Length (L)	1.00 ±0.10 (0.040 ± 0.004)
Width (W)	0.50 ±0.10 (0.020 ±0.004)
Max Thickness (T)	0.35 (0.014)
Terminal (t)	0.25±0.15 (0.010±0.006)



AntennaGuard Automotive Series



Multilayer Varistors for Automotive Applications



GENERAL DESCRIPTION

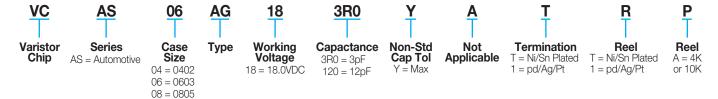
AVX 0402/0603 Automotive AntennaGuard products are an ultra low capacitance extension to the Automotive TransGuard® Series and are intended for use in RF and other capacitance sensitive circuits.

These low capacitance values have low insertion loss, low leakage current and unsurpassed reliability compared to diode options. These advantages combined with size advantages and bi-directional protection make the AntennaGuard the right choice for automotive applications including RF circuits, sensors, high-speed signal transmission lines, etc...

FEATURES

- AEC Q200 Qualified
- 25kV ESD rating
- Meet 27.5Vdc Jump Start requirements
- Multi-strike capability
- Sub 1nS response to ESD strike

HOW TO ORDER



ELECTRIAL CHARACTERISTICS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Maximum Leakage Current	Typical Cap	Case Size	Elements	Jump Start
VCAS04AG183R0Y	≤18.0	≤14.0	0.1	3	0402	1	27.5
VCAS06AG183R0Y	≤18.0	≤14.0	0.1	3	0603	1	27.5
VCAS06AG18120Y	≤18.0	≤14.0	0.1	12	0603	1	27.5

 $V_w(DC)$ DC Working Voltage (V) $V_w(AC)$ AC Working Voltage (V)

 I_L Maximum Leakage Current at the Working Voltage (μ A) Cap Typical Capacitance (pF) @ frequency specified and 0.5 $V_{\scriptscriptstyle RMS}$

Jump Start Maximum Jump start voltage at 5 minutes

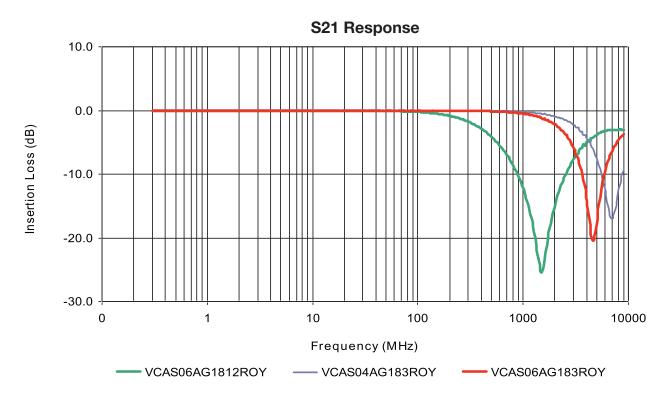


AntennaGuard Automotive Series

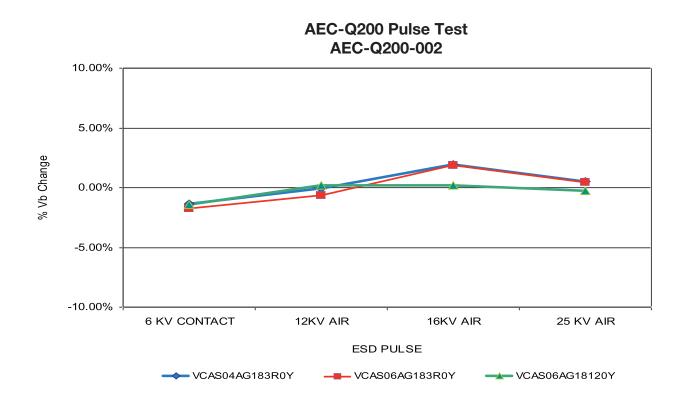


Multilayer Varistors for Automotive Applications

S21 TRANSMISSION CHARACTERISTICS



ESD CHARACTERISTICS



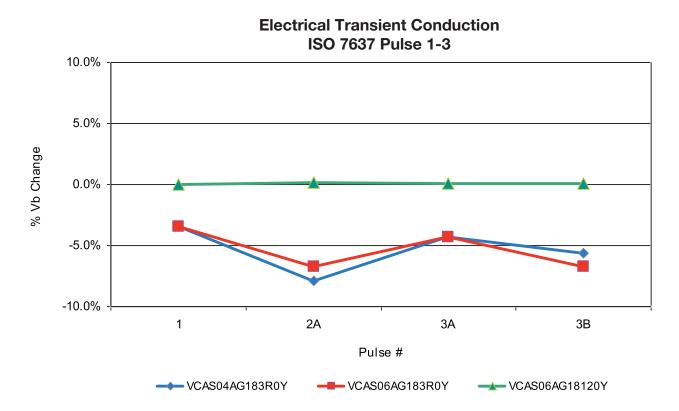


AntennaGuard Automotive Series



Multilayer Varistors for Automotive Applications

ELECTRICAL TRANSIENT CONDUCTION





Multilayer Varistors for Universal Serial BUS Protection

GENERAL DESCRIPTION

USB Series varistors are designed to protect the high speed data lines against ESD transients. They have very low capacitance and fast turn on times that make this series ideal for data and transmission lines with high data rates. The unique design enables these devices to meet the rigorous testing criteria of the **IEC 61000-4-2** standards. New and improved manufacturing process has created these USB series to be one of the best plated varistors in the market today.

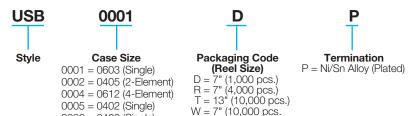
FEATURES

- Zinc Oxide (ZnO) based ceramic semiconductor devices with non-linear voltage-current characteristics
- Bi-directional device, similar to back-to-back Zener diodes plus an EMC capacitor in parallel
- Entire structure made up of conductive ZnO grains surrounded by electrically insulating barriers, creating varistor-like behavior
- Electrical advantages over Zener diodes are repetitive strike capability, high in rush current capability, fast turn-on-time and EMI attenuation
- Protects against ESD to meet IEC 61000-4-2 15kV (air) and 8kV (contact)
- · Low capacitance for high speed data lines
- Available in discrete and array packages (2 and 4 element)
- Low Clamping Voltage
- Low Operating Voltage
- Response time is < 1ns

MECHANICAL CHARACTERISTICS

- Available in EIA 0603 (Single), 0405 (Dual) and 0612 (Quad) cases
- Plated Tin over Nickel Barrier
- Packaged in Tape & Reel

PART NUMBERING

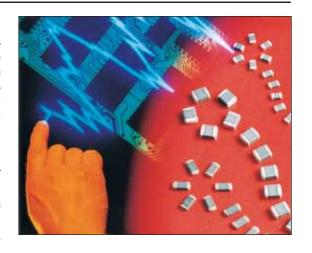


TYPICAL APPLICATIONS

0006 = 0402 (Single)

- USB BUS Lines/Firewire Data BUS Lines
- I/O BUS Lines
- 10/100/1000 Ethernet Transmission Lines
- Video Card Data Lines
- Handheld Devices
- Laptop Computers
- LCD Monitors

0402 only)

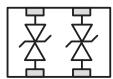


PINOUT CONFIGURATION

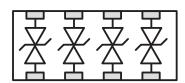
USB0001/0005/0006 0603 and 0402 (Single)



USB0002 0405 (Dual)



USB0004 0612 (Quad)











Multilayer Varistors for Universal Serial BUS Protection

RATINGS

Air Discharge ESD	15kV
Contact Discharge ESD	8kV
Operating Temperature	−55°C to +125°C
Soldering Temperature	230°C

PERFORMANCE CHARACTERISTICS

AVX Part No.	V _w (DC)	V _w (AC)	V _B	I <u>L</u>	E _T	I_P	Cap.	Case Size	Elements
USB0001	≤18	≤14	120	2	0.015	4	10	0603	1
USB0002	≤18	≤14	70	2	0.015	4	10	0405	2
USB0004	≤18	≤14	100	2	0.015	4	10	0612	4
USB0005	≤18	≤14	300	2	0.015	4	3	0402	1
USB0006	≤18	≤14	65	2	0.015	4	6	0402	1

Termination Finish Code
— Packaging Code

 $V_W(DC)$ DC Working Voltage (V) $V_W(AC)$ AC Working Voltage (V)

 V_B Typical Breakdown Voltage (V @ 1mA_{DC})

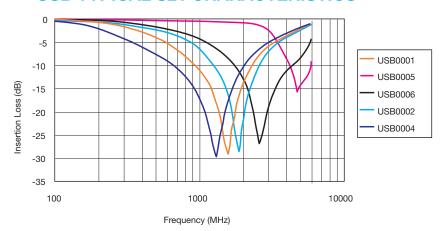
I_L Maximum Leakage Current at the Working Voltage (μA)

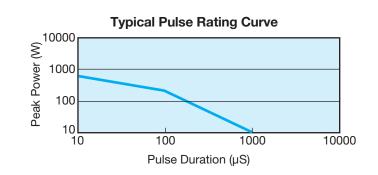
 $E_{\scriptscriptstyle T}$ Transient Energy Rating (J, 10x1000 μ S)

I_P Peak Current Rating (A, 8x20μS)

Cap Typical Capacitance (pF) @ 1 MHz and 0.5Vrms

USB TYPICAL S21 CHARACTERISTICS





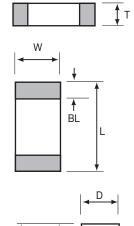




Multilayer Varistors for Universal Serial BUS Protection

PHYSICAL DIMENSIONS AND PAD LAYOUT

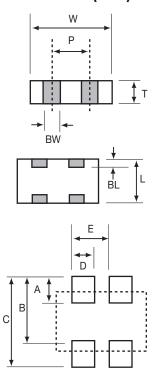
USB0001/5/6 (Single)



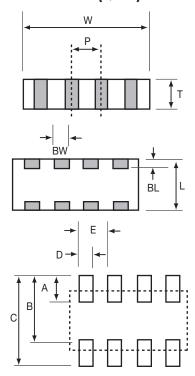
С

В

USB0002 (Dual)



USB0004 (Quad)



mm (inches)

L	W	Т	BW	BL	Р
USB0001					
1.60±.15 (0.063±0.006)	0.80±0.15 (0.032±0.006)	0.90 Max (0.035 Max.)	N/A	0.35±0.15 (0.014±0.006)	N/A
USB0002					
1.00±0.15 (0.039±0.006)	1.37±0.15 (0.054±0.006)	0.66 Max (0.026 Max.)	0.36±0.10 (0.014±0.004)	0.20±0.10 (0.008±0.004)	0.64 REF (0.025 REF)
USB0004					
1.60±0.20 (0.063±0.008)	3.20±0.20 (0.126±0.008)	1.22 Max (0.048 Max.)	0.41±0.10 (0.016±0.004)	0.18+0.25/-0.08 (0.007+.01/003)	0.76 REF (0.030 REF)
USB0005 /	USB0006				
1.0±0.10 (0.040±0.004)	0.50±0.10 (0.020±0.004)	0.60 Max (0.024 Max.)	N/A	0.25±0.15 (0.010±0.006)	N/A

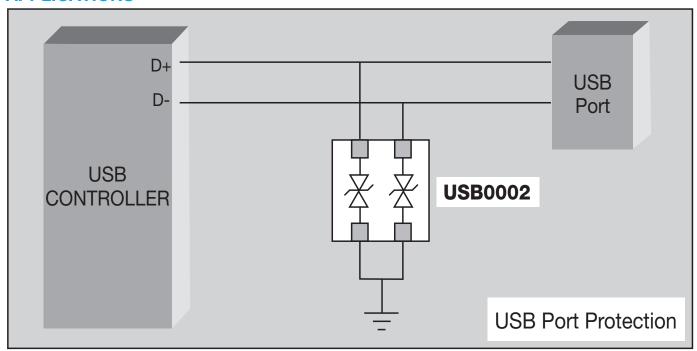
mm (inches)

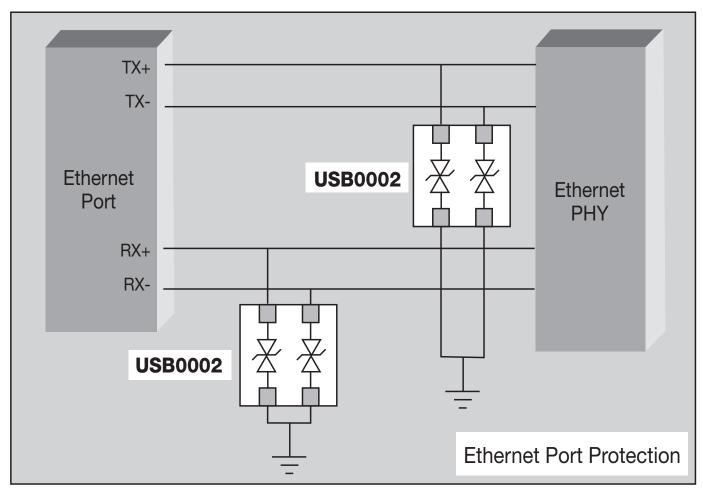
Α	В	С	D	E
USB0001				
0.89 (0.035)	0.76 (0.030)	2.54 (0.100)	0.76 (0.030)	N/A
USB0002				
0.46 (0.018)	0.74 (0.029)	1.20 (0.047)	0.30 (0.012)	0.64 (0.025)
USB0004				
0.89 (0.035)	1.65 (0.065)			0.76 (0.030)
USB0005	/ USB0006	3		
0.61 (0.024)	0.51 (0.020)	1.70 (0.067)	0.51 (0.020)	N/A



Multilayer Varistors for Universal Serial BUS Protection

APPLICATIONS





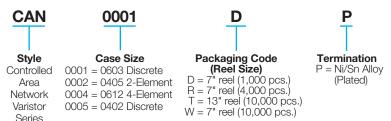
CAN BUS Varistor



GENERAL DESCRIPTION

The CAN BUS varistor is a zinc oxide (ZnO) based ceramic semiconductor device with non-linear voltage-current characteristics (bi-directional) similar to back-to-back Zener diodes and an EMC capacitor in parallel (see equivalent circuit model). They have the added advantage of greater current and energy handling capabilities as well as EMI/RFI attenuation. Devices are fabricated by a ceramic sintering process that yields a structure of conductive ZnO grains surrounded by electrically insulating barriers, creating varistor like behavior.

HOW TO ORDER







Discrete

登 2 2 3 0405

Array

Array

PERFORMANCE CHARACTERISTICS

AVX Part No.	V _w (DC)	V _w (AC)	V _B	I <u>L</u>	E _T	I _P	Сар.	Case Size	Elements
CAN0001	≤18	≤14	120	2	0.015	4	22	0603	1
CAN0002	≤18	≤14	70	2	0.015	4	22	0405	2
CAN0004	≤18	≤14	100	2	0.015	4	22	0612	4
CAN0005	≤18	≤14	33	2	0.015	4	37	0402	1

└ Termination Finish Code ─ Packaging Code

 $V_W(DC)$ DC Working Voltage (V) $V_W(AC)$ AC Working Voltage (V)

V_B Typical Breakdown Voltage (V @ 1mA_{DC})

 $\begin{array}{ll} V_{\text{\tiny C}} & & \text{Clamping Voltage (V @ I_{\text{\tiny VC}})} \\ I_{\text{\tiny VC}} & & \text{Test Current for V}_{\text{\tiny C}} \text{ (A, 8x20} \mu\text{S)} \end{array}$

I_L Maximum Leakage Current at the Working Voltage (μA)

 $E_{\scriptscriptstyle T}$ Transient Energy Rating (J, 10x1000 μ S) $I_{\scriptscriptstyle P}$ Peak Current Rating (A, 8x20 μ S)

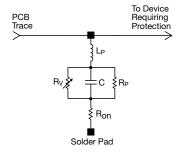
Cap Maximum Capacitance (pF) @ 1 MHz and 0.5Vrms

Temp Range -55°C to +125°C

10.0 0.0 Insertion Loss (dB) -10.0 -20.0 CANOODS -30.0 -40.0 -50.0 0 10 100 1000 10000 1 Frequency (MHz)

EQUIVALENT CIRCUIT MODEL

Discrete MLV Model

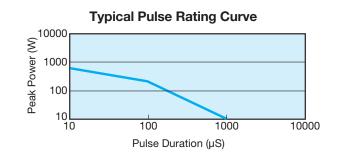


Where: R_V = Voltage Variable resistance (per VI curve)

 $R_p \geq 10^{12} \Omega$

C = defined by voltage rating and energy level

 R_{on} = turn on resistance L_{o} = parallel body inductance









CAN BUS Varistor



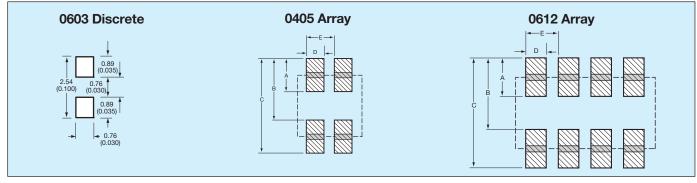
PHYSICAL DIMENSIONS

mm (inches)

	0402 Discrete	0603 Discrete	0405 Array	0612 Array
Length	1.00 ±0.10 (0.040 ±0.004)	1.60 ±0.15 (0.063 ±0.006)	1.00 ±0.15 (0.039 ±0.006)	1.60 ±0.20 (0.063 ±0.008)
Width	0.50 ±0.10 (0.020 ±0.004)	0.80 ±0.15 (0.032 ±0.006)	1.37 ±0.15 (0.054 ±0.006)	3.20 ±0.20 (0.126 ±0.008)
Thickness	0.60 Max. (0.024 Max.)	0.90 Max. (0.035 Max.)	0.66 Max. (0.026 Max.)	1.22 Max. (0.048 Max.)
Term Band Width	0.25 ±0.15 (0.010 ±0.006)	0.35 ±0.15 (0.014 ±0.006)	0.36 ±0.10 (0.014 ±0.004)	0.41 ±0.10 (0.016 ±0.010)

SOLDER PAD DIMENSIONS

mm (inches)



Α	A B		D	Е	
0.46 (0.018)	0.74 (0.029)	1.20 (0.047)	0.38 (0.015)	0.64 (0.025)	

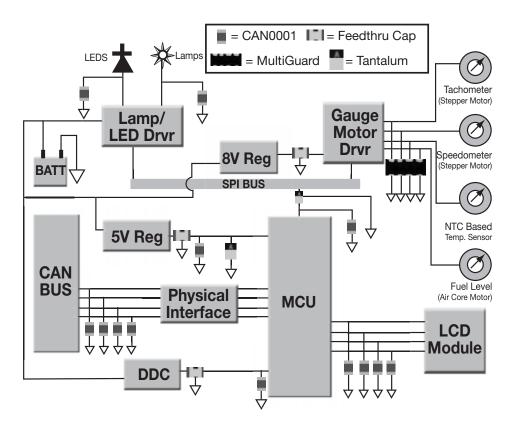
0612 Array

	-			
Α	В	С	D	Е
0.89	1.65	2.54	0.46	0.76
(0.035)	(0.065)	(0.100)	(0.018)	(0.030)

APPLICATION

AVX CAN BUS varistors offer significant advantages in general areas of a typical CAN network as shown on the right. Some of the advantages over diodes include:

- space savings
- higher ESD capability @ 25kV contact
- higher in rush current (4A) 8 x 20µS
- FIT rate ≤0.1 failures (per billion hours)





UltraGuard Series



ESD Protection for Low Leakage Requirements

GENERAL DESCRIPTION

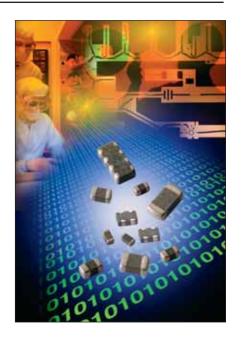
Faster semiconductor clock speeds and an increasing reliance on batteries as power sources have resulted in the need for varistors that exhibit very low leakage current. The UltraGuard (UG) Series of AVX Transient Voltage Suppressors address this problem.

The UG Series is the ideal transient protection solution for high clock speed integrated circuit application, battery-operated device, backlit display, medical/instrument application, low voltage power conversion circuits and power supervisory chip sets. In addition, UltraGuard's low leakage characteristics are also suitable for optic circuits like LDD, SerDes, and laser diodes.

The UG Series is offered as discrete chips (0402, 0603, and 0805), 2-element packages (0405 and 0508), and 4-element packages (0612).

LEAD-FREE COMPATIBLE COMPONENT



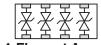




Discrete Chips 0402, 0603, and 0805



2-Element Arrays (0405 and 0508)



4-Element Arrays (0612)

HOW TO ORDER



Series
UG = Low

Series

= Low
Leakage
Series

04

Case Size 04 = 0402 06 = 0603 08 = 0805

0180

Maximum Working Voltage 0030 = 3.0Vpc 0050 = 5.0Vpc

0050 = 5.0Vpc 0075 = 7.5Vpc 0100 = 10.0Vpc 0150 = 15.0Vpc 0180 = 18.0Vpc +

Capacitance L = Low H = High 1 No. of

No. of Elements Packaging (pieces per reel)

W

D = 1,000 (7" reel) R = 4,000 (7" reel) T = 10,000 (13" reel) W = 10,000 (7" reel,

0402 only)

<u>P</u>

Termination Finish P = Ni/Sn Alloy (Plated)

HOW TO ORDER



MG=Array SUG

UG Series

UG = Low Leakage Series 06 |------

Case Size 04 = 0405 05 = 0508 06 = 0612

0150 Maximum

Voltage 0030 = 3.0Vpc 0050 = 5.0Vpc 0075 = 7.5Vpc 0100 = 10.0Vpc 0150 = 15.0Vpc

Working

L

Capacitance L = Low H = High 4 No. of

Elements 2 = 2 Elements 4 = 4 Elements

D

Packaging (pieces per reel)

D = 1,000 (7" reel) R = 4,000 (7" reel) T = 10,000 (13" reel)



Termination Finish P = Ni/Sn Alloy (Plated)



UltraGuard Series



ESD Protection for Low Leakage Requirements

AVX Part Number	V _{CIR} (DC)	V _{CIR} (AC)	Cap Required	Сар	Freq	ΙL	Case Size	Elements
MGUG040030L2	≤3.0	≤2.3	Low	300	М	2	0405	2
MGUG050030L2	≤3.0	≤2.3	Low	425	М	2	0508	2
MGUG060030L4	≤3.0	≤2.3	Low	425	М	2	0612	4
VCUG040030L1	≤3.0	≤2.3	Low	175	М	2	0402	1
VCUG060030L1	≤3.0	≤2.3	Low	750	К	2	0603	1
VCUG080030H1	≤3.0	≤2.3	High	3000	K	2	0805	1
VCUG080030L1	≤3.0	≤2.3	Low	1100	К	2	0805	1
VCUG120030H1	≤3.0	≤2.3	High	3000	K	2	1206	1
VCUG120030L1	≤3.0	≤2.3	Low	1200	K	2	1206	1
MGUG040050L2	≤5.0	≤3.5	Low	40	М	2	0405	2
MGUG050050L2	≤5.0	≤3.5	Low	425	М	2	0508	2
MGUG060050L4	≤5.0	≤3.5	Low	425	М	2	0612	4
VCUG040050L1	≤5.0	≤3.5	Low	175	М	2	0402	1
VCUG060050L1	≤5.0	≤3.5	Low	550	K	2	0603	1
VCUG080050L1	≤5.0	≤3.5	Low	750	K	2	0805	1
VCUG120050H1	≤5.0	≤3.5	High	1050	K	2	1206	1
VCUG120050L1	≤5.0	≤3.5	Low	600	K	2	1206	1
MGUG040075L2	≤7.5	≤5.3	Low	40	М	2	0405	2
MGUG050075L2	≤7.5	≤5.3	Low	425	М	2	0508	2
MGUG060075L4	≤7.5	≤5.3	Low	425	М	2	0612	4
VCUG040075L1	≤7.5	≤5.3	Low	100	М	2	0402	1
VCUG060075L1	≤7.5	≤5.3	Low	425	K	2	0603	1
VCUG080075H1	≤7.5	≤5.3	High	900	K	2	0805	1
VCUG080075L1	≤7.5	≤5.3	Low	325	K	2	0805	1
VCUG120075H1	≤7.5	≤5.3	High	1050	K	2	1206	1
VCUG120075L1	≤7.5	≤5.3	Low	600	K	2	1206	1
MGUG040100L2	≤10.0	≤7.1	Low	40	М	2	0405	2
MGUG050100L2	≤10.0	≤7.1	Low	225	М	2	0508	2
MGUG060100L4	≤10.0	≤7.1	Low	225	М	2	0612	4
VCUG040100L1	≤10.0	≤7.1	Low	65	М	2	0402	1
VCUG060100L1	≤10.0	≤7.1	Low	250	K	2	0603	1
VCUG080100H1	≤10.0	≤7.1	High	550	K	2	0805	1
VCUG080100L1	≤10.0	≤7.1	Low	225	K	2	0805	1
VCUG120100H1	≤10.0	≤7.1	High	900	K	2	1206	1
VCUG120100L1	≤10.0	≤7.1	Low	350	K	2	1206	1
MGUG040150L2	≤15.0	≤11	Low	50	М	2	0405	2
MGUG050150L2	≤15.0	≤11	Low	50	М	2	0508	2
MGUG060150L4	≤15.0	≤11	Low	75	М	2	0612	4
VCUG040150L1	≤15.0	≤11	Low	40	М	2	0402	1
VCUG060150L1	≤15.0	≤11	Low	155	K	2	0603	1
VCUG080150H1	≤15.0	≤11	High	250	K	2	0805	1
VCUG080150L1	≤15.0	≤11	Low	120	K	2	0805	1
VCUG120150H1	≤15.0	≤11	High	500	K	2	1206	1
VCUG040180L1	≤18.0	≤14	Low	30	М	1	0402	1

Termination Finish Code
Packaging Code

 $\begin{array}{lll} V_{\text{CIR}}(\text{DC}) & \text{DC Circuit Voltage (V)} \\ V_{\text{CIR}}(\text{AC}) & \text{AC Circuit Voltage (V)} \\ \text{Cap Req} & \text{Standard or Low} \end{array}$

 I_{L} Maximum Leakage Current at the Circuit Voltage (μ A)

Cap Typical Capacitance (pF) @ frequency specified and 0.5 Vrms

Frequency at which capacitance is measured (K = 1kHz, M = 1MHz)



UltraGuard Series



ESD Protection for Low Leakage Requirements

PHYSICAL DIMENSIONS

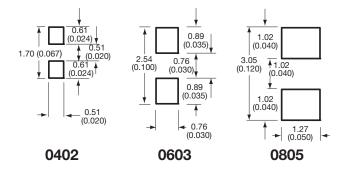
mm (inches)

	0402 Discrete	0603 Discrete	0805 Discrete
Length	1.00 ±0.10 (0.040 ±0.004)	1.60 ±0.15 (0.063 ±0.006)	2.01 ±0.20 (0.079 ±0.008)
Width	0.50 ±0.10 (0.020 ±0.004)	0.80 ±0.15 (0.032 ±0.006)	1.25 ±0.20 (0.049 ±0.008)
Thickness	0.60 Max. (0.024 Max.)	0.90 Max. (0.035 Max.)	1.02 Max. (0.040 Max.)
Term Band Width	0.25 ±0.15 (0.010 ±0.006)	0.35 ±0.15 (0.014 ±0.006)	0.71 Max. (0.028 Max.)

	0405 Array	0508 Array	0612 Array
Length	1.00 ±0.15 (0.039 ±0.006)	1.25 ±0.20 (0.049 ±0.008)	1.60 ±0.20 (0.063 ±0.008)
Width	1.37 ±0.15 (0.054 ±0.006)	2.01 ±0.20 (0.079 ±0.008)	3.20 ±0.20 (0.126 ±0.008)
Thickness 0.66 Max. (0.026 Max.)		1.02 Max. (0.040 Max.)	1.22 Max. (0.048 Max.)
Term Band Width	0.36 ±0.10 (0.014 ±0.004)	0.41 ±0.10 (0.016 ±0.004)	0.41 ±0.10 (0.016 ±0.004)

SOLDER PAD DIMENSIONS

mm (inches)

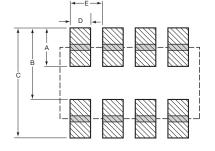


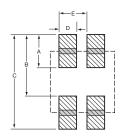
0612 4-Element Array

Α	В	С	D	Е
0.89	1.65	2.54	0.46	0.76
(0.035)	(0.065)	(0.100)	(0.018)	(0.030)

2-Element Arrays

	Α	В	С	D	Е
0405	0.46	0.74	1.20	0.38	0.64
	(0.018)	(0.029)	(0.047)	(0.015)	(0.025)
0508	0.89	1.27	2.16	0.46	0.76
	(0.035)	(0.050)	(0.085)	(0.018)	(0.030)





TransFeed

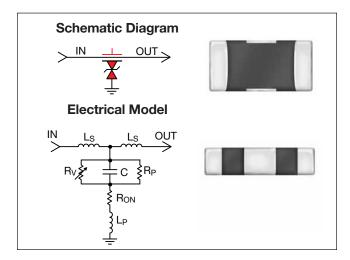
AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



GENERAL DESCRIPTION

AVX has combined the best electrical characteristics of its TransGuard® Transient Voltage Suppressors (TVS) and its Feedthru Capacitors into a single chip for state-of-the-art overvoltage circuit protection and EMI reduction over a broad range of frequencies. This unique combination of multilayer ceramic construction in a feedthru configuration gives the circuit designer a single 0805 chip that responds to transient events faster than any TVS device on the market today, and provides significant EMI attenuation when in the off-state.

The reduction in parallel inductance, typical of the feedthru chip construction when compared to the construction of standard TVS or ceramic capacitor chips, gives the TransFeed product two very important electrical advantages: (1) faster "turn-on" time. Calculated response times of <200 pSec are not unusual with this device, and measured response times range from 200 - 250 pSec. The TransFeed "turn-on" characteristic is less than half that of an equivalent TransGuard® part — and TransGuards® clamp transient voltages faster than any other bipolar TVS solution such as diodes; (2) the second electrical advantage of lower parallel inductance, coupled with optimal series inductance, is the enhanced attenuation characteristics of the TransFeed product. Not only is there significantly greater attenuation at a higher self-resonance frequency, but the roll-off characteristic becomes much flatter, resulting in EMI filtering over a much broader frequency spectrum. Typical applications include filtering/protection on Microcontroller I/O Lines, Interface I/O Lines, Power Line Conditioning and Power Regulation.

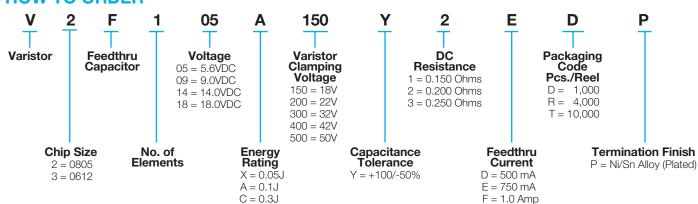


TYPICAL APPLICATIONS

- Fingerprint ID Circuit
- Magnetic Field Circuit
- LCD Dashboard Driver

Where designers are concerned with both transient voltage protection and EMI attenuation, either due to the electrical performance of their circuits or due to required compliance to specific EMC regulations, the TransFeed product is an ideal choice.

HOW TO ORDER









TransFeed

AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



TRANSFEED ELECTRICAL SPECIFICATIONS

AVX Part Number	Working Voltage (DC)	Working Voltage (AC)	Breakdown Voltage	Clamping Voltage	Maximum Leakage Current	Transient Energy Rating	Peak Current Rating	Typical Cap	DC Resistance	Maximum Feedthru Current
V2F105A150Y2E	5.6	4.0	8.5±20%	18	35	0.10	30	800	0.200	0.75
V2F105C150Y1F	5.6	4.0	8.5±20%	18	35	0.30	120	2500	0.150	1.00
V2F109A200Y2E	9.0	6.4	12.7±15%	22	25	0.10	30	575	0.200	0.75
V2F109C200Y1F	9.0	6.4	12.7±15%	22	25	0.30	120	1800	0.150	1.00
V2F114A300Y2E	14.0	10.0	18.5±12%	32	15	0.10	30	300	0.200	0.75
V2F114C300Y1F	14.0	10.0	18.5±12%	32	15	0.30	120	900	0.150	1.00
V2F118A400Y2E	18.0	13.0	25.5±10%	42	10	0.10	30	200	0.200	0.75
V2F118C400Y1F	18.0	13.0	25.5±10%	42	10	0.30	120	500	0.150	1.00
V2F118X500Y3D	18.0	13.0	25.5±10%	50	10	0.05	20	75	0.250	0.50
V3F418A400Y3G	18.0	13.0	25.5±10%	42	10	0.10	20	150	0.200	0.30
V3F418X500Y3G	18.0	13.0	25.5±10%	50	10	0.05	15	65	0.250	0.20

L Termination Finish Code -Packaging Code

 $V_{w}(DC)$ DC Working Voltage (V) AC Working Voltage (V) $V_w(AC)$

Typical Breakdown Voltage (V @ 1mAnc) $V_{\rm B}$ V_B Tolerance is ± from Typical Value $V_B Tol$ V_{c} Clamping Voltage (V @ 1A 8x20µS)

Maximum Leakage Current at the Working Voltage (µA) I_{L}

E, Transient Energy Rating (J, 10x1000µS) I_P

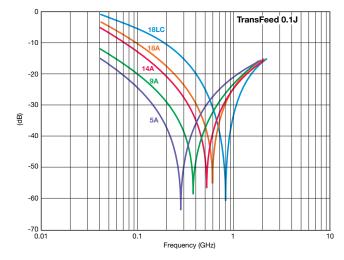
Peak Current Rating (A, 8x20µS)

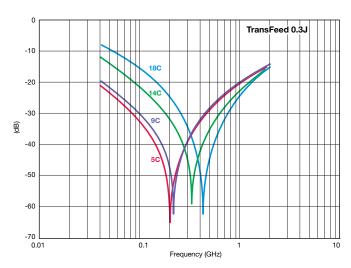
Cap Typical Capacitance (pF) @ 1MHz and 0.5 V

DCR DC Resistance (Ohms)

 I_{FT} Maximum Feedthru Current (A)

dB Attenuation vs Frequency







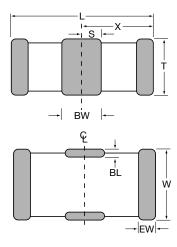
TransFeed





DIMENSIONS mm (inches)

	L	W	Т	BW	BL	EW	X	S
0805	2.01 ± 0.20	1.25 ± 0.20	1.143 Max.	0.46 ± 0.10	0.18 + 0.25 -0.08	0.25 ± 0.13	1.02 ± 0.10	0.23 ± 0.05
0005	(0.079 ± 0.008)	(0.049 ± 0.008)	(0.045 Max.)	(0.018 ± 0.004)	(0.007 + 0.010 - 0.003)	(0.010 ± 0.005)	(0.040 ± 0.004)	(0.009 ± 0.002)

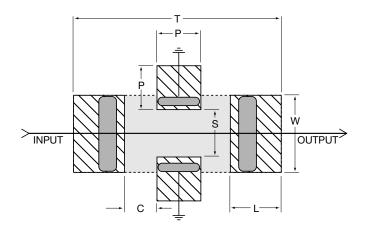


RECOMMENDED SOLDER PAD LAYOUT (Typical Dimensions)

mm (inches)

	Т	Р	S	W	L	С
0805	3.45 (0.136)	0.51 (0.020)	0.76 (0.030)	1.27 (0.050)	1.02 (0.040)	0.46 (0.018)

4 Pad Layout

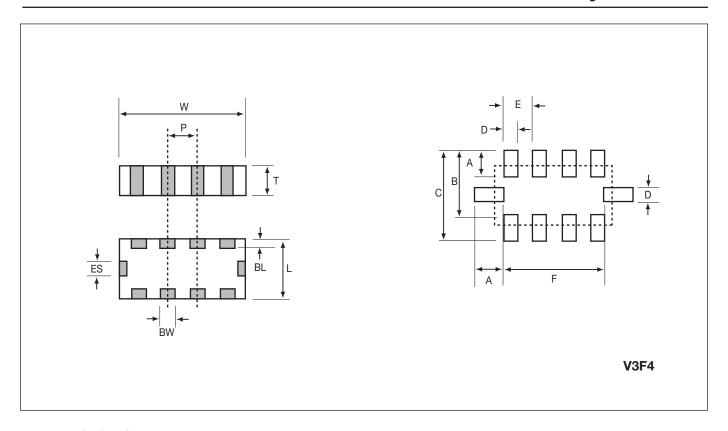




TransFeed Array - V3F4 Series



TVS Protection and EMI Attenuation in a 4-Element Array



DIMENSIONS mm (inches)

L	W	Т	BW	BL	ES	Р
1.60 ± 0.20	3.25 ± 0.15	1.22 Max.	0.41 ± 0.10	0.18 +0.25 -0.08	0.41 ± 0.10	0.76 REF
(0.063 ± 0.008)	(0.128 ± 0.006)	(0.048 Max.)	(0.016 ± 0.004)	(0.007 +0.010 -0.003)	(0.016 ± 0.004)	(0.030 REF)

mm (inches)

Α	В	С	D	E	F
0.60 (0.024)	1.60 (0.064)	2.20 (0.088)	0.35 (0.014)	0.76 (0.030)	2.60 (0.104)

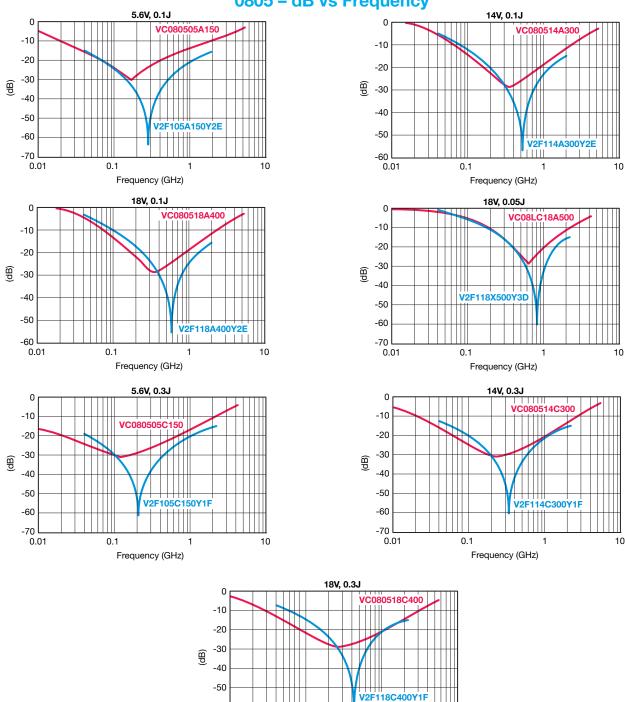
AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



PERFORMANCE CHARACTERISTICS

INSERTION LOSS COMPARISON (TransFeed vs TransGuard®)

0805 - dB vs Frequency





Frequency (GHz)

10

-60 -70 0.01

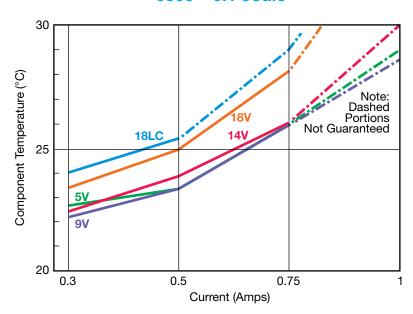
AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



PERFORMANCE CHARACTERISTICS

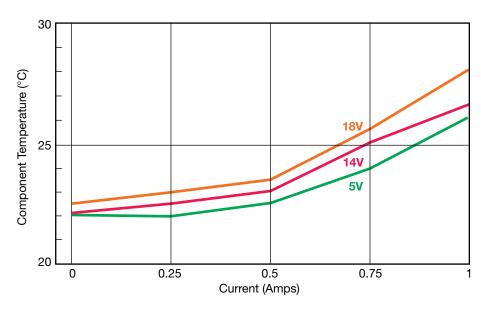
CURRENT vs TEMPERATURE

0805 - 0.1 Joule



CURRENT vs TEMPERATURE

0805 - 0.3 Joule





AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



PERFORMANCE CHARACTERISTICS

FEEDTHRU VARISTORS

AVX Multilayer Feedthru Varistors (MLVF) are an ideal choice for system designers with transient strike and broadband EMI/RFI concerns.

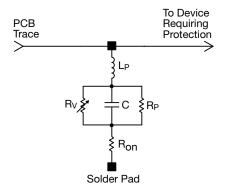
Feedthru Varistors utilize a ZnO varistor material and the electrode pattern of a feedthru capacitor. This combination allows the package advantage of the feedthru and material advantages of the ZnO dielectric to be optimized.

ZnO MLV Feedthrus exhibit electrical and physical advantages over standard ZnO MLVs. Among them are:

- 1. Faster Turn on Time
- 2. Broadband EMI attenuation
- 3. Small size (relative to discrete MLV and EMI filter schemes)

The electrical model for a ZnO MLV and a ZnO Feedthru MLV are shown below. The key difference in the model for the Feedthru is a transformation in parallel to series inductance. The added series inductance helps lower the injected transient peak current (by $2\pi fL$) resulting in an additional benefit of a lower clamping voltage. The lowered parallel inductance decreases the turn on time for the varistor to <250ps.

Discrete MLV Model



Where: R_V = Voltage Variable resistance

(per VI curve)

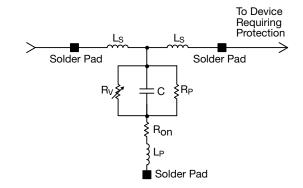
 $R_D \geq 10^{12} \Omega$

C = defined by voltage rating and energy level

R_{On} = turn on resistance

L_D = parallel body inductance

Discrete MLVF Model



Where: R_V = Voltage Variable resistance

(per VI curve)

 $R_D = Body IR$

C = defined by voltage rating and energy level

 $R_{\Omega n}$ = turn on resistance

 L_D = minimized parallel body inductance

L's = series body inductance



AVX Multilayer Ceramic Transient Voltage Suppressors TVS Protection and EMI Attenuation in a Single Chip



PERFORMANCE CHARACTERISTICS

APPLICATIONS

- EMI Suppression
- Broadband I/O Filtering
- Vcc Line Conditioning

FEATURES

- Small Size
- Low ESR
- Ultra-fast Response Time
- Broad S21 Characteristics

MARKET SEGMENTS

- Computers
- Automotive
- Power Supplies
- Multimedia Add-On Cards
- Bar Code Scanners
- Remote Terminals
- Medical Instrumentation
- Test Equipment
- Transceivers
- Cellular Phones / Pagers

TYPICAL CIRCUITS REQUIRING TRANSIENT VOLTAGE PROTECTION AND EMI FILTERING

The following applications and schematic diagrams show where TransFeed TVS/ EMI filtering devices might be used:

- System Board Level Interfaces: (Fig. 1)
 Digital to RF
 Analog to Digital
 Digital to Analog
- Voltage Regulation (Fig. 2)
- Power Conversion Circuits (Fig. 3)
- GaAs FET Protection (Fig. 4)

Fig. 1 - System Interface

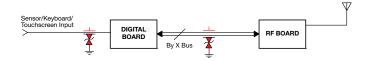
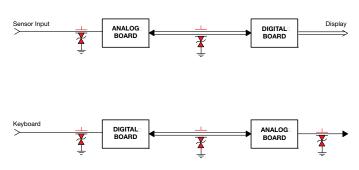
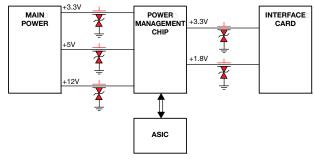


Fig. 2 - Voltage Regulators



Fig. 3 - Power Conversion Circuits/Power Switching Circuits

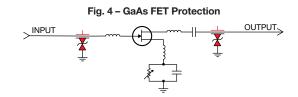




SPECIFICATION COMPARISON

MLVF 0805		PARAMETER	MLV 0805
5ph	Ls	typical	N/A
<600nh	Lp	typical	<1.5nh
<0.025Ω	Ron	typical	<0.1Ω
100pf to 2.5nf	С	typical	100pf to 5.5nf
see VI curves	R _v	typical	see VI curves
>0.25 x 10 ¹² Ω	Rp	typical	>1 x 10 ¹² Ω
<250ps		al turn on time al frequency response	<500ps

A comparison table showing typical element parameters and resulting performance features for MLV and MLVF is shown above.







/AV/XTransGuard®

TYPICAL CIRCUITS REQUIRING PROTECTION

The following applications and schematic diagrams show where TransGuards® might be used to suppress various transient voltages:

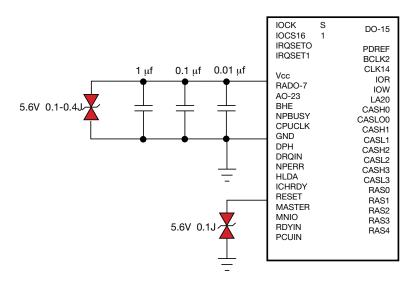
- ASIC Reset & Vcc Protection
- Micro Controllers, Relays, DC Motors
- I/O Port Protection
- Keyboard Protection
- Modem Protection
- Sensor Protection
- Preamplifier Protection
- Audio Circuit Protection
- LCD Protection
- Optics Protection



TransGuard® AVX Multilayer Transient Voltage Protection Typical Circuits Requiring Protection



ASIC RESET & Vcc PROTECTION

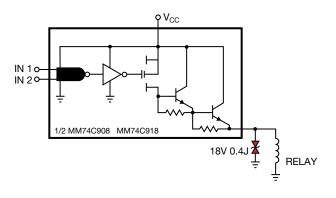


MICRO CONTROLLERS RELAYS, DC MOTORS

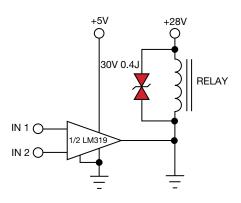
TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE ≥ RELAY OR MOTOR VOLTAGE ENERGY RATING TYPICALLY > 0.3J CAPACITANCE IS OF NO CONCERN

CMOS RELAY DRIVER



LM319 RELAY DRIVER







TransGuard®AVX Multilayer Transient Voltage Protection Typical Circuits Requiring Protection



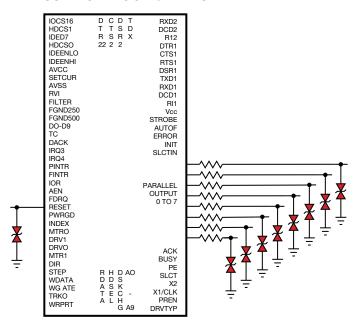
I/O PORT PROTECTION

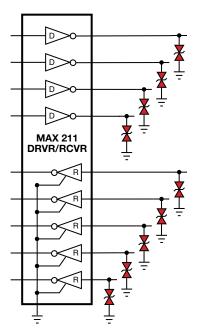
TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE TYPICALLY 14V - 18V ENERGY RATING TYPICALLY 0.05J - 0.1J CAPACITANCE SHOULD BE MINIMIZED

SUB NOTEBOOK & PDA'S

NOTEBOOK & WORK STATION

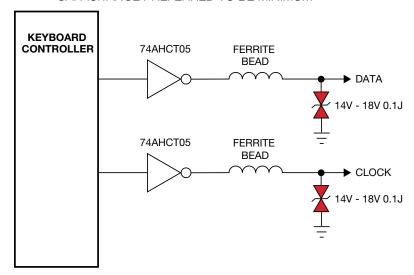




KEYBOARD PROTECTION

TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE >5.6V ENERGY RATING TYPICALLY <0.4J CAPACITANCE PREFERRED TO BE MINIMUM





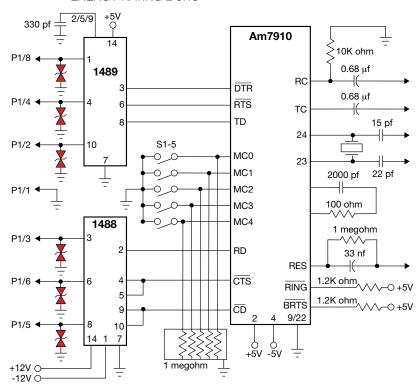




MODEM PROTECTION

TRANSGUARD® CHARACTERISTICS

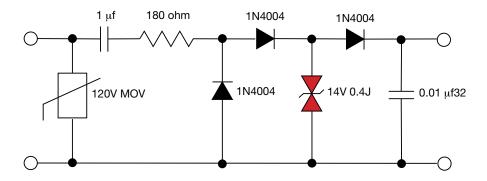
WORKING VOLTAGE <26V ENERGY RATING ≥ 0.1J



SENSOR PROTECTION

TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE TYPICALLY >14V ENERGY RATING > 0.4J CAPACITANCE IS NO CONCERN







TransGuard® AVX Multilayer Transient Voltage Protection Typical Circuits Requiring Protection

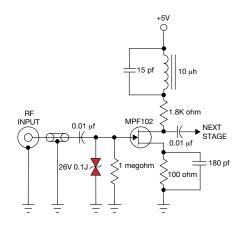


ANTENNA AND PREAMPLIFIER PROTECTION

TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE TYPICALLY 18V - 26V ENERGY RATING 0.05J - 0.9J CAPACITANCE OF CONCERN ON MANY DESIGNS

PREAMPLIFIER PROTECTION

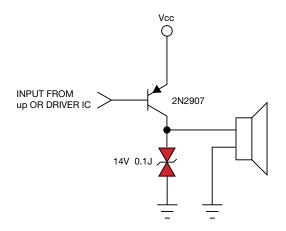


AUDIO CIRCUIT PROTECTION

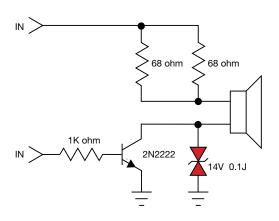
TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE TYPICALLY 14V - 18V ENERGY RATING 0.1J

PAGER AUDIO PROTECTION



NOTEBOOK, WORK STATION AUDIO PROTECTION







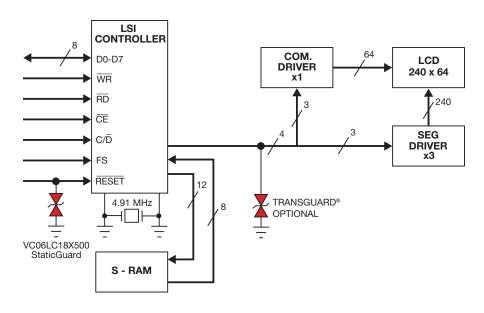
TransGuard® AVX Multilayer Transient Voltage Protection Typical Circuits Requiring Protection



LCD PROTECTION

TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE < 5.6V ENERGY RATING < 0.1J

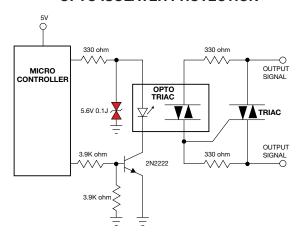


OPTICS PROTECTION

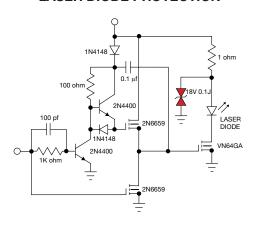
TRANSGUARD® CHARACTERISTICS

WORKING VOLTAGE ≤ 18V ENERGY RATING 0.1J CAPACITANCE SHOULD BE MINIMIZED

OPTO ISOLATER PROTECTION



LASER DIODE PROTECTION









/AV/XTransGuard®

APPLICATION NOTES

- AVX Multilayer Varistors Assembly Guidelines
- IEC 61000-4 Requirements
- Turn On Time Characteristics of AVX Multilayer Varistors
- The Impact of ESD on Insulated Portable Equipment
- AVX TransGuard® Motor and Relay Application Study
- AVX Multilayer Varistors in Automobile MUX Bus Applications



AVX Multilayer Varistors – Application Notes

TRANSGUARD® SURFACE MOUNT DEVICES

The move toward SMT assembly of Transient Voltage Suppressors (TVS) will continue accelerating due to improved long-term reliability, more efficient transient voltage attenuation and size/functionality/cost issues.

TransGuards® are uniquely suited for wide-scale usage in SMT applications. TransGuards® exhibit many advantages when used in SMT assemblies. Among them are:

- Available in standard EIA chip sizes 0402/0603/0805/ 1206/1210.
- Placed with standard equipment (8mm tape and reel).
- Processed with fewer guidelines than either ceramic chip or resistor chip devices.
- Exhibit the highest energy/volume ratio of any EIA size TVS.

This general guideline is aimed at familiarizing users with the characteristics of soldering multilayer SMT ZnO TransGuards®. TransGuards® can be processed on wave or infrared reflow assembly lines. For optimum performance, EIA standard solder pads (land areas) shown in Figure 1 are recommended regardless of the specific attachment method.

Dimensions: mm (inches)

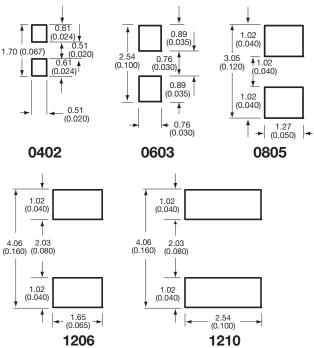


Figure 1: TransGuard® Solder Pad Dimensions

STORAGE

Good solderability of plated components is maintained for at least twelve months, provided the components are stored in their "as received" packaging at less than 30°C and 85% RH.

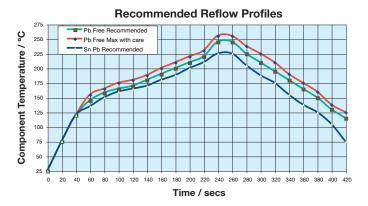
SOLDERABILITY

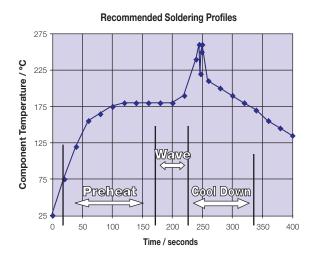
Plated terminations will be well soldered after immersion in a 60/40 tin/lead solder bath at 235° C $\pm 5^{\circ}$ C for 5 ± 1 seconds.

LEACHING

Plated terminations will resist leaching for at least 30 seconds when immersed in 60/40 tin/lead solder at 260° C $\pm 5^{\circ}$ C.

RECOMMENDED SOLDERING PROFILES





GENERAL

Surface mount multilayer varistors (MLVs) are designed for soldering to printed circuit boards or other substrates. The construction of the components is such that they will withstand the time/temperature profiles used in both wave and reflow soldering methods.



AVX Multilayer Varistors – Application Notes



HANDLING

MLVs should be handled with care to avoid damage or contamination from perspiration and skin oils. The use of tweezers or vacuum pickups is strongly recommended for individual components. Bulk handling should ensure that abrasion and mechanical shock are minimized. Taped and reeled components provide the ideal medium for direct presentation to the placement machine.

PREHEAT

It is important to avoid the possibility of thermal shock during soldering and carefully controlled preheat is therefore required. The rate of preheat should not exceed 4°C/second and a target figure 2°C/second is recommended.

SOLDERING

Mildly activated rosin fluxes are preferred. The minimum amount of solder to give a good joint should be used. Excessive solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. AVX terminations are suitable for all wave and reflow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

COOLING

Natural cooling in air is preferred, as this minimizes stresses within the soldered joint. When forced air cooling is used, cooling rate should not exceed 4°C/second.

CLEANING

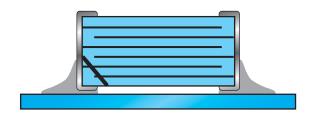
Flux residues may be hygroscopic or acidic and must be removed. AVX MLVs are acceptable for use with all of the solvents described in the specifications MIL-STD-202 and EIA-RS-198. Alcohol-based solvents are acceptable and properly controlled water cleaning systems are also acceptable. Many other solvents have been proven successful, and most solvents that are acceptable to other components on circuit assemblies are equally acceptable for use with MLVs.

POST SOLDER HANDLING

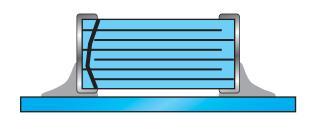
Once the components are soldered to the board, any bending or flexure of the PCB applies stresses to the soldered joints of the components. For leaded devices, the stresses are absorbed by the compliancy of the metal leads and generally don't result in problems unless the stress is large enough to fracture the soldered connection.

Surface mount devices are more susceptible to such stress because they don't have compliant leads and are brittle in nature. The most frequent failure mode is high leakage current (or low breakdown voltage). Also, a significant loss of capacitance due to severing of contact between sets of internal electrodes may be observed.

Cracks caused by mechanical flexure are very easily identified and generally take one of the following two general forms:



Type A:
Angled crack between bottom of device to top of solder joint.



Type B: Fracture from top of device to bottom of device.

Mechanical cracks are often hidden underneath the termination and are difficult to see externally. However, if one end termination falls off during the removal process from PCB, this is one indication that the cause of failure was excessive mechanical stress due to board flexure.

COMMON CRACKS OF MECHANICAL CRACKING

The most common source for mechanical stress is board depanelization equipment, such as manual breakapart, v-cutters and shear presses. Improperly aligned or dull cutters may cause torquing of the PCB resulting in flex stresses being transmitted to components near the board edge. Another common source of flexural stress is contact during parametric testing when test points are probed. If the PCB is allowed to flex during the test cycle, nearby components may be broken.

A third common source is board-to-board connections at the vertical connectors where cables or other PCBs are connected to the PCB. If the board is not supported during the plug/unplug cycle, it may flex and cause damage to nearby components.

Special care should also be taken when handling large (>6" on a side) PCBs since they more easily flex or warp than smaller boards.





AVX Multilayer Varistors – Application Notes

REWORKING ASSEMBLIES

Thermal shock is common in MLVs that are manually attached or reworked with a soldering iron. AVX strongly recommends that any reworking of MLVs be done with hot air reflow rather than soldering irons.

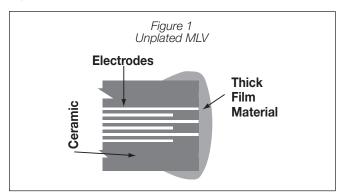
Direct contact by the soldering iron tip often causes thermal cracks that may fail at a later date. If rework by soldering iron is absolutely necessary, it is recommended that the wattage of the iron be less than 30 watts and the tip temperature be <300°C. Rework should be performed by applying the solder iron tip to the pad and not directly contacting any part of the component.

VARISTOR SOLDERABILITY

Historically, the solderability of Multilayer Varistors (MLVs) has been a problem for the electronics manufacturer. He was faced with a device that either did not wet as well as other electronic components, or had its termination material leached away during the assembly process. However, by utilizing proprietary procedures, AVX Corporation provides the market with a MLV that has solderability comparable to that of other electronic components, and resists leaching during assembly.

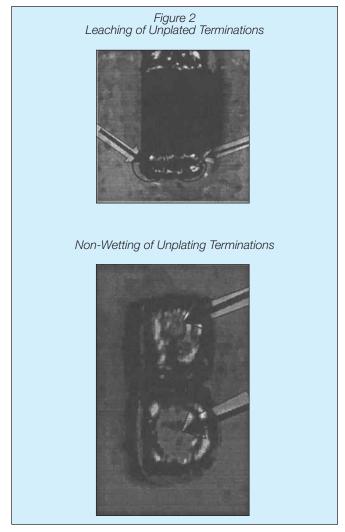
BACKGROUND

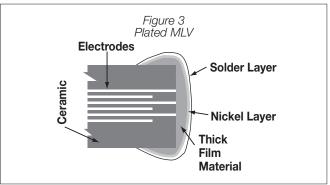
The basic construction of an unplated MLV is presented in Figure 1. The external termination is a metal that connects



the internal electrodes to the circuitry of the assembly using the MLV. The external electrode must accomplish two goals. First, it must be sufficiently solderable to allow the solder used in assembly to wet the end of the chip and make a reliable connection to the traces on the circuit board. Second, it must be robust enough to withstand the assembly process. This is particularly important if wave soldering is used. Unfortunately these two goals are competing. In order to achieve good solderability, an alloy high in silver content is chosen. However, this alloy is prone to leaching during assembly, so an additional metal is added to improve the leach resistance. While this improves the leach resistance, this addition makes the termination less solderable. The results are either terminations that leach away, or do not solder well (see the photographs in Figure 2).

Clearly, a plated termination system (as seen in Figure 3) is desired. This system, which is typical of other electronic components such as capacitors and resistors, produces a much better assembled product.





In the plated termination, the base termination layer is still used (it provides contact from the electrodes to the circuitry). On top of the base termination is a layer of nickel. This is the surface to which the solder bonds during assembly. It must be thick enough to stay intact during IR reflow or wave





AVX Multilayer Varistors – Application Notes

soldering so that the thick film material does not leach away. It must also be thick enough to prevent the inter-metallic layer between the thick film termination and the nickel layer from affecting the solderability.

In order to protect the nickel (i.e., maintain its solderability), a layer of solder is plated on top of the nickel. The solder preserves the solderability of the nickel layer. It must be thick and dense to keep oxygen and water from reaching the nickel layer.

THE CHALLENGE

Zinc oxide varistors are semi-conductive in nature – that is what allows them to "turn on" and divert a damaging transient away from sensitive electronic circuitry and safely to ground. This semi-conduction poses a major problem for the manufacturer that wants to plate the terminations – the ceramic plates also! This condition, overplating, must be controlled, as it is cosmetically undesirable and could result in an unwanted path of conduction across the chip.

Early efforts in plating MLVs revolved around limiting the time that the chip was in the plating bath. This helped prevent overplating, but also produced chips with marginal solderability. The photographs in Figure 4 depict the problems that occur when the plated layers are not thick enough.

THE SOLUTION

AVX has developed a proprietary process that passivates the ceramic surface of the MLV. This allows us to plate the parts for a longer time without getting the overplate. This results in significantly thicker layers of nickel and alloy plated onto the base termination. These thicker layers translate into bond strengths that are typically twice those of our competitors and solder fillets and parts that pass all measured of solderability (as seen in Figure 5).

AVX: The solution for MLV assembly problems.

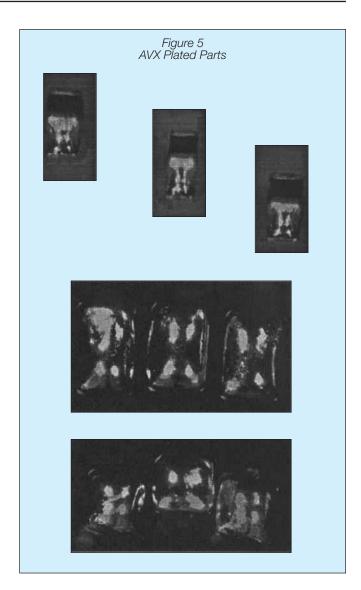
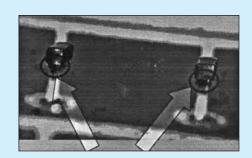


Figure 4
Problems when the Plated Layers are Too Thin







AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: IEC 61000-4 Requirements



WHAT IS IEC 61000-4?

The International Electrotechnical Commission (IEC) has written a series of specifications, IEC 61000-4, which mandate the performance of all electronic devices in a variety of transient and incident RF conditions. This specification requirement resulted as part of Europe's move toward a single market structure and a desire to formalize and harmonize current member countries' requirements. As of January 1, 1996, all electronic and electrical items sold to Europe must meet IEC 61000-4 series specifications.

WHY IS IEC 61000-4 REQUIRED BY EUROPE?

The various regulatory agencies within Europe feel that the IEC 61000-4 series of specifications is necessary to insure acceptable performance of electronic equipment in a world filled with increasingly more Electromagnetic Interference - EMI. Furthermore, as electronic systems become more portable, and the transient susceptibility of semiconductors increases, government regulations are essential to maintain a minimum level of performance in all equipment. Europe is so serious about the problem that they require that equipment be certified via testing to meet IEC 61000-4 series specifications after 1/1/96 to avoid fines and prosecution.

HOW DO COMPANIES SELLING ELECTRONIC SYSTEMS MEET IEC 61000-4 PARTS 2-5 SPECIFICATIONS?

Companies and design engineers must now use protective circuits or devices to meet these requirements. First, a description of IEC 61000-4/2-6 is in order:

IEC 61000-4-2 ESD TESTING REQUIREMENTS

All equipment destined for Europe must be able to withstand 10 strikes of ESD waveforms with Tr < 1ns in contact discharge mode (preferred) at pre-selected points accessible during normal usage or maintenance. Testing shall be performed at one or more of four (4) severity levels, depending upon equipment category.

Level	Contact Discharge ¹ Mode Test Voltage kV	Air Discharge Mode Test Voltage kV
1	2	2
2	4	4
3	6	8
4	8	15

61000-4-2 Test Conditions

¹Preferred mode of testing due to repeatability.

WAVEFORM PARAMETERS

Level	Test Voltage Level kV	First Peak of Discharge Current Amps ± 10%	TR nS	30 nS Current Amps ± 30%	60 nS Current Amps ± 30%
1	2	7.5	0.7 -1	4	2
2	4	15	0.7 -1	8	4
3	6	22.5	0.7 -1	12	6
4	8	30	0.7 -1	16	8

Upon completion of the test, the system must not experience upset (data or processing errors) or permanent damage. The waveforms are to be injected at or along the DUT's body which is accessible in normal set-up and operation.

IEC 61000-4-3 ELECTROMAGNETIC COMPATIBILITY IMPACT TESTING (EMC)

This test is concerned with the susceptibility of equipment when subjected to radio frequencies of 27 MHz to 500 MHz. The system must be able to withstand three (3) incident radiation levels:

Level 1 1V/m field strength
Level 2 3V/m field strength

Level 3 10V/m field strength

Level X User defined > 10V/m field strength

The system must not experience upset (data or processing errors) or permanent errors.

IEC 61000-4-4 ELECTRICAL FAST TRANSIENT (EFT) TESTING

The EFT test is modeled to simulate interference from inductive loads, relay contacts and switching sources. It consists of coupling EFT signals on I/O parts, keyboard cables, communication lines and power source lines. The system, depending upon appropriate severity level, must be able to withstand repetition rates of 2.5 kHz to 5 kHz for \geq 1 minute as follows:

Open Circuit Output Voltage/10%

On Power Supply		On I/O, Signal, Data, Control lines
Level 1	0.5kV	0.25kV
Level 2	1kV	0.5kV
Level 3	2kV	1kV
Level 4	4kV	2kV



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: IEC 61000-4 Requirements



IEC 61000-4-5 UNIDIRECTIONAL POWER LINE SURGE TEST

The details of this specification for high energy disturbances are being addressed in several drafts under discussion within the EC at this time.

IEC 61000-4-6 CONDUCTED RF TEST FROM 9kHz TO 80MHz

The details of this specification for conducted broad band RF signals are being addressed in a first edition draft within the EC at this time.

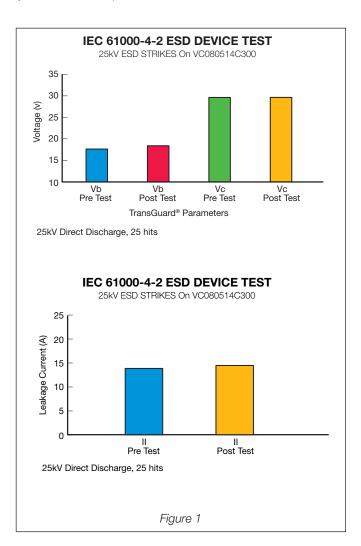
Designers have the option of using AVX TransGuards® to meet IEC 61000-4-2, 3 and 4.

In the case of IEC 61000-4-2 TransGuards® can be used to suppress the incoming Transient just like a Zener diode would. TransGuards®, however, exhibit bipolar characteristics, a faster turn-on-time (<1nS), a better repetitive strike capability and superior thermal stability to the Zener suppression device. Furthermore, TransGuards® are typically smaller and lighter when placed on SMT circuit boards. See Figure 1 for data illustrating IEC 61000-4-2 repetitive strike capability.

The TransGuards® effective capacitance allows the device to be used to meet IEC 61000-4-3 and 61000-4-4. The device's parallel capacitance can be used as effectively as a capacitor to block low level incident and conducted RF energy. If in the case of some levels of IEC 61000-4-3 and IEC 61000-4-4 when the intensity of pulse is greater than the device's breakdown capability it will then turn on and suppress via MOV means rather than capacitance (as in the small signal case). Effectiveness hinges upon the proper placement of the device within the PCB (which is usually easily accomplished since TransGuards® are so small).

SUMMARY

AVX TransGuards® are exceptionally suited to meet the defined portions of the IEC 61000-4 document. Experimentation is critical to proper choice and selection of devices to suppress 61000-4-3/4. Samples are available from your local sales representative.



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Turn on Time Characteristics of AVX Multilayer Varistors

INTRODUCTION

Due to the growing importance of ESD immunity testing, as required by the EMC Directive, proper selection of voltage suppressor devices is critical. The proper selection is a function of the performance of the device under transient conditions. An ideal transient voltage suppressor would reach its "clamping voltage" in zero time. Under the conditions imposed by the 1991 version of IEC 61000-4-2, the actual turn-on-time must be less than one nanosecond to properly respond to the fast leading edge of the waveform defined in the standard.

It has been found during testing of transient suppressors that the response time is very closely dictated by the packaging of the device. Inductance that is present in the connection between the silicon die and the leads of the device creates an impedance in series with the suppressor device; this impedance increases the overall device response time, reducing the effectiveness of the suppressor device.

The purpose of this paper is to present the Turn on Time characteristics of Multilayer Varistors (MLVs) and to compare the MLV Turn on Time to that of various silicon transient voltage suppressors (SiTVs).

The Turn on Time of a transient voltage suppressor (TVS) is of growing importance since IEC 61000-4-2 now specifies ESD waveform with a rise time < 1 ns. Therefore, TVS's must have a turn on time < 1 ns to effectively suppress ESD. In many, if not all, ESD suppression applications, TVS turn on time can be of more importance than absolute clamping voltage (Vc) of the TVS (assuming that the TVS clamping voltage is less than the damage voltage of the circuit or IC).

To measure the turn on time of today's TVS's, a broad cross section of MLVs and SiTVs were chosen. Only surface mount devices were chosen in order to best represent today's TVS current usage/trends and to keep the test matrix to a reasonable level of simplicity. The following devices were tested:

SMT MLV	SiTVS		
	MA141WA		
0603	BAV 99		
0805	SOT 23 type		
1206	SMB - 500W gull-wing SM device		
1210	SMC - 1500W gull-wing SM device		

TEST PROCEDURE

The TVS device under test (DUT) was placed on a PCB test fixture using SN60/40 solder. The test fixture (see Figure 1) was designed to provide an input region for an 8kV contact ESD discharge waveform (per IEC 61000-4-2 level 4 requirements). In addition, the fixture was designed to provide low impedance connections to the DUTs.

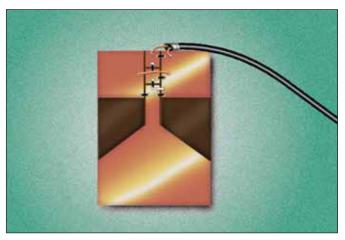


Figure 1. DUT Test Fixture

The ESD pulse was injected to the PCB from a Keytek minizap ESD simulator. Additionally, the fixture was to channel the ESD event to a storage oscilloscope to monitor the suppressor's response. Six resistors were used on the PCB to provide waveshaping and an attenuated voltage to the storage scope (see Figure 2):

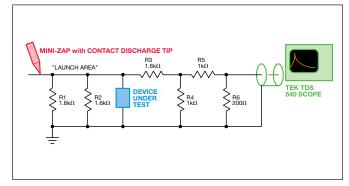


Figure 2. Schematic of Test Set Up





AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Turn on Time Characteristics of AVX Multilayer Varistors

The functions of the resistors are as follows: The resistor values were adjusted in "open circuit" conditions to obtain best open circuit response.

- R1, R2 (1.6K) provide wave shaping during the ESD discharge event
- R3 (1.6K), R4 (1K), R5 (1K) Form a 60 dB Attenuator (1000:1 ratio) for input of Tektronix TDS 540 1 giga sample/second storage oscilloscope
- R6 (200 Ω) provides matching to the 50 ohm coax feeding the TDS 540 oscilloscope.

The open circuit response of the ESD test fixture with a 9kV ESD pulse is shown in Figure 3.

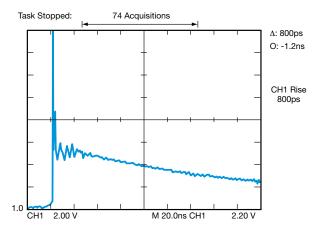


Figure 3. Open Circuit Response of Test Fixture to an Injected ESD Waveform

The graph shows the voltage attenuated by a factor of 1000, with a 800ps risetime for the ESD waveform (this agrees with typical data given by Keytek for equipment performance). It should be noted that only the positive polarity was tested. Prior testing showed turn on time was not dependent upon waveform polarity (assuming that DUTs are bidirectional).

TEST RESULTS

MLV TURN ON TIME TRANSGUARDS®

The turn on time test results for AVX TransGuards® showed that all case sizes were capable of a sub-nanosecond turn on response. This corresponds favorably with the calculated turn on time of less than 1 ns. Specific performance data follows:

AVX TransGuard®			
CASE SIZE TURN ON SPEED			
0603	< 0.7 ns		
0805	< 0.9 ns		
1206	< 0.9 ns		
1210	< 0.8 ns		

TVS TURN ON TIME

Test results for SiTVs varied widely depending upon the physical size and silicon die mounting configuration of the device. The results agree with several SiTVs manufacturers papers indicating that the absolute response from the silicon die could be < 1 ns. However, when the die is placed in a package, the turn on time delay increases dramatically. The reason for this is the series inductance of the SiTVs packaging decreases the effective response time of the device. Reports of 1-5 ns are frequently referred to in SiTVs manufacturers publications. Further, the turn on times for SiTVs vary dramatically from manufacturer to manufacturer and also vary within a particular manufacturers lot. The data provided in the following table generally agreed with these findings:

SiTVS				
CASE SIZE	TURN ON SPEED			
MA141WA	0.8ns			
BAV 99	0.9ns to 1.2ns			
SOT 23 Type	0.8ns			
SMB	1.5ns to 2.2ns			
SMC	1.5ns to 3ns			

SUMMARY

This test confirms calculations that show that AVX TransGuards® have a true sub-nanosecond turn on time. Although the silicon die of a SiTVs has a sub-nanosecond response, the packaged SiTVs typically has a response time much slower than a TransGuard®. If the two devices were directly compared on a single graph (see Figure 4), it could be shown that the TransGuard® diverts significantly more power than even the fastest SiTVs devices. Additionally, TransGuard® have a multiple strike capability, high peak inrush current, high thermal stability and an EMI/RFI suppression capability which diodes do not have.

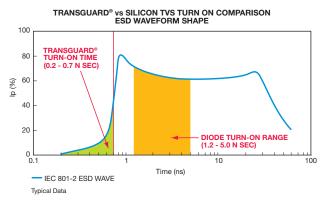


Figure 4.



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: The Impact of ESD on Insulated Portable Equipment



The purpose of this discussion is to recap the impact ESD has on portable, battery powered equipment. It will be shown that ESD can cause failures in "floating ground systems" in a variety of ways. Specifically, ESD induced failures can be caused by one or more of its complex components:

- Corona Generated RF Predischarge

E Field Predischarge

Discharge Collapsing E Field Discharge Collapsing H Field

Discharge Current Injection...Voltage...Additional

Fields

With this in mind it will be shown that the only way to insure equipment survivability to ESD is to use a Transient Voltage Suppressor (in addition to proper circuit layout, decoupling, and shielding).

In order to get a better understanding of what happens in an ESD event the charge developed by a human body should be defined. The ESD schematic equivalent of the human body model is shown in Figure 1. Typically, the charge developed on a person can be represented by a 150pF capacitor in series with a resistance of 330 ohms. The energy of an ESD waveform generated from this model is $Q = 1/2 \text{ CV}^2$ where Q = total energy in Joules, C = capacitance of the human body model in farads and V = charging voltage in volts.

Voltages can be as high as 25 kV, however typical voltages seen are in the 8 to 15 kV regions.

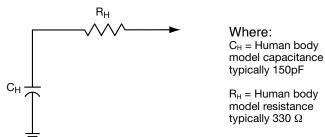


Figure 1. Human Body Model

PREDISCHARGE E FIELD FAILURES

Now that we have a definition of the basic ESD human body model we can discuss the predischarge E field failure mode.

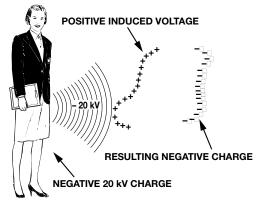


Figure 2. Pre-Discharge Scenario

In the predischarge scenario (Figure 2) a human charged to -20 kV may approach a battery powered "system" on a table. As the person reaches toward the system electrostatics dictate that the system will have an equal and opposite charge on the system's surface nearest to the person. Since the system we are approaching is isolated from ground, the charge is only redistributed among the device. (If the system were grounded a current would be generated by the loss of electrons to ground. The system would then become positive relative to ground). The rate of approach of the human body model affects the charging current to a small extent. However, most importantly, it is the electrostatic field and the unequal voltages which developed across the equipment that cause the destruction of components within the system. In general, unprotected IC's (particularly CMOS) are susceptible to damage due to induced E field voltages. This problem is further complicated by the device type and complexity and the fact that the breakdown voltage of a generic IC will vary greatly from manufacturer to manufacturer (Figure 3). This brief discussion should be adequately convincing that electrostatically induced E field can impact system reliability. IC protection can be achieved by placing a transient suppressor on the most susceptible pins of the sensitive IC's (e.g., Vcc and I/O pins, etc.).

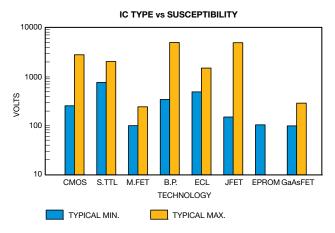


Figure 3. IC Type E Field Susceptibility

CONTACT DISCHARGE FAILURES

As the charged person gets closer to the system, the situation is more complex. First a much more detailed human body model is needed to represent the complex transmission line which will transport energy to the system (see Figure 4). In this discussion we will only consider the case of a single contact discharge. In the real world, however, multiple discharges will likely occur (possibly caused by a person's hand reacting to an ESD spark and then touching the system again, etc.).

In contact discharge, when a charged person approaches the system, E fields are induced. As the person gets closer to the system, the field intensity becomes greater, eventually reaching a point large enough to draw an arc between the



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: The Impact of ESD on Insulated Portable Equipment

person and the system. In contrast to the noncontrast E field example, the speed of approach is of great importance in the contact discharge model. A fast approach causes a more intensive discharge and faster current rise times and peaks.

The model shown on Figure 4 can be broken up into 4 sections for the sake of simplification. The first section is the human body model input voltage. This section is identical to the simplified human body model shown in Figure 1.

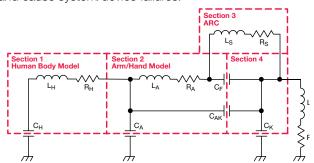
Section 2 takes into account how the human body model gets the energy to the system. This section considers the inductance, resistance and capacitance of the human's arm and finger and its capacitance relative to ground and the system.

The third section is the inductance and resistance of the arc which is created as section 2 approaches the system (Section 4).

Section four is the system itself.

The combination of the capacitances and inductances in these sections form a complex network of LC tank circuits which will inject a variety of waveforms (transients) into the system. These waveforms will range in frequency from very high (5 GHz) to high (100 MHz) to low (20-50 MHz) plus a variety of under damped and over damped waveforms.

Finally, in addition to current/voltage injection occurring as a result of the discharge, there will be collapsing E and H fields and significant high frequency RF waveforms. Many times these waveforms propagate into shielded equipment and cause system/device failures.



Where: C_H = Lumped capacitance between the human body and earth

 R_H = Lumped resistance of the human body

L_H = Lumped inductance of the human body

 $C_{\text{A}} = \text{Lumped capacitance}$ between the person's arm and earth

 $C_{\text{AK}} = \text{Lumped capacitance between the person's arm}$ (and near portions of the body) and the keyboard

 $R_A = Lumped$ resistance of the person's arm's discharge path

L_A = Lumped inductance of the person's arm's discharge path

 $C_{\text{F}} = \text{Capacitance}$ between person's finger, hand, and the keyboard

 C_K = Lumped capacitance of the keyboard to earth

 R_K = Lumped resistance of the keyboard earth ground path

 L_K = Lumped inductance of the keyboard earth ground path

Figure 4. Contact Discharge Model

SUMMARY

Designers may be inclined to think that E field variation due to near field electrostatics (as in the person being close to the system but not touching it) can be eliminated by shielding. This is usually not the case because it is difficult to get a tight columbic shield around internal circuitry without incurring significant additional manufacturing costs. Additionally, the shielding will likely have seams, ventilation holes, or I/O ports which represent a significant portion of a wavelength (at 5 GHz). Therefore, E fields and corona generated RF can be a problem. Finally, if the system has I/O connectors, keyboards, antennas, etc., care must be taken to adequately protect them from direct/and indirect transients. The most effective resolution is to place a TransGuard® as close to the device in need of protection as possible. These recommendations and comments are based upon case studies, customer input and Warren Boxleitner's book Electrostatic Discharge and Electronic Equipment - A Practical Guide for Designing to Prevent ESD Problems.



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Motor and Relay Application Study



PURPOSE

A significant number of end customers have experienced failures of circuitry in and around low voltage relays and motors. Additionally, EMI problems have been associated with running motors.

This study is aimed at evaluating how TransGuards® can reduce EMI from running motors and clamp transients generated from relays and motors during power off.

DESCRIPTION

Three different motors and two different relays were chosen to represent the wide range of possible devices used by designers. Device choices were as follows:

MOTORS

Cramer 8001 series Geared Motor

12V, 30rpm (4800 RPM armature speed) 170ma

Start/Run Torque 30oz

Comair Rotron DC Biscut Fan - 24V, 480ma Comair Rotron DC Biscut Fan - 12V, 900ma

RELAYS

Potter and Brumfield 24V Relay

1/3 HP 120V AC, 10A 240 VAC Rating

Potter and Brumfield 12V Relay

1/3 HP 120V AC, 10A 240 VAC Rating

A Tektronix TDS 784A four channel 1GHz 4G S/s digitizing storage scope was used to capture the -1/2 LI2 transient peak from the relays and motors. A x10 probe was

Fig. 1. Geared Motor Transient at Turnoff without protection 60 V Gear Motor 20 V/Division

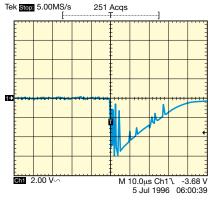
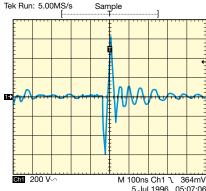


Fig. 2. Geared Motor Running noise without protection 12 V pk-pk 2 V/Division



connected to the scope and one leg of the relay/motor coil; the probe's ground was connected to the other relay coil/motor wire. The scope was triggered on the pulse and waveforms printed.

When suppression was introduced into the circuit, it was placed directly on the relay coils/motor lead wires. The axial TransGuard® and capacitors had a 19mm (3/4") total lead length in each case. Upon careful consideration, it was determined that this was a fairly common lead length for such applications.

SUMMARY

GEARED MOTOR

The Cramer geared motor was tested while running (under load) to determine its "on state" noise as well as under loaded turn off conditions. Both TransGuards® and ceramic capacitors were tested to determine the level of protection they offer.

A 14V axial TransGuard® provided the best protection during running and turn off. The VA100014D300 TransGuard® cut the 60V unprotected turn off voltage spike to 30V. It also cut the on state noise to 4.0V pk-pk due to its internal capacitance. The following is a summary of measured voltages (scope traces are shown in Figures 1, 1A, 2, 2A).

Test Condition	Transient without Protection	Transient with .1µF cap	Transient with .01µF cap	Transient with 14v TransGuard®
Geared motor at turn off	60V	32V	48V	30V
Geared motor during running	12V pk-pk	4.0V pk-pk	4.0V pk-pk	4.0V pk-pk

Fig. 1A. Geared Motor Transient at Turnoff with 14 V TransGuard® 30 V 10 V/Division

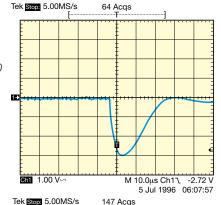
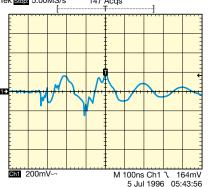


Fig. 2A. Geared Motor Running with 14 V TransGuard® 4 V pk-pk 2 V/Division



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Motor and Relay Application Study



BISCUT FAN

The Comair 24V and 12V biscut fans were tested only for transients at turn off. Results of those tests are shown in the table at the right (as well as slope traces 3, 3A, 4, 4A).

Motor Type	Transient without Protection	Transient with .1µF cap	Transient with .01µF cap	Transient with TransGuard®
24V Fan	165V	120V	140V	65V ⁽¹⁾
12V Fan	60V	52V	64V	30V ⁽²⁾

Tek Stop: 5.00MS/s

Fig. 3. 24 V Biscut Fan without protection 165 V Biscut 50 V/Division

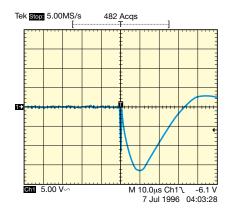


Fig. 3A. 24 V Biscut Fan with 30 V TransGuard® 65 V 50 V/Division

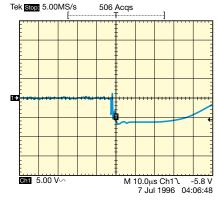


Fig. 4. 12 V Biscut Fan without protection 60 V 20 V/Division

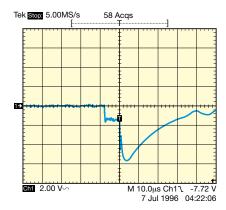
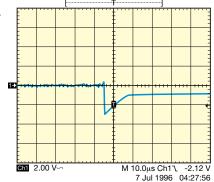


Fig. 4A. 12 V Biscut Fan with 14 V TransGuard® 30 V 20 V/Division



265 Acqs

⁽¹⁾ VA100030D650 TransGuard® / (2) VA100014D300 TransGuard®

AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Motor and Relay Application Study



RELAYS

The 12V and 24V relays were tested only for transients at turn off. The results of those tests are shown in the table at the right (as well as scope traces 5, 5A, 6, 6A).

Relay Type	Transient without Protection	Transient with .1µF cap	Transient with .01µF cap	Transient with TransGuard®
24V	44V	24V	28V	28V ⁽³⁾
12V	105V	63V	100V	30V ⁽⁴⁾

⁽³⁾ VA100026D580 TransGuard® / (4) VA100014D300 TransGuard®

Fig. 5. 24 V Relay Transient without protection 44 V 10 V/Division

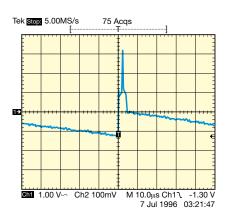


Fig. 5A. 24 V Relay Transient with 26 V TransGuard® 10 V/Division

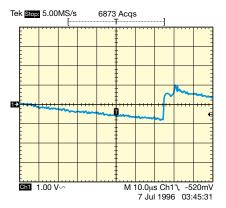


Fig. 6. 12 V Relay Transient without protection 105 V 50 V/Division

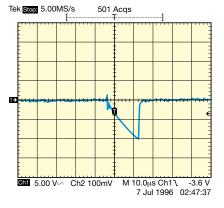
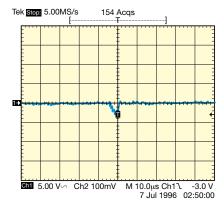


Fig. 6A. 12 V Relay Transient with 14 V TransGuard® 30 V 50 V/Division



CONCLUSIONS

TransGuards® can clamp the wide range of voltages coming from small/medium motors and relays due to inductive discharge. In addition, TransGuards® capacitance can help reduce EMI/RFI. Proper selection of the TransGuards® voltage is critical to clamping efficiency and correct circuit operation.



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Multilayer Varistors In Automobile MUX Bus Applications

The current trend in automobiles is towards increased performance, comfort and efficiency. To achieve these goals, automobile companies are incorporating an ever increasing array of electronics into cars. As the electronic content within cars increases, auto manufacturers are utilizing multiplex bus designs to network all the sensors to a central point (usually the engine control unit [ECU]). Multiplex lines save wiring harness weight and decrease the harness' complexity, while allowing higher communication speeds. However, the multiplex structure tends to increase the occurrence and severity of Electromagnetic Interference (EMC) and Electrostatic Discharge (ESD).

Multilayer varistors (MLVs) are a single component solution for auto manufacturers to utilize on multiplex nodes to eliminate both ESD and EMC problems. MLVs also offer improved reliability rates (FIT rates <1 failure/billion hours) and smaller designs over traditional diode protection schemes.

TYPICAL MUX NODE APPLICATION

There are a variety of SAE recommended practices for vehicle multiplexing (J-1850, J-1939, J-1708, J-1587, CAN). Given the number of multiplexing specifications, it is easy to understand that bus complexity will vary considerably.

Each node has an interface circuit which typically consists of a terminating resistor (or sometimes a series limiting resistor), back to back Zener diodes (for over voltage protection) and an EMC capacitor. Such a method is compared to that of a multilayer varistor in Figure 1.

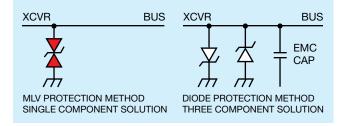


Figure 1. Comparison of past node protection methods to MLV node protection methods.

To more clearly understand the functional structure of a MLV, see the equivalent electrical model shown in Figure 2.

- MULTIPLE ELECTRODES YIELD A CAPACITANCE
- THE CAPACITANCE CAN BE USED IN DECOUPLING
- CAPACITANCE CAN BE SELECTED FROM 30pF TO 4700pF

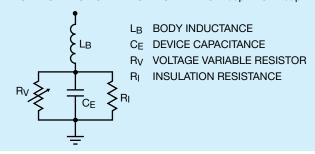


Figure 2. TransGuard® Equivalent Model.

As the schematic in Figure 1 illustrates, the implementation of MLV protection methods greatly simplifies circuit layout, saves PCB space and improves system reliability. The MLV offers many additional electrical improvements over the Zener/passive schemes. Among those advantages are higher multiple strike capability, faster turn on time and larger transient overstrike capability. Further clarification on the types of varistors compared to the performance of Zener diodes follows.

CONSTRUCTION AND PHYSICAL COMPARISON

The construction of Zinc Oxide (ZnO) varistors is a well known, relatively straightforward process in which ZnO grains are doped with cobalt, bismuth, manganese and other oxides. The resulting grains have a Schottky barrier at the grain interface and a typical grain breakdown voltage (V_b) of approximately 3.6V per grain.

Currently, there are two types of varistors. Single layer varistors (SLVs) – an older technology referred to as "pressed pill," typically are larger, radial leaded components designed to handle significant power. Multilayer varistors (MLVs) are a relatively new technology packaged in true EIA SMT case sizes.

Beyond the ZnO material system and grain breakdown similarity, MLVs and SLVs have little in common. That is, to design a low voltage SLV, the grains must be grown as large as possible to achieve a physically large enough part to be handled in the manufacturing process. Typically it is very difficult to obtain a consistent grain size in a low voltage SLV process.

The electrical performance of SLV is affected by inconsistent grain size in two ways. First, low voltage SLVs often exhibit an inconsistent V_b and leakage current (I_L) from device to device within a particular manufacturing lot of a given rating. This contributes to early high voltage repetitive strike wear out.

Secondly, SLVs with similar voltage and energy ratings as MLVs typically exhibit a lower peak current capability due in part to increased resistance of the long current path of the large grains. This contributes to early repetitive high current wear out.

At higher voltages, the grain size variations within SLVs play a much smaller percentage role in $V_{\rm b}$ and leakage current values. As a result, SLVs are the most efficient cost effective way to suppress transients in high voltages (e.g., 115 VAC, 220 VAC).



AVX Multilayer Ceramic Transient Voltage Suppressors Application Notes: Multilayer Varistors In Automobile MUX Bus Applications

MLV MANUFACTURE

The construction of a MLV was made possible by employing a variety of advanced multilayer chip capacitors (MLCC) manufacturing schemes coupled with a variety of novel and proprietary ZnO manufacturing steps. In the MLCC process, thin dielectrics are commonly employed to obtain very large capacitance values. It is that capability to design and manufacture multilayer structures with dielectric thicknesses of ≤ 1 mil that allows MLVs to be easily made with operating/working voltages (V $_{\rm wm}$) as low as 3.3V (for use in next generation silicon devices).

Once a particular working voltage has been determined (by altering the ZnO dielectric thickness), the multilayer varistor's transient energy capability is determined by the number of layers of dielectric and electrodes. It is, therefore, generally easy to control the grain size and uniformity within a MLV due to the relative simplicity of this process.

MLVs exhibit capacitance due to their multiple electrode design and the fact that ZnO is a ceramic dielectric. This capacitance can be utilized with the device's series inductance to provide a filter to help limit EMI/RFI. The equivalent model of a MLV is shown in Figure 2.

MLVs are primarily used as transient voltage suppressors. In their "on" state, they act as a back-to-back Zener, diverting to ground any excess, unwanted energy above their clamping voltage. In their "off" state, they act as an EMC capacitor (capacitance can be minimized for high speed applications). A single MLV, therefore, can replace the diode, capacitor and resistor array on multiplex node applications.

Any TVS will see a large number of transient strikes over its lifetime. These transient strikes will result from different events such as well known ESD HBM, IC MM, alternator field decay, load dump models and uncontrolled random events. It is because of the repetitive strikes that all TVS suppressors should be tested for multiple strike capability. Typically, a TVS will fail due to high voltage, high current or over-energy strikes.

High voltage repetitive strikes are best represented by IEC 61000-4-2 8kV waveforms. MLVs demonstrate a greatly superior capability to withstand repetitive ESD high voltage discharge without degradation.

High current repetitive strikes are represented by 8x20µs 150A waveforms. A comparison between MLVs, SLVs and SiTVS is shown in Figures 3A, B, C respectively.

SILICON TVS MANUFACTURE

The construction of a silicon TVS departs dramatically from that of either single layer varistor or multilayer varistor construction. Devices are generally produced as Zener diodes with the exception that a larger junction area is designed into the parts and additional testing was likely performed. After the silicon die is processed in accordance to standard semi-conductor manufacturing practice, the TVS die is connected to a heavy metal lead frame and molded into axial and surface mount (SMT) configuration.

MLVs COMPARED TO DIODES

The response time for a silicon diode die is truly subnanosecond. The lead frame into which the die is placed and the wire bonds used for die connections introduce a significant amount of inductance. The large inductance of this packaging causes a series impedance that slows the response time of SiTVS devices. A best case response time of 8nS on SOT23 and a 1.5nS to 5nS response time on SMB and SMC products respectively are rather typical. MLVs turn on time is <7nS. MLVs turn on time is faster than SiTVS and that fast turn on time diverts more energy and current away from the IC than any other protection device available.

CONCLUSION

The technology to manufacture MLVs exists and allows the manufacture of miniature SMT surge suppressors. MLVs do not have the wear out failure mode of first generation (single layer) varistors. In fact, MLVs exhibit better reliability numbers than that of TVS diodes. MLVs are a viable protection device for auto multiplex bus applications.

Written by Ron Demcko

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150 AMP Current Repetitive Strike Comparison

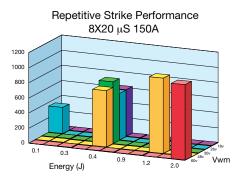


Figure 3A. Multilayer Varistor.

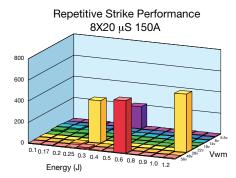


Figure 3B. Single Layer Varistor.

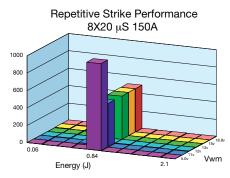


Figure 3C. Silicon TVS.





/AV/XTransGuard®

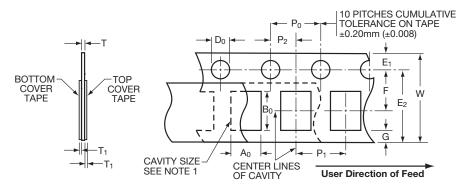
PACKAGING

- Chips
- Axial Leads

Paper Carrier Configuration







8mm Paper Tape Metric Dimensions Will Govern

CONSTANT DIMENSIONS

mm (inches)

Tape Size	D ₀	E	P ₀	P ₂	T ₁	G. Min.	R Min.
8mm	1.50 ^{+0.10} _{-0.0} (0.059 ^{+0.004} _{-0.0})	1.75 ± 0.10 (0.069 ± 0.004)	4.00 ± 0.10 (0.157 ± 0.004)	2.00 ± 0.05 (0.079 ± 0.002)	0.10 (0.004) Max.	0.75 (0.030) Min.	25.0 (0.984) See Note 2 Min.

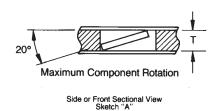
VARIABLE DIMENSIONS

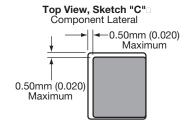
mm (inches)

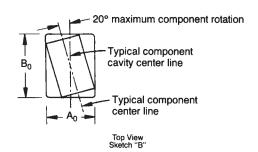
Tape Size	P ₁ See Note 4	E ₂ Min.	F	W	$A_0 B_0$	Т
8mm	4.00 ± 0.10 (0.157 ± 0.004)	6.25 (0.246)	3.50 ± 0.05 (0.138 ± 0.002)	8.00 ±%;% (0.315 ±%%;)	See Note 1	1.10mm (0.043) Max. for Paper Base Tape and 1.60mm (0.063) Max. for Non-Paper Base Compositions

NOTES:

- 1. The cavity defined by A_0 , B_0 , and T shall be configured to provide sufficient clearance surrounding the component so that:
 - a) the component does not protrude beyond either surface of the carrier tape;
 b) the component can be removed from the cavity in a vertical direction without mechanical restriction after the top cover tape has been removed;
 - c) rotation of the component is limited to 20° maximum (see Sketches A & B);
 - d) lateral movement of the component is restricted to 0.5mm maximum (see Sketch C).
- 2. Tape with or without components shall pass around radius "R" without damage.
- Bar code labeling (if required) shall be on the side of the reel opposite the sprocket holes. Refer to EIA-556.
- 4. If $P_1 = 2.0$ mm, the tape may not properly index in all tape feeders.







Bar Code Labeling Standard

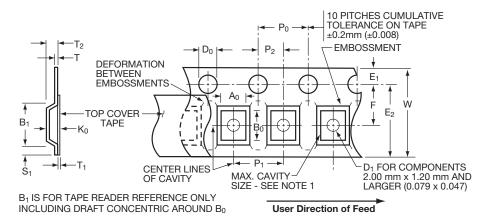
AVX bar code labeling is available and follows latest version of EIA-556



Embossed Carrier Configuration



8 & 12mm Tape Only



8 & 12mm Embossed Tape Metric Dimensions Will Govern

CONSTANT DIMENSIONS

mm (inches)

Т	ape Size	D ₀	E	Po	P ₂	S₁ Min.	T Max.	T ₁
	8mm and 12mm	1.50 ^{+0.10} (0.059 ^{+0.004})	1.75 ± 0.10 (0.069 ± 0.004)	4.0 ± 0.10 (0.157 ± 0.004)	2.0 ± 0.05 (0.079 ± 0.002)	0.60 (0.024)	0.60 (0.024)	0.10 (0.004) Max.

VARIABLE DIMENSIONS

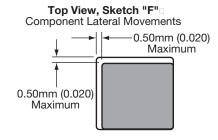
mm (inches)

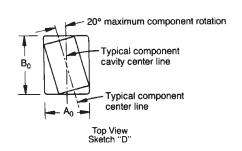
Tape Size	B ₁ Max.	D₁ Min.	E ₂ Min.	F	P ₁ See Note 5	R Min. See Note 2	T ₂	W Max.	$A_0 B_0 K_0$
8mm	4.35 (0.171)	1.00 (0.039)	6.25 (0.246)	3.50 ± 0.05 (0.138 ± 0.002)	4.00 ± 0.10 (0.157 ± 0.004)	25.0 (0.984)	2.50 Max. (0.098)	8.30 (0.327)	See Note 1
12mm	8.20 (0.323)	1.50 (0.059)	10.25 (0.404)	5.50 ± 0.05 (0.217 ± 0.002)	4.00 ± 0.10 (0.157 ± 0.004)	30.0 (1.181)	6.50 Max. (0.256)	12.3 (0.484)	See Note 1

NOTES:

- 1. The cavity defined by $A_{\!\scriptscriptstyle 0},\,B_{\!\scriptscriptstyle 0},$ and $K_{\!\scriptscriptstyle 0}$ shall be configured to provide the following:
- Surround the component with sufficient clearance such that:
 - a) the component does not protrude beyond the sealing plane of the cover tape.
 - b) the component can be removed from the cavity in a vertical direction without mechanical restriction, after the cover tape has been removed.
 - c) rotation of the component is limited to 20° maximum (see Sketches D & E).
 - d) lateral movement of the component is restricted to 0.5mm maximum (see Sketch F).
- 2. Tape with or without components shall pass around radius "R" without damage.
- Bar code labeling (if required) shall be on the side of the reel opposite the round sprocket holes. Refer to EIA-556.
- 4. $\ensuremath{\mathsf{B}}_1$ dimension is a reference dimension for tape feeder clearance only.
- 5. If $P_1 = 2.0$ mm, the tape may not properly index in all tape feeders.







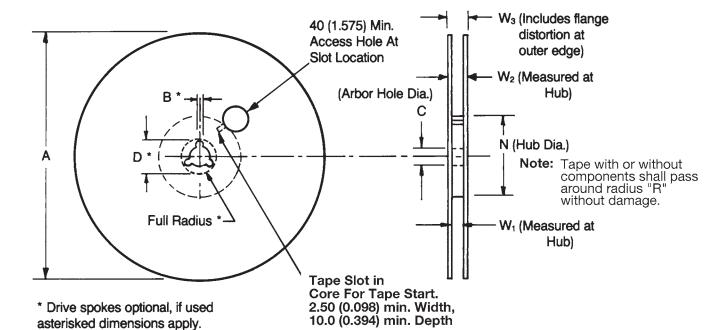


Packaging of Chip Components



Automatic Insertion Packaging

REEL DIMENSIONS



mm (inches)

Tape Size	A Max.	B* Min.	С	D* Min.	N Min.	W ₁	W ₂ Max.	W ₃
8mm	330	1.5	13.0 ^{+0.50}	20.2 (0.795)	50.0 (1.969)	8.40 ^{+1,5} (0.331 ^{+0,059})	14.4 (0.567)	7.90 Min. (0.311) 10.9 Max. (0.429)
12mm	(12.992)	(0.059)	(0.512 -0.008)			12.4 ^{+2.0} (0.488 ^{+0.079})	18.4 (0.724)	11.9 Min. (0.469) 15.4 Max. (0.607)

Metric dimensions will govern.

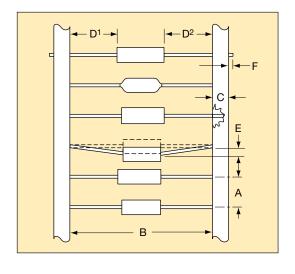
English measurements rounded and for reference only.

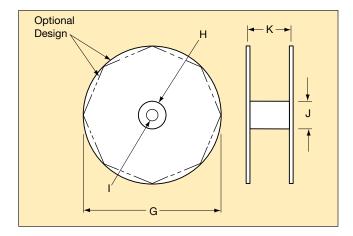


AVX Multilayer Ceramic Transient Voltage Suppressors

PACKAGING - AXIAL LEADS / TAPE AND REEL

CLASS I / RS-296					
A.	5mm ± 0.5mm (0.200" ± 0.020")				
B*.	52.4mm ± 1.5mm (2.063" ± 0.059")				
C.	6.35mm ± 0.4mm (0.250" ± 0.016")				
D¹-D².	1.4mm (0.055" MAX.)				
E.	1.2mm (0.047" MAX.)				
F.	1.6mm (0.063" MAX.)				
G.	356mm (14.00" MAX.)				
H.	76mm (3.000")				
I.	25.4mm (1.000")				
J.	84mm (3.300")				
K.	70mm (2.750")				





Leader Tape: 300mm min. (12")

Splicing: Tape Only
Missing Parts: 0.25% of component count max.-

No consecutive missing parts

AMERICAS

AVX Myrtle Beach, SC Tel: 843-448-9411

AVX Northwest, WA Tel: 360-699-8746

AVX Midwest, IN Tel: 317-861-9184

AVX Mid/Pacific, CA Tel: 408-988-4900

AVX Northeast, MA Tel: 617-479-0345

AVX Southwest, CA Tel: 949-859-9509

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